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## ADC322x

### Dual-Channel, 12-Bit, 25-MSPS to 125-MSPS, Analog-to-Digital Converters

#### 1 Features

- Dual Channel
- 12-Bit Resolution
- Single Supply: 1.8 V
- Serial LVDS Interface (SLVDS)
- Flexible Input Clock Buffer with Divide-by-1, -2, -4
- SNR = 70.2 dBFS, SFDR = 87 dBc at  $f_{IN} = 70$  MHz
- Ultra-Low Power Consumption:
  - 116 mW/Ch at 125 MSPS
- Channel Isolation: 105 dB
- Internal Dither and Chopper
- Support for Multi-Chip Synchronization
- Pin-to-Pin Compatible with 14-Bit Version
- Package: VQFN-48 (7 mm × 7 mm)

#### 2 Applications

- Multi-Carrier, Multi-Mode Cellular Base Stations
- Radar and Smart Antenna Arrays
- Munitions Guidance
- Motor Control Feedback
- Network and Vector Analyzers
- Communications Test Equipment
- Nondestructive Testing
- Microwave Receivers
- Software-Defined Radios (SDRs)
- Quadrature and Diversity Radio Receivers
- Handheld Radio and Instrumentation

#### 3 Description

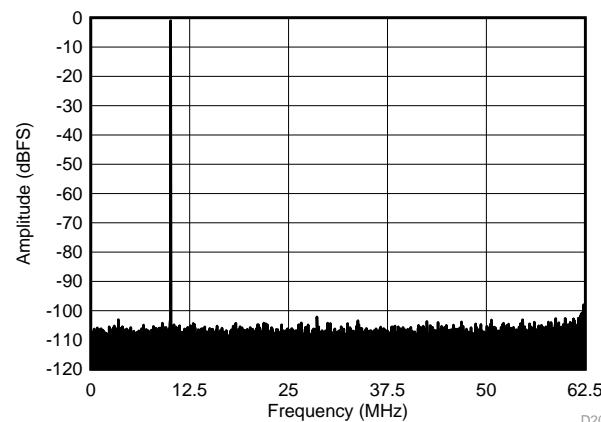
The ADC322x are a high-linearity, ultra-low power, dual-channel, 12-bit, 25-MSPS to 125-MSPS, analog-to-digital converter (ADC) family. The devices are designed specifically to support demanding, high input frequency signals with large dynamic range requirements. An input clock divider allows more flexibility for system clock architecture design and the SYSREF input enables complete system synchronization. The ADC322x family supports serial low-voltage differential signaling (LVDS) in order to reduce the number of interface lines, thus allowing for high system integration density. The serial LVDS interface is two-wire, where each ADC data are serialized and output over two LVDS pairs. An internal phase-locked loop (PLL) multiplies the incoming ADC sampling clock to derive the bit clock that is used to serialize the 12-bit output data from each channel. In addition to the serial data streams, the frame and bit clocks are also transmitted as LVDS outputs.

#### Device Information<sup>(1)</sup>

PART NUMBER	PACKAGE	BODY SIZE (NOM)
ADC322x	VQFN (48)	7.00 mm × 7.00 mm

(1) For all available packages, see the orderable addendum at the end of the datasheet.

#### Performance at $f_S = 125$ MSPS, $f_{IN} = 10$ MHz (SNR = 70.6 dBFS, SFDR = 100 dBc)



An IMPORTANT NOTICE at the end of this data sheet addresses availability, warranty, changes, use in safety-critical applications, intellectual property matters and other important disclaimers. PRODUCTION DATA.

**ADC3221, ADC3222, ADC3223, ADC3224**

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**4 Revision History**
**Changes from Revision A (March 2015) to Revision B**

		Page
• Added <i>Digital Inputs</i> section to Digital Characteristics table .....		17
• Updated Figure 19, Figure 20, Figure 23, Figure 24, Figure 25 and, Figure 26 .....		22
• Updated Figure 50, Figure 53, Figure 54, Figure 55, and Figure 56 .....		27
• Updated Figure 79, Figure 80, Figure 83, Figure 84, Figure 85, and Figure 86 .....		32
• Updated Figure 109, Figure 110, Figure 113, Figure 114, Figure 115, and Figure 116 .....		37
• Changed conditions of Figure 122 and Figure 124 .....		39
• Changed Figure 129 .....		41
• Changed <i>SNR and Clock Jitter</i> section: changed typical thermal noise value in description of and changed Figure 137 to reflect updated thermal noise value .....		45
• Changed Table 3 .....		46
• Changed <i>Lane to Wire</i> in Figure 138 .....		47
• Changed <i>Register Map Summary</i> table: changed <i>FLIP BITS</i> to <i>FLIP WIRE</i> in register 04h, changed bit 7 in register 70Ah, and added register 13h .....		53
• Changed Summary of Special Mode Registers section: changed title, moved section to correct location .....		54
• Changed <i>Lane to wire</i> in register 03h description .....		54
• Changed register 04h: changed <i>FLIP BITS</i> to <i>FLIP WIRE</i> and changed description of bit 0 .....		55
• Changed register 0Ah and 0Bh descriptions .....		57
• Added register 13h .....		58
• Changed register 70Ah to include the DIS CLK FILT register bit .....		63

**Changes from Original (July 2014) to Revision A****Page**

- Released to Production Data..... **1**

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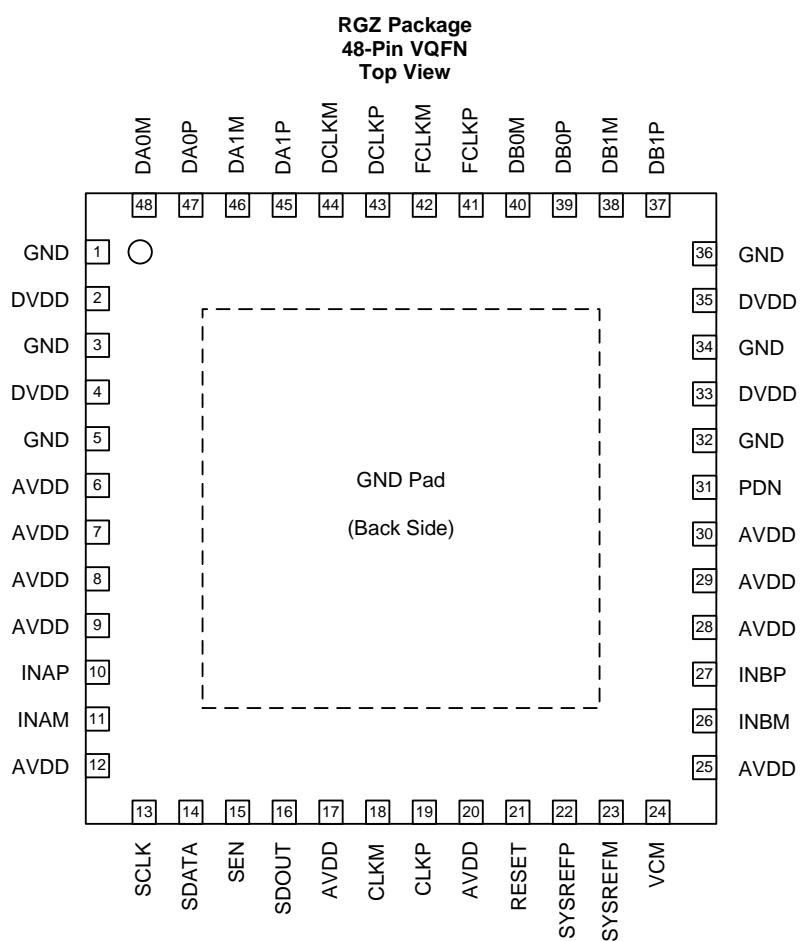
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## 5 Device Comparison Table

INTERFACE	RESOLUTION (Bits)	25 MSPS	50 MSPS	80 MSPS	125 MSPS	160 MSPS
Serial LVDS	12	ADC3221	ADC3222	ADC3223	ADC3224	—
	14	ADC3241	ADC3242	ADC3243	ADC3244	—
JESD204B	12	—	ADC32J22	ADC32J23	ADC32J24	ADC32J2x5
	14	—	ADC32J42	ADC32J43	ADC32J44	ADC32J45

## 6 Pin Configuration and Functions



**Pin Functions**

<b>PIN</b>		<b>I/O</b>	<b>DESCRIPTION</b>
<b>NAME</b>	<b>NO.</b>		
AVDD	6-9, 12, 17, 20, 25, 28-30	I	Analog 1.8-V power supply
CLKM	18	I	Negative differential clock input for the ADC
CLKP	19	I	Positive differential clock input for the ADC
DA0M	48	O	Negative serial LVDS output for channel A0
DA0P	47	O	Positive serial LVDS output for channel A0
DA1M	46	O	Negative serial LVDS output for channel A1
DA1P	45	O	Positive serial LVDS output for channel A1
DB0M	40	O	Negative serial LVDS output for channel B0
DB0P	39	O	Positive serial LVDS output for channel B0
DB1M	38	O	Negative serial LVDS output for channel B1
DB1P	37	O	Positive serial LVDS output for channel B1
DCLKM	44	O	Negative bit clock output
DCLKP	43	O	Positive bit clock output
DVDD	2, 4, 33, 35	I	Digital 1.8-V power supply
FCLKM	42	O	Negative frame clock output
FCLKP	41	O	Positive frame clock output
GND	1, 3, 5, 32, 34, 36, PowerPAD™	I	Ground, 0 V
INAM	11	I	Negative differential analog input for channel A
INAP	10	I	Positive differential analog input for channel A
INBM	26	I	Negative differential analog input for channel B
INBP	27	I	Positive differential analog input for channel B
PDN	31	I	Power-down control. This pin can be configured via the SPI. This pin has an internal 150-kΩ pull-down resistor.
RESET	21	I	Hardware reset; active high. This pin has an internal 150-kΩ pull-down resistor.
SCLK	13	I	Serial interface clock input. This pin has an internal 150-kΩ pull-down resistor.
SDATA	14	I	Serial interface data input. This pin has an internal 150-kΩ pull-down resistor.
SDOUT	16	O	Serial interface data output
SEN	15	I	Serial interface enable; active low. This pin has an internal 150-kΩ pull-up resistor to AVDD.
SYSREFM	23	I	Negative external SYSREF input
SYSREFP	22	I	Positive external SYSREF input
VCM	24	O	Common-mode voltage for analog inputs

## ADC3221, ADC3222, ADC3223, ADC3224

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## 7 Specifications

### 7.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

		MIN	MAX	UNIT
Analog supply voltage range, AVDD		–0.3	2.1	V
Digital supply voltage range, DVDD		–0.3	2.1	V
Voltage applied to input pins	INAP, INBP, INAM, INBM	–0.3	min (1.9, AVDD + 0.3)	V
	CLKP, CLKM	–0.3	AVDD + 0.3	
	SYSREFP, SYSREFM	–0.3	AVDD + 0.3	
Temperature	SCLK, SEN, SDATA, RESET, PDN	–0.3	3.9	°C
	Operating free-air, $T_A$	–40	85	
	Operating junction, $T_J$		125	
	Storage, $T_{stg}$	–65	150	

(1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

### 7.2 ESD Ratings

		VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001 <sup>(1)</sup>	±2000 V

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

### 7.3 Recommended Operating Conditions<sup>(1)</sup>

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM	MAX	UNIT
<b>SUPPLIES</b>					
AVDD	Analog supply voltage range	1.7	1.8	1.9	V
DVDD	Digital supply voltage range	1.7	1.8	1.9	V
<b>ANALOG INPUT</b>					
$V_{ID}$	Differential input voltage	For input frequencies < 450 MHz	2		$V_{PP}$
		For input frequencies < 600 MHz	1		
$V_{IC}$	Input common-mode voltage	$V_{CM} \pm 0.025$			V
<b>CLOCK INPUT</b>					
Input clock frequency	Sampling clock frequency	15 <sup>(2)</sup>		125 <sup>(3)</sup>	MSPS
	Sine wave, ac-coupled	0.2	1.5		$V_{PP}$
	LVPECL, ac-coupled		1.6		
	LVDS, ac-coupled		0.7		
Input clock duty cycle		35%	50%	65%	
Input clock common-mode voltage			0.95		V
<b>DIGITAL OUTPUTS</b>					
$C_{LOAD}$	Maximum external load capacitance from each output pin to GND		3.3		pF
$R_{LOAD}$	Differential load resistance placed externally		100		$\Omega$

(1) To reset the device for the first time after power-up, only use the RESET pin; see the *Register Initialization* section.

(2) See [Table 3](#) for details.

(3) With the clock divider enabled by default for divide-by-1. Maximum sampling clock frequency for the divide-by-4 option is 500 MSPS.

## 7.4 Thermal Information

THERMAL METRIC <sup>(1)</sup>			ADC322x	UNIT
			RGZ (VQFN)	
			48 PINS	
R <sub>θJA</sub>	Junction-to-ambient thermal resistance		25.7	°C/W
R <sub>θJC(top)</sub>	Junction-to-case (top) thermal resistance		18.9	°C/W
R <sub>θJB</sub>	Junction-to-board thermal resistance		3.0	°C/W
Ψ <sub>JT</sub>	Junction-to-top characterization parameter		0.2	°C/W
Ψ <sub>JB</sub>	Junction-to-board characterization parameter		3	°C/W
R <sub>θJC(bot)</sub>	Junction-to-case (bottom) thermal resistance		0.5	°C/W

(1) For more information about traditional and new thermal metrics, see the *IC Package Thermal Metrics* application report, [SPRA953](#).

## 7.5 Electrical Characteristics: ADC3221, ADC3222

typical values are over the operating free-air temperature range, at T<sub>A</sub> = 25°C, full temperature range is T<sub>MIN</sub> = -40°C to T<sub>MAX</sub> = 85°C, maximum sampling rate, 50% clock duty cycle, AVDD = DVDD = 1.8 V, and -1-dBFS differential input (unless otherwise noted)

PARAMETER	ADC3241			ADC3242			UNIT
	MIN	TYP	MAX	MIN	TYP	MAX	
ADC clock frequency			125			125	MSPS
1.8-V analog supply current		31	71		39	81	mA
1.8-V digital supply current		35	65		43	75	mA
Total power dissipation	118	205		147	245		mW
Global power-down dissipation		5	17		5	17	mW
Standby power-down dissipation		78	103		78	103	mW

## 7.6 Electrical Characteristics: ADC3223, ADC3224

typical values are over the operating free-air temperature range, at T<sub>A</sub> = 25°C, full temperature range is T<sub>MIN</sub> = -40°C to T<sub>MAX</sub> = 85°C, maximum sampling rate, 50% clock duty cycle, AVDD = DVDD = 1.8 V, and -1-dBFS differential input (unless otherwise noted)

PARAMETER	ADC3243			ADC3244			UNIT
	MIN	TYP	MAX	MIN	TYP	MAX	
ADC clock frequency			80			125	MSPS
1.8-V analog supply current		50	91		65	106	mA
1.8-V digital supply current		52	85		64	95	mA
Total power dissipation	183	285		233	325		mW
Global power-down dissipation		5	17		5	17	mW
Standby power-down dissipation		72	103		78	103	mW

## ADC3221, ADC3222, ADC3223, ADC3224

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### 7.7 Electrical Characteristics: General

typical values are over the operating free-air temperature range, at  $T_A = 25^\circ\text{C}$ , full temperature range is  $T_{\text{MIN}} = -40^\circ\text{C}$  to  $T_{\text{MAX}} = 85^\circ\text{C}$ , maximum sampling rate, 50% clock duty cycle, AVDD = DVDD = 1.8 V, and -1-dBFS differential input (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
<b>RESOLUTION</b>					
Resolution		12			Bits
<b>ANALOG INPUT</b>					
Differential input full-scale		2.0			$\text{V}_{\text{PP}}$
$R_{\text{IN}}$	Input resistance	6.6			$\text{k}\Omega$
$C_{\text{IN}}$	Input capacitance	3.7			$\text{pF}$
$V_{\text{OC(VCM)}}$	VCM common-mode voltage output	0.95			$\text{V}$
VCM output current capability		10			$\text{mA}$
Input common-mode current	Per analog input pin	1.5			$\mu\text{A}/\text{MSPS}$
Analog input bandwidth (3 dB)	50- $\Omega$ differential source driving 50- $\Omega$ termination across INP and INM	540			$\text{MHz}$
<b>DC ACCURACY</b>					
$E_{\text{O}}$	Offset error	-25		25	$\text{mV}$
$\alpha_{\text{EO}}$	Temperature coefficient of offset error	$\pm 0.024$			$\text{mV}/\text{C}$
$E_{\text{G(REF)}}$	Gain error as a result of internal reference inaccuracy alone	-2%		2%	
$E_{\text{G(CHAN)}}$	Gain error of channel alone	-2			$\%/\text{FS}$
$\alpha_{\text{EGCHAN}}$	Temperature coefficient of $E_{\text{G(CHAN)}}$	$\pm 0.008$			$\Delta\%/\text{FS}/^\circ\text{C}$
<b>CHANNEL-TO-CHANNEL ISOLATION</b>					
Crosstalk <sup>(1)</sup>	$f_{\text{IN}} = 10 \text{ MHz}$	105	dB		
	$f_{\text{IN}} = 100 \text{ MHz}$	105			
	$f_{\text{IN}} = 200 \text{ MHz}$	105			
	$f_{\text{IN}} = 230 \text{ MHz}$	105			
	$f_{\text{IN}} = 300 \text{ MHz}$	105			

(1) Crosstalk is measured with a -1-dBFS input signal on one channel and no input on the other channel.

## 7.8 AC Performance: ADC3221

typical values are over the operating free-air temperature range, at  $T_A = 25^\circ\text{C}$ , full temperature range is  $T_{\text{MIN}} = -40^\circ\text{C}$  to  $T_{\text{MAX}} = 85^\circ\text{C}$ , ADC sampling rate = 25 MSPS, 50% clock duty cycle, AVDD = DVDD = 1.8 V, and  $-1\text{-dBFS}$  differential input (unless otherwise noted)

PARAMETER	TEST CONDITIONS	ADC3221 ( $f_S = 25 \text{ MSPS}$ )						UNIT	
		DITHER ON			DITHER OFF				
		MIN	TYP	MAX	MIN	TYP	MAX		
<b>DYNAMIC AC CHARACTERISTICS</b>									
SNR	Signal-to-noise ratio (from 1-MHz offset)	$f_{\text{IN}} = 10 \text{ MHz}$	70.9	71.2				dBFS	
		$f_{\text{IN}} = 20 \text{ MHz}$	68.5	70.8	71.1				
		$f_{\text{IN}} = 70 \text{ MHz}$	70.6	70.9					
		$f_{\text{IN}} = 100 \text{ MHz}$	70.3	70.6					
		$f_{\text{IN}} = 170 \text{ MHz}$	69.7	69.9					
		$f_{\text{IN}} = 230 \text{ MHz}$	68.8	69					
	Signal-to-noise ratio (full Nyquist band)	$f_{\text{IN}} = 10 \text{ MHz}$	70.2	70.6				dBFS	
		$f_{\text{IN}} = 20 \text{ MHz}$	70.2	70.5					
		$f_{\text{IN}} = 70 \text{ MHz}$	69.9	70.2					
		$f_{\text{IN}} = 100 \text{ MHz}$	69.6	69.9					
		$f_{\text{IN}} = 170 \text{ MHz}$	69.2	69.3					
		$f_{\text{IN}} = 230 \text{ MHz}$	68.2	68.4					
NSD <sup>(1)</sup>	Noise spectral density (averaged across Nyquist zone)	$f_{\text{IN}} = 10 \text{ MHz}$	-141.9	-142.2				dBFS/Hz	
		$f_{\text{IN}} = 20 \text{ MHz}$	-141.8	-139.5	-142.1				
		$f_{\text{IN}} = 70 \text{ MHz}$	-141.6	-141.9					
		$f_{\text{IN}} = 100 \text{ MHz}$	-141.3	-141.6					
		$f_{\text{IN}} = 170 \text{ MHz}$	-140.7	-140.9					
		$f_{\text{IN}} = 230 \text{ MHz}$	-139.8	-140.0					
SINAD <sup>(1)</sup>	Signal-to-noise and distortion ratio	$f_{\text{IN}} = 10 \text{ MHz}$	70.9	71.1				dBFS	
		$f_{\text{IN}} = 20 \text{ MHz}$	68.1	70.8	71				
		$f_{\text{IN}} = 70 \text{ MHz}$	70.6	70.7					
		$f_{\text{IN}} = 100 \text{ MHz}$	70.2	70.3					
		$f_{\text{IN}} = 170 \text{ MHz}$	69.6	69.6					
		$f_{\text{IN}} = 230 \text{ MHz}$	68.5	68.5					
ENOB <sup>(1)</sup>	Effective number of bits	$f_{\text{IN}} = 10 \text{ MHz}$	11.5	11.5				Bits	
		$f_{\text{IN}} = 20 \text{ MHz}$	11	11.5	11.5				
		$f_{\text{IN}} = 70 \text{ MHz}$	11.4	11.5					
		$f_{\text{IN}} = 100 \text{ MHz}$	11.4	11.4					
		$f_{\text{IN}} = 170 \text{ MHz}$	11.3	11.3					
		$f_{\text{IN}} = 230 \text{ MHz}$	11.1	11.1					
SFDR	Spurious-free dynamic range	$f_{\text{IN}} = 10 \text{ MHz}$	96	88				dBc	
		$f_{\text{IN}} = 20 \text{ MHz}$	82	93	89				
		$f_{\text{IN}} = 70 \text{ MHz}$	93	87					
		$f_{\text{IN}} = 100 \text{ MHz}$	85	82					
		$f_{\text{IN}} = 170 \text{ MHz}$	86	83					
		$f_{\text{IN}} = 230 \text{ MHz}$	81	80					

(1) Reported from a 1-MHz offset.

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**AC Performance: ADC3221 (continued)**

typical values are over the operating free-air temperature range, at  $T_A = 25^\circ\text{C}$ , full temperature range is  $T_{\text{MIN}} = -40^\circ\text{C}$  to  $T_{\text{MAX}} = 85^\circ\text{C}$ , ADC sampling rate = 25 MSPS, 50% clock duty cycle, AVDD = DVDD = 1.8 V, and  $-1\text{-dBFS}$  differential input (unless otherwise noted)

PARAMETER	TEST CONDITIONS	ADC3221 ( $f_S = 25 \text{ MSPS}$ )						UNIT	
		DITHER ON			DITHER OFF				
		MIN	TYP	MAX	MIN	TYP	MAX		
HD2	Second-order harmonic distortion	$f_{\text{IN}} = 10 \text{ MHz}$	106		97			dBc	
		$f_{\text{IN}} = 20 \text{ MHz}$	82	102	95				
		$f_{\text{IN}} = 70 \text{ MHz}$	101		95				
		$f_{\text{IN}} = 100 \text{ MHz}$	95		93				
		$f_{\text{IN}} = 170 \text{ MHz}$	88		87				
		$f_{\text{IN}} = 230 \text{ MHz}$	81		81				
HD3	Third-order harmonic distortion	$f_{\text{IN}} = 10 \text{ MHz}$	96		88			dBc	
		$f_{\text{IN}} = 20 \text{ MHz}$	82	93	92				
		$f_{\text{IN}} = 70 \text{ MHz}$	93		87				
		$f_{\text{IN}} = 100 \text{ MHz}$	85		82				
		$f_{\text{IN}} = 170 \text{ MHz}$	87		83				
		$f_{\text{IN}} = 230 \text{ MHz}$	82		80				
Non HD2, HD3	Spurious-free dynamic range (excluding HD2, HD3)	$f_{\text{IN}} = 10 \text{ MHz}$	99		92			dBc	
		$f_{\text{IN}} = 20 \text{ MHz}$	87	101	91				
		$f_{\text{IN}} = 70 \text{ MHz}$	99		93				
		$f_{\text{IN}} = 100 \text{ MHz}$	98		92				
		$f_{\text{IN}} = 170 \text{ MHz}$	99		92				
		$f_{\text{IN}} = 230 \text{ MHz}$	97		93				
THD	Total harmonic distortion	$f_{\text{IN}} = 10 \text{ MHz}$	94		85			dBc	
		$f_{\text{IN}} = 20 \text{ MHz}$	80	92	85				
		$f_{\text{IN}} = 70 \text{ MHz}$	91		85				
		$f_{\text{IN}} = 100 \text{ MHz}$	86		82				
		$f_{\text{IN}} = 170 \text{ MHz}$	84		81				
		$f_{\text{IN}} = 230 \text{ MHz}$	78		77				
IMD3	Two-tone, third-order intermodulation distortion	$f_{\text{IN}1} = 45 \text{ MHz}$ , $f_{\text{IN}2} = 50 \text{ MHz}$		-95		-94		dBFS	
		$f_{\text{IN}1} = 185 \text{ MHz}$ , $f_{\text{IN}2} = 190 \text{ MHz}$		-90		-89			

## 7.9 AC Performance: ADC3222

typical values are over the operating free-air temperature range, at  $T_A = 25^\circ\text{C}$ , full temperature range is  $T_{\text{MIN}} = -40^\circ\text{C}$  to  $T_{\text{MAX}} = 85^\circ\text{C}$ , ADC sampling rate = 50 MSPS, 50% clock duty cycle, AVDD = DVDD = 1.8 V, and  $-1\text{-dBFS}$  differential input (unless otherwise noted)

PARAMETER	TEST CONDITIONS	ADC3222 ( $f_S = 50 \text{ MSPS}$ )						UNIT	
		DITHER ON			DITHER OFF				
		MIN	TYP	MAX	MIN	TYP	MAX		
<b>DYNAMIC AC CHARACTERISTICS</b>									
SNR	Signal-to-noise ratio (from 1-MHz offset)	$f_{\text{IN}} = 10 \text{ MHz}$	70.9		71.1			dBFS	
		$f_{\text{IN}} = 20 \text{ MHz}$	68.5	70.9		71.1			
		$f_{\text{IN}} = 70 \text{ MHz}$		70.7		70.9			
		$f_{\text{IN}} = 100 \text{ MHz}$		70.5		70.7			
		$f_{\text{IN}} = 170 \text{ MHz}$		70		70.1			
		$f_{\text{IN}} = 230 \text{ MHz}$		69.3		69.6			
	Signal-to-noise ratio (full Nyquist band)	$f_{\text{IN}} = 10 \text{ MHz}$		70.3		70.5			
		$f_{\text{IN}} = 20 \text{ MHz}$		70.1		70.3			
		$f_{\text{IN}} = 70 \text{ MHz}$		70.1		70.3			
		$f_{\text{IN}} = 100 \text{ MHz}$		69.9		70.2			
		$f_{\text{IN}} = 170 \text{ MHz}$		69.5		69.5			
		$f_{\text{IN}} = 230 \text{ MHz}$		68.7		69			
NSD <sup>(1)</sup>	Noise spectral density (averaged across Nyquist zone)	$f_{\text{IN}} = 10 \text{ MHz}$		-144.9		-145.1		dBFS/Hz	
		$f_{\text{IN}} = 20 \text{ MHz}$		-144.9	-142.5	-145.1			
		$f_{\text{IN}} = 70 \text{ MHz}$		-144.7		-144.9			
		$f_{\text{IN}} = 100 \text{ MHz}$		-144.5		-144.7			
		$f_{\text{IN}} = 170 \text{ MHz}$		-144.0		-144.1			
		$f_{\text{IN}} = 230 \text{ MHz}$		-143.3		-143.6			
SINAD <sup>(1)</sup>	Signal-to-noise and distortion ratio	$f_{\text{IN}} = 10 \text{ MHz}$		70.8		71		dBFS	
		$f_{\text{IN}} = 20 \text{ MHz}$	68	70.8		71			
		$f_{\text{IN}} = 70 \text{ MHz}$		70.6		70.8			
		$f_{\text{IN}} = 100 \text{ MHz}$		70.4		70.6			
		$f_{\text{IN}} = 170 \text{ MHz}$		69.8		69.9			
		$f_{\text{IN}} = 230 \text{ MHz}$		69		69.1			
ENOB <sup>(1)</sup>	Effective number of bits	$f_{\text{IN}} = 10 \text{ MHz}$		11.5		11.5		Bits	
		$f_{\text{IN}} = 20 \text{ MHz}$	11	11.5		11.5			
		$f_{\text{IN}} = 70 \text{ MHz}$		11.4		11.5			
		$f_{\text{IN}} = 100 \text{ MHz}$		11.4		11.4			
		$f_{\text{IN}} = 170 \text{ MHz}$		11.3		11.3			
		$f_{\text{IN}} = 230 \text{ MHz}$		11.2		11.2			
SFDR	Spurious-free dynamic range	$f_{\text{IN}} = 10 \text{ MHz}$		89		95		dBc	
		$f_{\text{IN}} = 20 \text{ MHz}$	82	95		91			
		$f_{\text{IN}} = 70 \text{ MHz}$		95		93			
		$f_{\text{IN}} = 100 \text{ MHz}$		88		86			
		$f_{\text{IN}} = 170 \text{ MHz}$		85		83			
		$f_{\text{IN}} = 230 \text{ MHz}$		82		81			

(1) Reported from a 1-MHz offset.

## ADC3221, ADC3222, ADC3223, ADC3224

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### AC Performance: ADC3222 (continued)

typical values are over the operating free-air temperature range, at  $T_A = 25^\circ\text{C}$ , full temperature range is  $T_{\text{MIN}} = -40^\circ\text{C}$  to  $T_{\text{MAX}} = 85^\circ\text{C}$ , ADC sampling rate = 50 MSPS, 50% clock duty cycle, AVDD = DVDD = 1.8 V, and  $-1\text{-dBFS}$  differential input (unless otherwise noted)

PARAMETER	TEST CONDITIONS	ADC3222 ( $f_S = 50 \text{ MSPS}$ )						UNIT	
		DITHER ON			DITHER OFF				
		MIN	TYP	MAX	MIN	TYP	MAX		
HD2	Second-order harmonic distortion	$f_{\text{IN}} = 10 \text{ MHz}$	103		97			dBc	
		$f_{\text{IN}} = 20 \text{ MHz}$	82	100	94				
		$f_{\text{IN}} = 70 \text{ MHz}$	97		94				
		$f_{\text{IN}} = 100 \text{ MHz}$	94		93				
		$f_{\text{IN}} = 170 \text{ MHz}$	89		89				
		$f_{\text{IN}} = 230 \text{ MHz}$	83		83				
HD3	Third-order harmonic distortion	$f_{\text{IN}} = 10 \text{ MHz}$	89		96			dBc	
		$f_{\text{IN}} = 20 \text{ MHz}$	82	94	95				
		$f_{\text{IN}} = 70 \text{ MHz}$	95		93				
		$f_{\text{IN}} = 100 \text{ MHz}$	88		86				
		$f_{\text{IN}} = 170 \text{ MHz}$	85		83				
		$f_{\text{IN}} = 230 \text{ MHz}$	83		81				
Non HD2, HD3	Spurious-free dynamic range (excluding HD2, HD3)	$f_{\text{IN}} = 10 \text{ MHz}$	99		95			dBc	
		$f_{\text{IN}} = 20 \text{ MHz}$	87	101	93				
		$f_{\text{IN}} = 70 \text{ MHz}$	99		94				
		$f_{\text{IN}} = 100 \text{ MHz}$	100		94				
		$f_{\text{IN}} = 170 \text{ MHz}$	99		93				
		$f_{\text{IN}} = 230 \text{ MHz}$	97		93				
THD	Total harmonic distortion	$f_{\text{IN}} = 10 \text{ MHz}$	89		89			dBc	
		$f_{\text{IN}} = 20 \text{ MHz}$	80	93	87				
		$f_{\text{IN}} = 70 \text{ MHz}$	92		88				
		$f_{\text{IN}} = 100 \text{ MHz}$	90		86				
		$f_{\text{IN}} = 170 \text{ MHz}$	83		81				
		$f_{\text{IN}} = 230 \text{ MHz}$	80		78				
IMD3	Two-tone, third-order intermodulation distortion	$f_{\text{IN}1} = 45 \text{ MHz}$ , $f_{\text{IN}2} = 50 \text{ MHz}$		-95		-92		dBFS	
		$f_{\text{IN}1} = 185 \text{ MHz}$ , $f_{\text{IN}2} = 190 \text{ MHz}$		-92		-92			

## 7.10 AC Performance: ADC3223

typical values are over the operating free-air temperature range, at  $T_A = 25^\circ\text{C}$ , full temperature range is  $T_{\text{MIN}} = -40^\circ\text{C}$  to  $T_{\text{MAX}} = 85^\circ\text{C}$ , ADC sampling rate = 80 MSPS, 50% clock duty cycle, AVDD = DVDD = 1.8 V, and  $-1\text{-dBFS}$  differential input (unless otherwise noted)

PARAMETER	TEST CONDITIONS	ADC3223 ( $f_S = 80 \text{ MSPS}$ )						UNIT	
		DITHER ON			DITHER OFF				
		MIN	TYP	MAX	MIN	TYP	MAX		
<b>DYNAMIC AC CHARACTERISTICS</b>									
SNR	Signal-to-noise ratio (from 1-MHz offset)	$f_{\text{IN}} = 10 \text{ MHz}$	70.7	70.9				dBFS	
		$f_{\text{IN}} = 70 \text{ MHz}$	68.5	70.6					
		$f_{\text{IN}} = 100 \text{ MHz}$	70.5	70.7					
		$f_{\text{IN}} = 170 \text{ MHz}$	70.1	70.3					
		$f_{\text{IN}} = 230 \text{ MHz}$	69.7	69.9					
	Signal-to-noise ratio (full Nyquist band)	$f_{\text{IN}} = 10 \text{ MHz}$	70.3	70.5					
		$f_{\text{IN}} = 70 \text{ MHz}$	70.2	70.5					
		$f_{\text{IN}} = 100 \text{ MHz}$	70.1	70.4					
		$f_{\text{IN}} = 170 \text{ MHz}$	69.7	69.9					
		$f_{\text{IN}} = 230 \text{ MHz}$	69.4	69.6					
NSD <sup>(1)</sup>	Noise spectral density (averaged across Nyquist zone)	$f_{\text{IN}} = 10 \text{ MHz}$	-146.7	-146.9				dBFS/Hz	
		$f_{\text{IN}} = 70 \text{ MHz}$	-146.6	-144.5	-146.8				
		$f_{\text{IN}} = 100 \text{ MHz}$	-146.5	-146.7					
		$f_{\text{IN}} = 170 \text{ MHz}$	-146.1	-146.3					
		$f_{\text{IN}} = 230 \text{ MHz}$	-145.7	-145.9					
SINAD <sup>(1)</sup>	Signal-to-noise and distortion ratio	$f_{\text{IN}} = 10 \text{ MHz}$	70.7	70.9				dBFS	
		$f_{\text{IN}} = 70 \text{ MHz}$	68.1	70.6	70.8				
		$f_{\text{IN}} = 100 \text{ MHz}$	70.5	70.6					
		$f_{\text{IN}} = 170 \text{ MHz}$	70	70.2					
		$f_{\text{IN}} = 230 \text{ MHz}$	69.5	69.6					
ENOB <sup>(1)</sup>	Effective number of bits	$f_{\text{IN}} = 10 \text{ MHz}$	11.4	11.5				Bits	
		$f_{\text{IN}} = 70 \text{ MHz}$	11.02	11.4	11.5				
		$f_{\text{IN}} = 100 \text{ MHz}$	11.4	11.4	11.4				
		$f_{\text{IN}} = 170 \text{ MHz}$	11.3	11.4	11.4				
		$f_{\text{IN}} = 230 \text{ MHz}$	11.3	11.3	11.3				
SFDR	Spurious-free dynamic range	$f_{\text{IN}} = 10 \text{ MHz}$	88	95				dBc	
		$f_{\text{IN}} = 70 \text{ MHz}$	82	94	93				
		$f_{\text{IN}} = 100 \text{ MHz}$	93	93	92				
		$f_{\text{IN}} = 170 \text{ MHz}$	88	88	87				
		$f_{\text{IN}} = 230 \text{ MHz}$	85	85	84				

(1) Reported from a 1-MHz offset.

**ADC3221, ADC3222, ADC3223, ADC3224**

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**AC Performance: ADC3223 (continued)**

typical values are over the operating free-air temperature range, at  $T_A = 25^\circ\text{C}$ , full temperature range is  $T_{\text{MIN}} = -40^\circ\text{C}$  to  $T_{\text{MAX}} = 85^\circ\text{C}$ , ADC sampling rate = 80 MSPS, 50% clock duty cycle, AVDD = DVDD = 1.8 V, and  $-1\text{-dBFS}$  differential input (unless otherwise noted)

PARAMETER	TEST CONDITIONS	ADC3223 ( $f_S = 80 \text{ MSPS}$ )						UNIT	
		DITHER ON			DITHER OFF				
		MIN	TYP	MAX	MIN	TYP	MAX		
HD2	Second-order harmonic distortion	$f_{\text{IN}} = 10 \text{ MHz}$	104		99			dBc	
		$f_{\text{IN}} = 70 \text{ MHz}$	82	95	94				
		$f_{\text{IN}} = 100 \text{ MHz}$	95		93				
		$f_{\text{IN}} = 170 \text{ MHz}$	88		87				
		$f_{\text{IN}} = 230 \text{ MHz}$	85		85				
HD3	Third-order harmonic distortion	$f_{\text{IN}} = 10 \text{ MHz}$	89		95			dBc	
		$f_{\text{IN}} = 70 \text{ MHz}$	82	94	94				
		$f_{\text{IN}} = 100 \text{ MHz}$	95		96				
		$f_{\text{IN}} = 170 \text{ MHz}$	93		90				
		$f_{\text{IN}} = 230 \text{ MHz}$	89		85				
Non HD2, HD3	Spurious-free dynamic range (excluding HD2, HD3)	$f_{\text{IN}} = 10 \text{ MHz}$	94		93			dBc	
		$f_{\text{IN}} = 70 \text{ MHz}$	87	100	95				
		$f_{\text{IN}} = 100 \text{ MHz}$	99		96				
		$f_{\text{IN}} = 170 \text{ MHz}$	99		95				
		$f_{\text{IN}} = 230 \text{ MHz}$	98		95				
THD	Total harmonic distortion	$f_{\text{IN}} = 10 \text{ MHz}$	88		91			dBc	
		$f_{\text{IN}} = 70 \text{ MHz}$	79.5	91	89				
		$f_{\text{IN}} = 100 \text{ MHz}$	91		88				
		$f_{\text{IN}} = 170 \text{ MHz}$	86		84				
		$f_{\text{IN}} = 230 \text{ MHz}$	83		81				
IMD3	Two-tone, third-order intermodulation distortion	$f_{\text{IN}1} = 45 \text{ MHz}$ , $f_{\text{IN}2} = 50 \text{ MHz}$		-94		-94		dBFS	
		$f_{\text{IN}1} = 185 \text{ MHz}$ , $f_{\text{IN}2} = 190 \text{ MHz}$		-92		-90			

## 7.11 AC Performance: ADC3224

typical values are over the operating free-air temperature range, at  $T_A = 25^\circ\text{C}$ , full temperature range is  $T_{\text{MIN}} = -40^\circ\text{C}$  to  $T_{\text{MAX}} = 85^\circ\text{C}$ , ADC sampling rate = 125 MSPS, 50% clock duty cycle, AVDD = DVDD = 1.8 V, and  $-1\text{-dBFS}$  differential input (unless otherwise noted)

PARAMETER	TEST CONDITIONS	ADC3224 ( $f_s = 125 \text{ MSPS}$ )						UNIT	
		DITHER ON			DITHER OFF				
		MIN	TYP	MAX	MIN	TYP	MAX		
<b>DYNAMIC AC CHARACTERISTICS</b>									
SNR	Signal-to-noise ratio (from 1-MHz offset)	$f_{\text{IN}} = 10 \text{ MHz}$	70.5		70.8			dBFS	
		$f_{\text{IN}} = 70 \text{ MHz}$	68.5	70.4		70.7			
		$f_{\text{IN}} = 100 \text{ MHz}$		70.3		70.6			
		$f_{\text{IN}} = 170 \text{ MHz}$		69.9		70.2			
		$f_{\text{IN}} = 230 \text{ MHz}$		69.4		69.8			
	Signal-to-noise ratio (full Nyquist band)	$f_{\text{IN}} = 10 \text{ MHz}$	70.3		70.6				
		$f_{\text{IN}} = 70 \text{ MHz}$		70.2		70.5			
		$f_{\text{IN}} = 100 \text{ MHz}$		70.2		70.4			
		$f_{\text{IN}} = 170 \text{ MHz}$		69.7		70.0			
		$f_{\text{IN}} = 230 \text{ MHz}$		69.2		69.6			
NSD <sup>(1)</sup>	Noise spectral density (averaged across Nyquist zone)	$f_{\text{IN}} = 10 \text{ MHz}$		-148.5		-148.8		dBFS/Hz	
		$f_{\text{IN}} = 70 \text{ MHz}$		-148.4	-146.5	-148.7			
		$f_{\text{IN}} = 100 \text{ MHz}$		-148.3		-148.6			
		$f_{\text{IN}} = 170 \text{ MHz}$		-147.9		-148.2			
		$f_{\text{IN}} = 230 \text{ MHz}$		-147.4		-147.8			
SINAD <sup>(1)</sup>	Signal-to-noise and distortion ratio	$f_{\text{IN}} = 10 \text{ MHz}$	70.5		70.6			dBFS	
		$f_{\text{IN}} = 70 \text{ MHz}$	68	70.4		70.6			
		$f_{\text{IN}} = 100 \text{ MHz}$		70.2		70.3			
		$f_{\text{IN}} = 170 \text{ MHz}$		69.7		69.9			
		$f_{\text{IN}} = 230 \text{ MHz}$		69.2		69.5			
ENOB <sup>(1)</sup>	Effective number of bits	$f_{\text{IN}} = 10 \text{ MHz}$		11.4		11.4		Bits	
		$f_{\text{IN}} = 70 \text{ MHz}$	11	11.4		11.4			
		$f_{\text{IN}} = 100 \text{ MHz}$		11.4		11.4			
		$f_{\text{IN}} = 170 \text{ MHz}$		11.3		11.3			
		$f_{\text{IN}} = 230 \text{ MHz}$		11.2		11.2			
SFDR	Spurious-free dynamic range	$f_{\text{IN}} = 10 \text{ MHz}$		93		87		dBc	
		$f_{\text{IN}} = 70 \text{ MHz}$	82	95		89			
		$f_{\text{IN}} = 100 \text{ MHz}$		89		86			
		$f_{\text{IN}} = 170 \text{ MHz}$		86		85			
		$f_{\text{IN}} = 230 \text{ MHz}$		83		83			

(1) Reported from a 1-MHz offset.

**ADC3221, ADC3222, ADC3223, ADC3224**

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**AC Performance: ADC3224 (continued)**

typical values are over the operating free-air temperature range, at  $T_A = 25^\circ\text{C}$ , full temperature range is  $T_{\text{MIN}} = -40^\circ\text{C}$  to  $T_{\text{MAX}} = 85^\circ\text{C}$ , ADC sampling rate = 125 MSPS, 50% clock duty cycle, AVDD = DVDD = 1.8 V, and –1-dBFS differential input (unless otherwise noted)

PARAMETER	TEST CONDITIONS	ADC3224 ( $f_S = 125 \text{ MSPS}$ )						UNIT	
		DITHER ON			DITHER OFF				
		MIN	TYP	MAX	MIN	TYP	MAX		
HD2	Second-order harmonic distortion	$f_{\text{IN}} = 10 \text{ MHz}$	96		96			dBc	
		$f_{\text{IN}} = 70 \text{ MHz}$	84	96		96			
		$f_{\text{IN}} = 100 \text{ MHz}$	91		91				
		$f_{\text{IN}} = 170 \text{ MHz}$	86		85				
		$f_{\text{IN}} = 230 \text{ MHz}$	83		83				
HD3	Third-order harmonic distortion	$f_{\text{IN}} = 10 \text{ MHz}$	94		87			dBc	
		$f_{\text{IN}} = 70 \text{ MHz}$	82	95		89			
		$f_{\text{IN}} = 100 \text{ MHz}$	91		86				
		$f_{\text{IN}} = 170 \text{ MHz}$	96		89				
		$f_{\text{IN}} = 230 \text{ MHz}$	88		85				
Non HD2, HD3	Spurious-free dynamic range (excluding HD2, HD3)	$f_{\text{IN}} = 10 \text{ MHz}$	99		96			dBc	
		$f_{\text{IN}} = 70 \text{ MHz}$	87	99		95			
		$f_{\text{IN}} = 100 \text{ MHz}$	99		95				
		$f_{\text{IN}} = 170 \text{ MHz}$	99		92				
		$f_{\text{IN}} = 230 \text{ MHz}$	97		92				
THD	Total harmonic distortion	$f_{\text{IN}} = 10 \text{ MHz}$	91		85			dBc	
		$f_{\text{IN}} = 70 \text{ MHz}$	80	91		86			
		$f_{\text{IN}} = 100 \text{ MHz}$	87		83				
		$f_{\text{IN}} = 170 \text{ MHz}$	85		82				
		$f_{\text{IN}} = 230 \text{ MHz}$	82		80				
IMD3	Two-tone, third-order intermodulation distortion	$f_{\text{IN}1} = 45 \text{ MHz}$ , $f_{\text{IN}2} = 50 \text{ MHz}$		–96		–95		dBFS	
		$f_{\text{IN}1} = 185 \text{ MHz}$ , $f_{\text{IN}2} = 190 \text{ MHz}$		–92		–88			

## 7.12 Digital Characteristics

the dc specifications refer to the condition where the digital outputs are not switching, but are permanently at a valid logic level 0 or 1; AVDD = DVDD = 1.8 V, and –1-dBFS differential input (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
<b>DIGITAL INPUTS (RESET, SCLK, SDATA, SEN, PDN)</b>						
$V_{IH}$	High-level input voltage	All digital inputs support 1.8-V and 3.3-V CMOS logic levels	1.3			V
$V_{IL}$	Low-level input voltage	All digital inputs support 1.8-V and 3.3-V CMOS logic levels		0.4		V
$I_{IH}$	High-level input current	$V_{HIGH} = 1.8$ V		10		$\mu$ A
	SEN <sup>(1)</sup>	$V_{HIGH} = 1.8$ V		0		
$I_{IL}$	Low-level input current	$V_{LOW} = 0$ V		0		$\mu$ A
	SEN	$V_{LOW} = 0$ V		10		
<b>DIGITAL INPUTS (SYSREFP, SYSREFM)</b>						
$V_{IH}$	High-level input voltage		1.3			V
$V_{IL}$	Low-level input voltage		0.5			V
Common-mode voltage for SYSREF			0.9			V
<b>DIGITAL OUTPUTS, CMOS INTERFACE (SDOUT)</b>						
$V_{OH}$	High-level output voltage		DVDD – 0.1	DVDD		V
$V_{OL}$	Low-level output voltage		0	0.1		V
<b>DIGITAL OUTPUTS, LVDS INTERFACE</b>						
$V_{ODH}$	High-level output differential voltage	With an external 100- $\Omega$ termination	280	350	460	mV
$V_{ODL}$	Low-level output differential voltage	With an external 100- $\Omega$ termination	–460	–350	–280	mV
$V_{OCM}$	Output common-mode voltage			1.05		V

(1) SEN has an internal 150-k $\Omega$  pull-up resistor to AVDD. SPI pins (SEN, SCLK, SDATA) can be driven by 1.8-V or 3.3-V CMOS buffers.

## 7.13 Timing Requirements: General

typical values are at  $T_A = 25^\circ\text{C}$ , AVDD = DVDD = 1.8 V, and –1-dBFS differential input (unless otherwise noted); minimum and maximum values are across the full temperature range:  $T_{MIN} = -40^\circ\text{C}$  to  $T_{MAX} = 85^\circ\text{C}$

		MIN	TYP	MAX	UNIT
$t_A$ Aperture delay		1.24	1.44	1.64	ns
Aperture delay matching between two channels of the same device			±70		ps
Aperture delay variation between two devices at same temperature and supply voltage			±150		ps
$t_J$	Aperture jitter		130		$f_S$ rms
Wake-up time	Time to valid data after exiting standby power-down mode		35	65	$\mu$ s
	Time to valid data after exiting global power-down mode (in this mode, both channels power down)		85	140	
ADC latency <sup>(1)</sup>	2-wire mode (default)		9		Clock cycles
	1-wire mode		8		
$t_{SU\_SYSREF}$	Setup time for SYSREF referenced to input clock rising edge	1000			ps
$t_{H\_SYSREF}$	Hold time for SYSREF referenced to input clock rising edge	100			

(1) Overall latency = ADC latency +  $t_{PDI}$ .

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### 7.14 Timing Requirements: LVDS Output

typical values are at  $T_A = 25^\circ\text{C}$ ,  $\text{AVDD} = \text{DVDD} = 1.8 \text{ V}$ , and  $-1\text{-dBFS}$  differential input, 6x serialization (2-wire mode),  $C_{\text{LOAD}} = 3.3 \text{ pF}^{(1)}$ , and  $R_{\text{LOAD}} = 100 \Omega^{(2)}$  (unless otherwise noted); minimum and maximum values are across the full temperature range:  $T_{\text{MIN}} = -40^\circ\text{C}$  to  $T_{\text{MAX}} = 85^\circ\text{C}^{(3)(4)}$

		MIN	TYP	MAX	UNIT
$t_{\text{SU}}$	Data setup time: data valid to zero-crossing of differential output clock (CLKOUTP – CLKOUTM) <sup>(5)</sup>	0.43	0.5		ns
$t_{\text{HO}}$	Data hold time: zero-crossing of differential output clock (CLKOUTP – CLKOUTM) to data becoming invalid <sup>(5)</sup>	0.48	0.58		ns
$t_{\text{PDI}}$	Clock propagation delay: input clock falling edge cross-over to frame clock rising edge cross-over (15 MSPS < sampling frequency < 125 MSPS)	1-wire mode	2.7	4.5	6.5
		2-wire mode		$0.44 \times t_{\text{S}} + t_{\text{DELAY}}$	ns
$t_{\text{DELAY}}$	Delay time	3	4.5	5.9	ns
	LVDS bit clock duty cycle: duty cycle of differential clock (CLKOUTP – CLKOUTM)		49%		
$t_{\text{FALL}}, t_{\text{RISE}}$	Data fall time, data rise time: rise time measured from $-100 \text{ mV}$ to $100 \text{ mV}$ , $15 \text{ MSPS} \leq \text{Sampling frequency} \leq 125 \text{ MSPS}$		0.11		ns
$t_{\text{CLKRISE}}, t_{\text{CLKFALL}}$	Output clock rise time, output clock fall time: rise time measured from $-100 \text{ mV}$ to $100 \text{ mV}$ , $10 \text{ MSPS} \leq \text{Sampling frequency} \leq 125 \text{ MSPS}$		0.11		ns

(1)  $C_{\text{LOAD}}$  is the effective external single-ended load capacitance between each output pin and ground.

(2)  $R_{\text{LOAD}}$  is the differential load resistance between the LVDS output pair.

(3) Measurements are done with a transmission line of a  $100\text{-}\Omega$  characteristic impedance between the device and load. Setup and hold time specifications take into account the effect of jitter on the output data and clock.

(4) Timing parameters are ensured by design and characterization and are not tested in production.

(5) Data valid refers to a logic high of  $100 \text{ mV}$  and a logic low of  $-100 \text{ mV}$ .

**Table 1. LVDS Timing at Lower Sampling Frequencies: 6X Serialization (2-Wire Mode)**

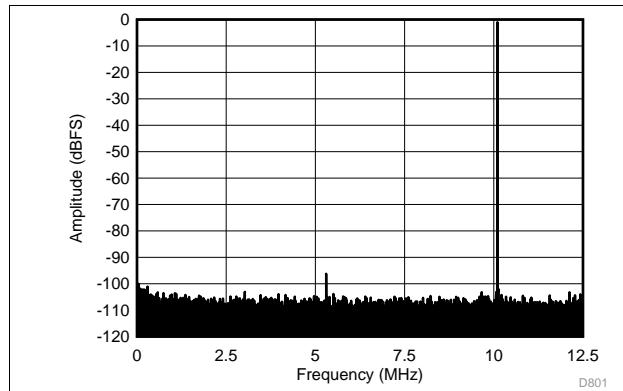
SAMPLING FREQUENCY (MSPS)	SETUP TIME ( $t_{\text{SU}}$ , ns)			HOLD TIME ( $t_{\text{HO}}$ , ns)		
	MIN	TYP	MAX	MIN	TYP	MAX
25	2.61	3.06		2.75	3.12	
40	1.69	1.9		1.8	1.98	
60	1.11	1.23		1.18	1.31	
80	0.81	0.89		0.88	0.97	
100	0.6	0.68		0.68	0.77	

**Table 2. LVDS Timings at Lower Sampling Frequencies: 12X Serialization (1-Wire Mode)**

SAMPLING FREQUENCY (MSPS)	SETUP TIME ( $t_{\text{SU}}$ , ns)			HOLD TIME ( $t_{\text{HO}}$ , ns)		
	MIN	TYP	MAX	MIN	TYP	MAX
25	1.3	1.48		1.32	1.57	
40	0.76	0.88		0.79	0.97	
50	0.57	0.68		0.61	0.77	
60	0.42	0.55		0.45	0.62	
70	0.35	0.44		0.4	0.51	
80	0.26	0.35		0.35	0.43	

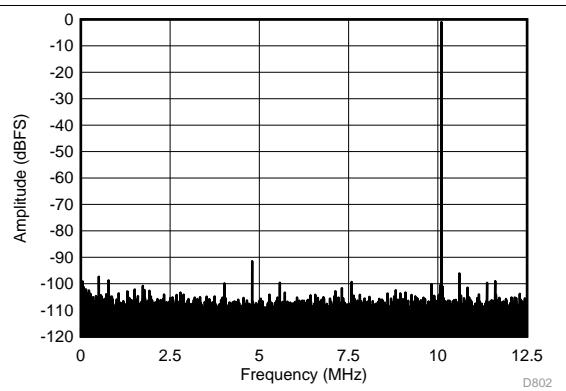
## 7.15 Typical Characteristics: ADC3221

typical values are at  $T_A = 25^\circ\text{C}$ , ADC sampling rate = 25 MSPS, 50% clock duty cycle, AVDD = 1.8 V, DVDD = 1.8 V, -1-dBFS differential input, 2- $V_{\text{PP}}$  full-scale, 32k-point FFT, chopper disabled, and SNR reported with a 1-MHz offset from dc when chopper is disabled and from  $f_s / 2$  when chopper is enabled (unless otherwise noted)



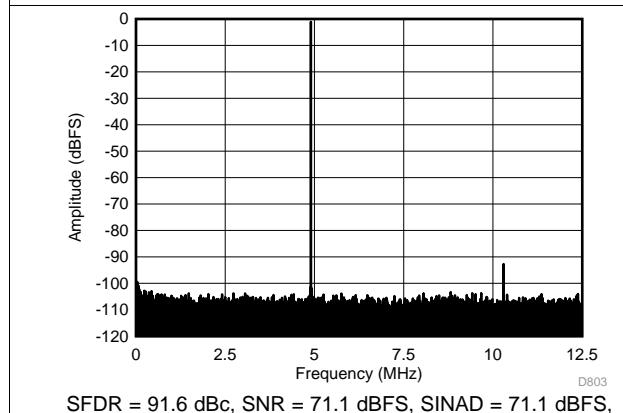
SFDR = 95.2 dBc, SNR = 71.2 dBFS, SINAD = 71.2 dBFS, THD = 94.1 dBc, HD2 = 106.0 dBc, HD3 = 95.2 dBc

**Figure 1. FFT for 10-MHz Input Signal (Dither On)**



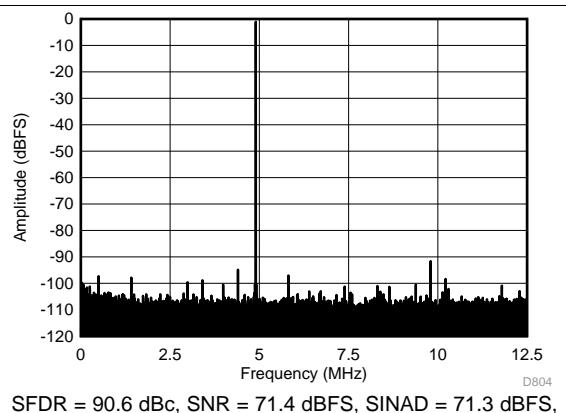
SFDR = 90.4 dBc, SNR = 71.6 dBFS, SINAD = 71.5 dBFS, THD = 88.6 dBc, HD2 = 90.4 dBc, HD3 = 105.5 dBc

**Figure 2. FFT for 10-MHz Input Signal (Dither Off)**



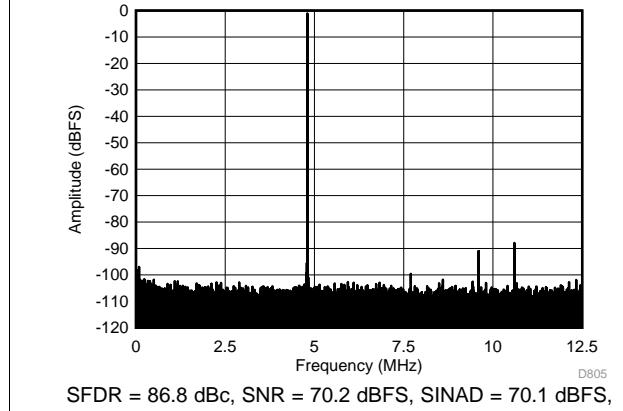
SFDR = 91.6 dBc, SNR = 71.1 dBFS, SINAD = 71.1 dBFS, THD = 91 dBc, HD2 = 105.3 dBc, HD3 = 91.6 dBc

**Figure 3. FFT for 70-MHz Input Signal (Dither On)**



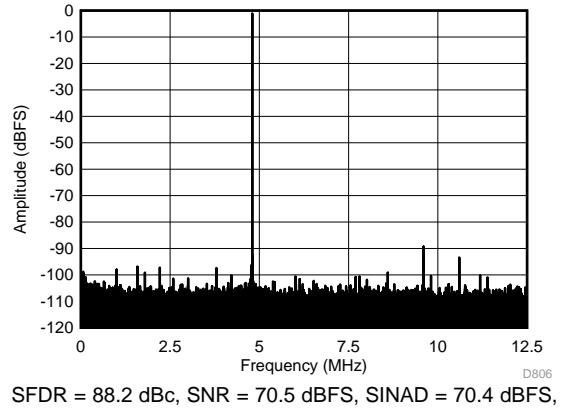
SFDR = 90.6 dBc, SNR = 71.4 dBFS, SINAD = 71.3 dBFS, THD = 88.4 dBc, HD2 = 90.6 dBc, HD3 = 101.1 dBc

**Figure 4. FFT for 70-MHz Input Signal (Dither Off)**



SFDR = 86.8 dBc, SNR = 70.2 dBFS, SINAD = 70.1 dBFS, THD = 84.8 dBc, HD2 = 89.9 dBc, HD3 = 86.8 dBc

**Figure 5. FFT for 170-MHz Input Signal (Dither On)**



SFDR = 88.2 dBc, SNR = 70.5 dBFS, SINAD = 70.4 dBFS, THD = 85.7 dBc, HD2 = 88.2 dBc, HD3 = 92.3 dBc

**Figure 6. FFT for 170-MHz Input Signal (Dither Off)**

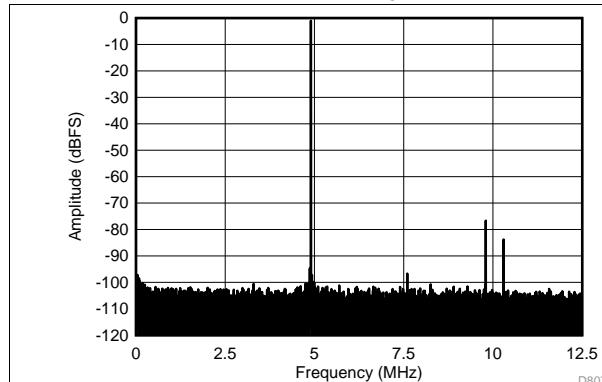
## ADC3221, ADC3222, ADC3223, ADC3224

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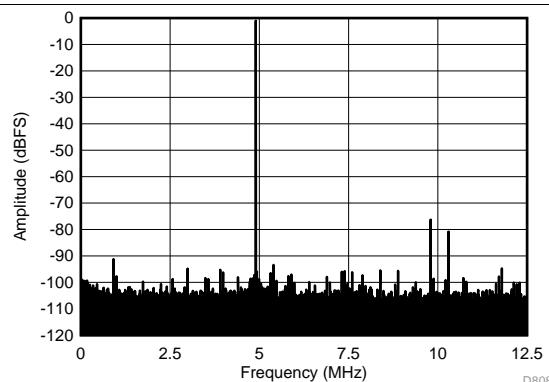
### Typical Characteristics: ADC3221 (continued)

typical values are at  $T_A = 25^\circ\text{C}$ , ADC sampling rate = 25 MSPS, 50% clock duty cycle, AVDD = 1.8 V, DVDD = 1.8 V, -1-dBFS differential input, 2-V<sub>PP</sub> full-scale, 32k-point FFT, chopper disabled, and SNR reported with a 1-MHz offset from dc when chopper is disabled and from  $f_S / 2$  when chopper is enabled (unless otherwise noted)



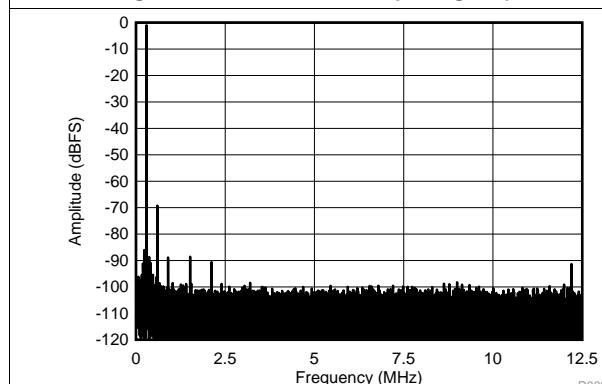
SFDR = 75.7 dBc, SNR = 68.6 dBFS, SINAD = 67.8 dBFS, THD = 74.9 dBc, HD2 = 75.7 dBc, HD3 = 82.8 dBc

Figure 7. FFT for 270-MHz Input Signal (Dither On)



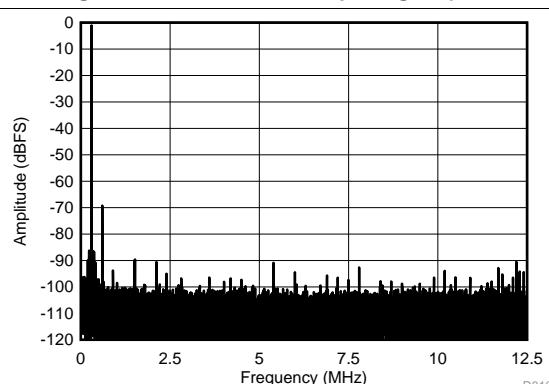
SFDR = 75.3 dBc, SNR = 68.7 dBFS, SINAD = 67.7 dBFS, THD = 73.8 dBc, HD2 = 75.3 dBc, HD3 = 79.8 dBc

Figure 8. FFT for 270-MHz Input Signal (Dither Off)



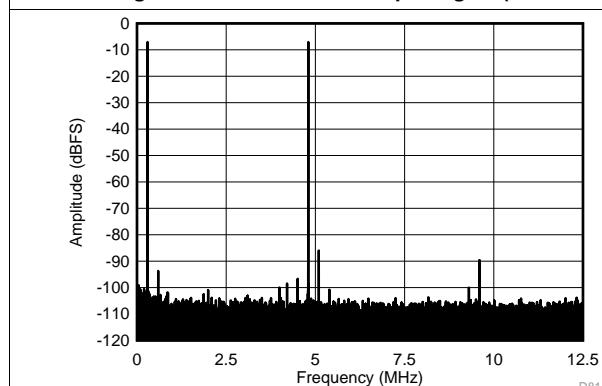
SFDR = 68.2 dBc, SNR = 66.6 dBFS, SINAD = 66.6 dBFS, THD = 92.7 dBc, HD2 = 68.2 dBc, HD3 = 87.8 dBc

Figure 9. FFT for 450-MHz Input Signal (Dither On)



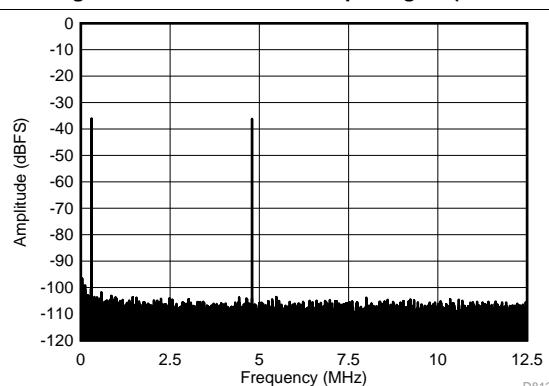
SFDR = 68.2 dBc, SNR = 66.5 dBFS, SINAD = 66.5 dBFS, THD = 87.1 dBc, HD2 = 68.2 dBc, HD3 = 92.7 dBc

Figure 10. FFT for 450-MHz Input Signal (Dither Off)



$f_{IN1} = 46$  MHz,  $f_{IN2} = 50$  MHz, IMD3 = 84 dBFS, each tone at -7 dBFS

Figure 11. FFT for Two-Tone Input Signal (-7 dBFS at 46 MHz and 50 MHz)

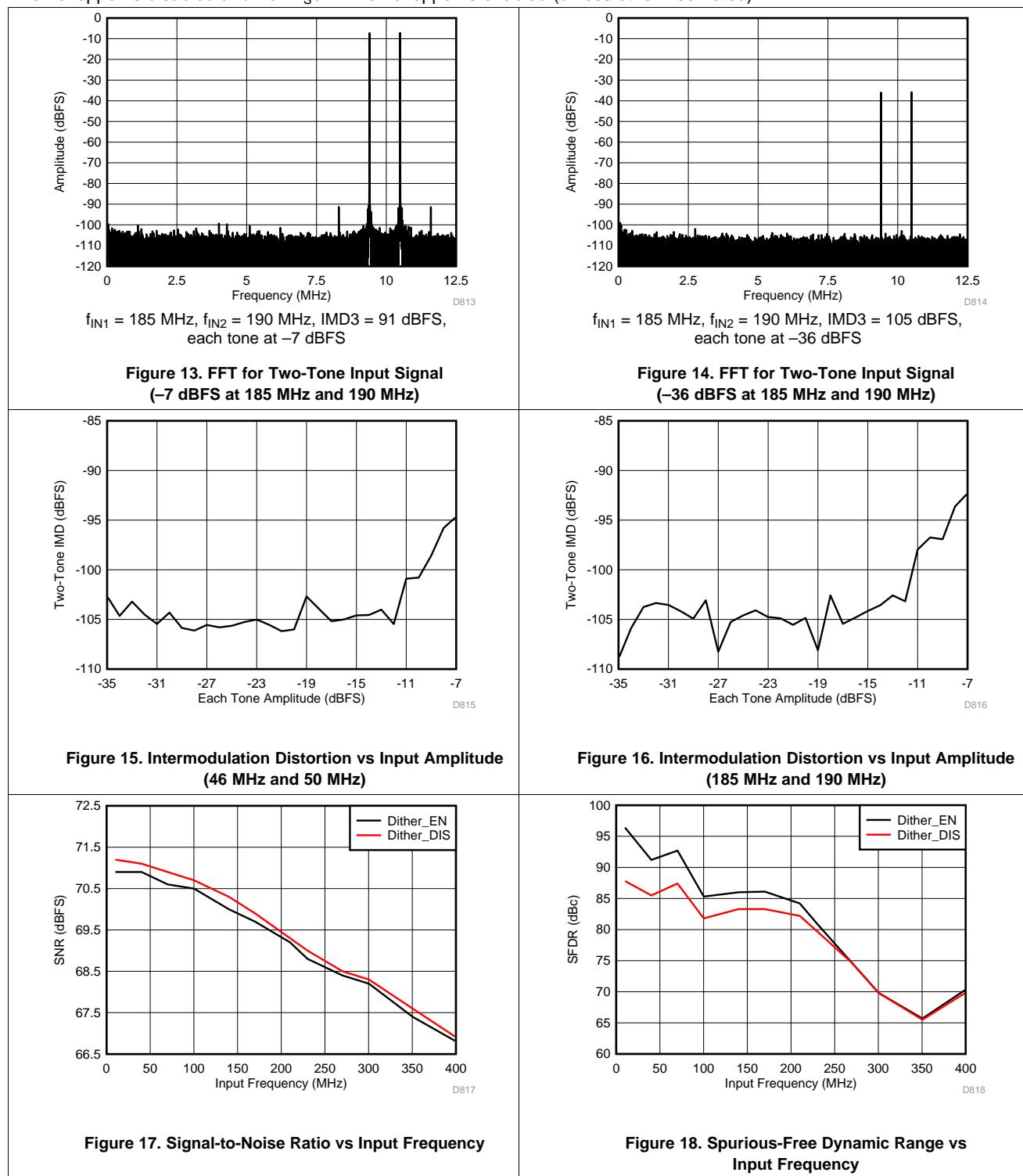


$f_{IN1} = 46$  MHz,  $f_{IN2} = 50$  MHz, IMD3 = 105 dBFS, each tone at -36 dBFS

Figure 12. FFT for Two-Tone Input Signal (-36 dBFS at 46 MHz and 50 MHz)

### Typical Characteristics: ADC3221 (continued)

typical values are at  $T_A = 25^\circ\text{C}$ , ADC sampling rate = 25 MSPS, 50% clock duty cycle, AVDD = 1.8 V, DVDD = 1.8 V, -1-dBFS differential input, 2-V<sub>PP</sub> full-scale, 32k-point FFT, chopper disabled, and SNR reported with a 1-MHz offset from dc when chopper is disabled and from  $f_S / 2$  when chopper is enabled (unless otherwise noted)



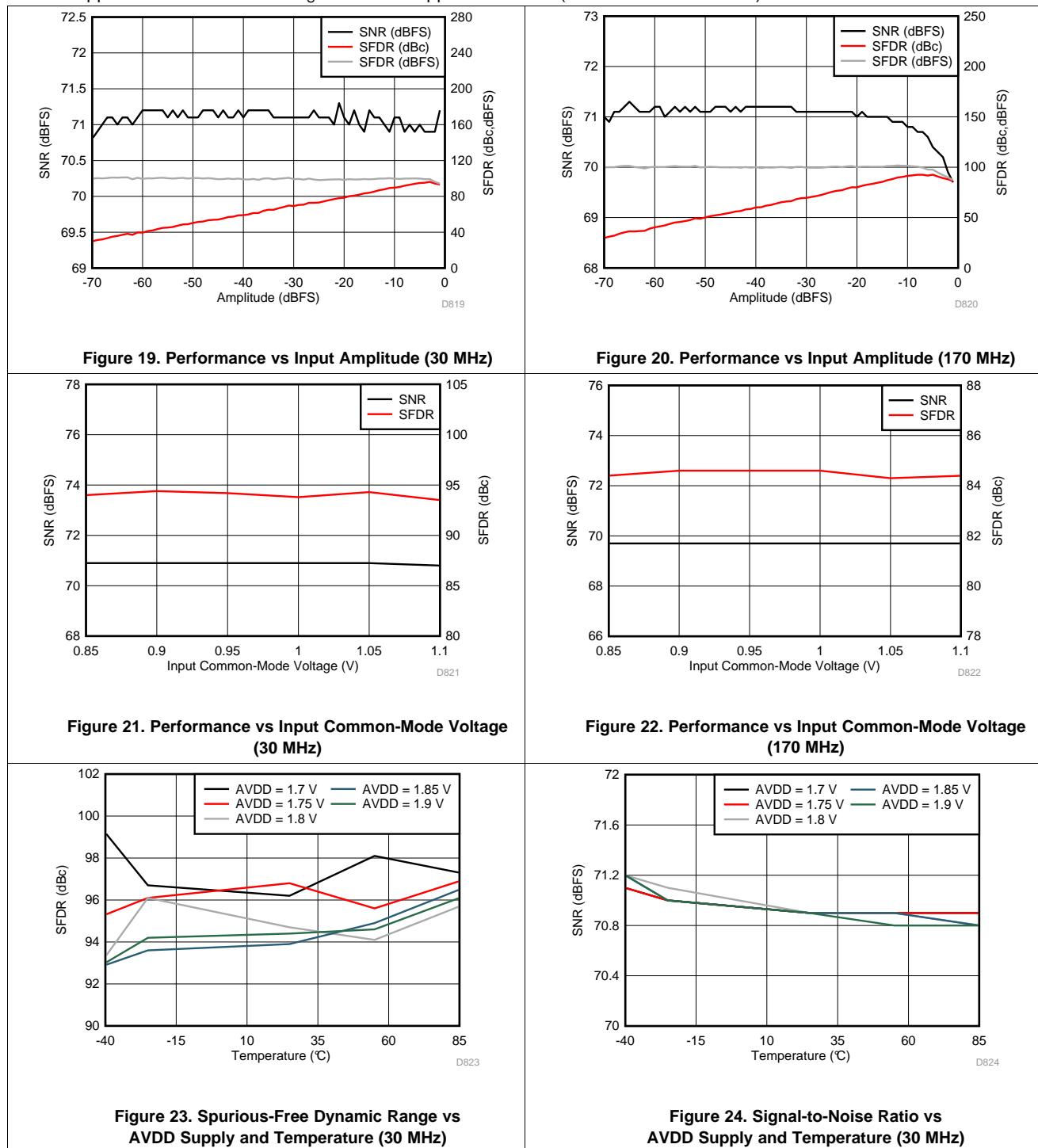
## ADC3221, ADC3222, ADC3223, ADC3224

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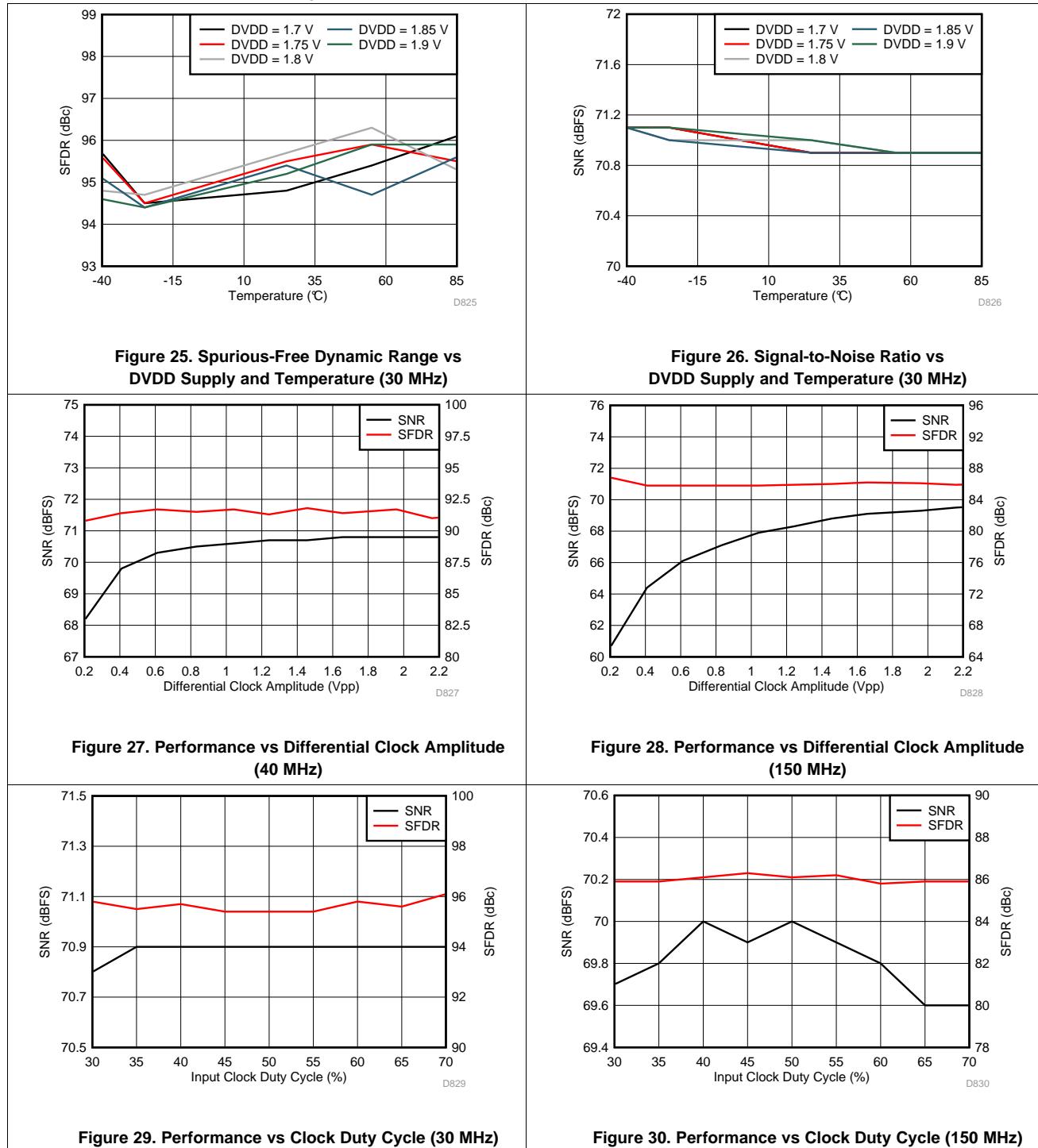
### Typical Characteristics: ADC3221 (continued)

typical values are at  $T_A = 25^\circ\text{C}$ , ADC sampling rate = 25 MSPS, 50% clock duty cycle, AVDD = 1.8 V, DVDD = 1.8 V, -1-dBFS differential input, 2-V<sub>PP</sub> full-scale, 32k-point FFT, chopper disabled, and SNR reported with a 1-MHz offset from dc when chopper is disabled and from  $f_s / 2$  when chopper is enabled (unless otherwise noted)



### Typical Characteristics: ADC3221 (continued)

typical values are at  $T_A = 25^\circ\text{C}$ , ADC sampling rate = 25 MSPS, 50% clock duty cycle, AVDD = 1.8 V, DVDD = 1.8 V, -1-dBFS differential input, 2-V<sub>PP</sub> full-scale, 32k-point FFT, chopper disabled, and SNR reported with a 1-MHz offset from dc when chopper is disabled and from  $f_s / 2$  when chopper is enabled (unless otherwise noted)



## ADC3221, ADC3222, ADC3223, ADC3224

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### 7.16 Typical Characteristics: ADC3222

typical values are at  $T_A = 25^\circ\text{C}$ , ADC sampling rate = 50 MSPS, 50% clock duty cycle, AVDD = 1.8 V, DVDD = 1.8 V, -1-dBFS differential input, 2- $V_{\text{PP}}$  full-scale, 32k-point FFT, chopper disabled, and SNR reported with a 1-MHz offset from dc when chopper is disabled and from  $f_S / 2$  when chopper is enabled (unless otherwise noted)

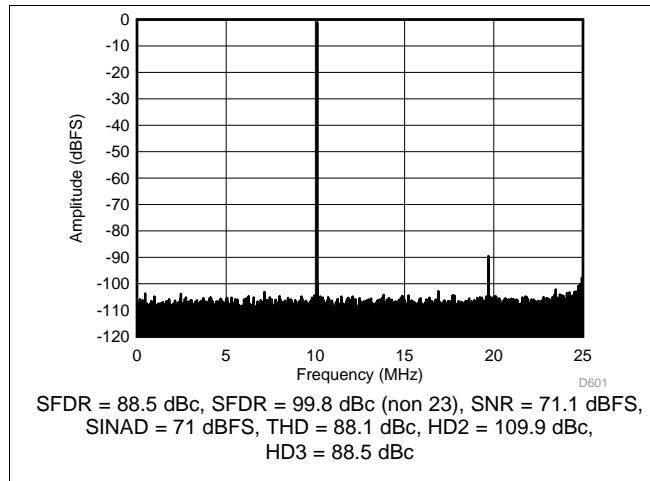


Figure 31. FFT for 10-MHz Input Signal (Dither On)

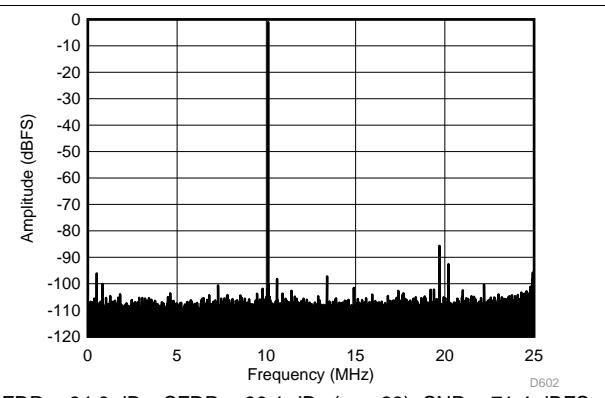


Figure 32. FFT for 10-MHz Input Signal (Dither Off)

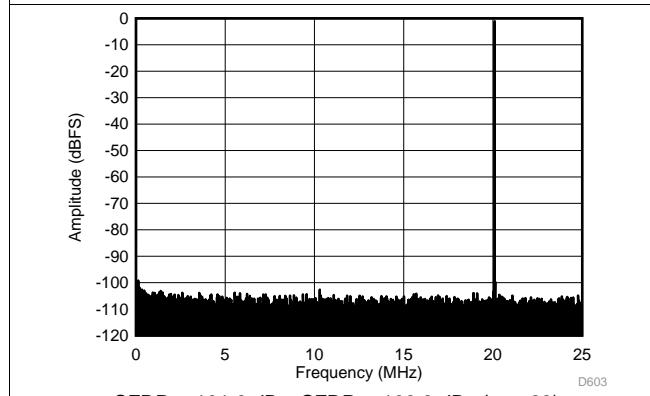


Figure 33. FFT for 70-MHz Input Signal (Dither On)

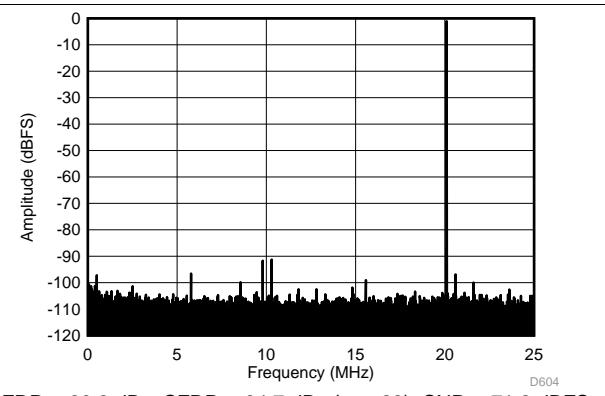


Figure 34. FFT for 70-MHz Input Signal (Dither Off)

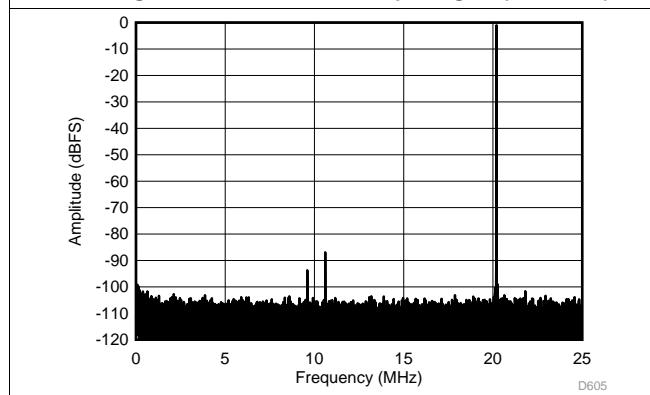


Figure 35. FFT for 170-MHz Input Signal (Dither On)

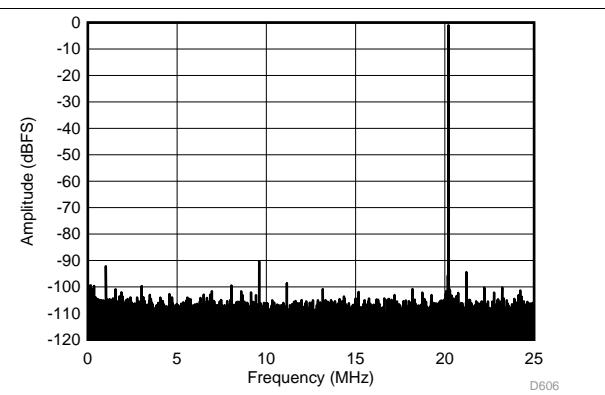
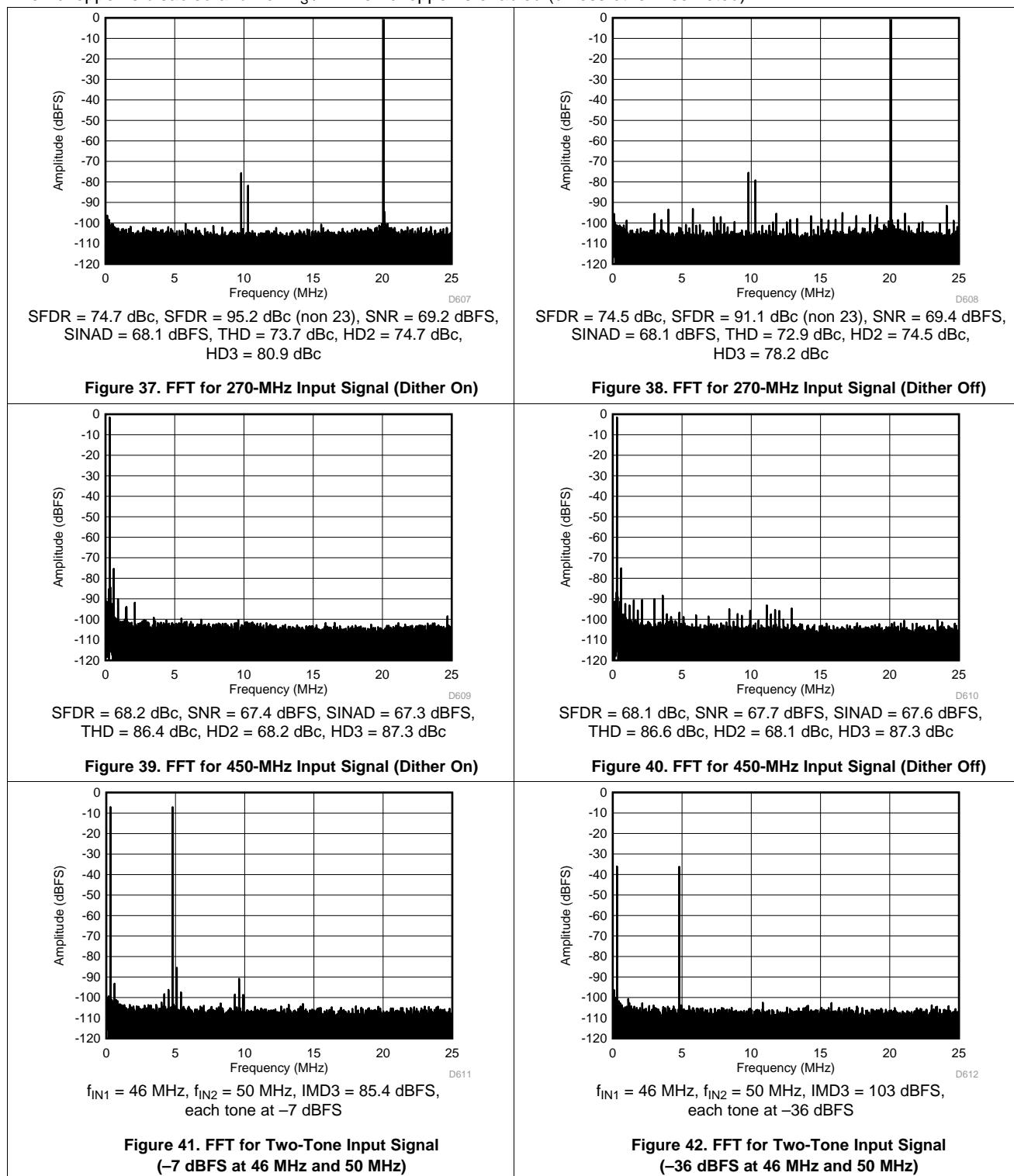


Figure 36. FFT for 170-MHz Input Signal (Dither Off)

### Typical Characteristics: ADC3222 (continued)

typical values are at  $T_A = 25^\circ\text{C}$ , ADC sampling rate = 50 MSPS, 50% clock duty cycle, AVDD = 1.8 V, DVDD = 1.8 V, -1-dBFS differential input, 2-V<sub>PP</sub> full-scale, 32k-point FFT, chopper disabled, and SNR reported with a 1-MHz offset from dc when chopper is disabled and from  $f_S / 2$  when chopper is enabled (unless otherwise noted)



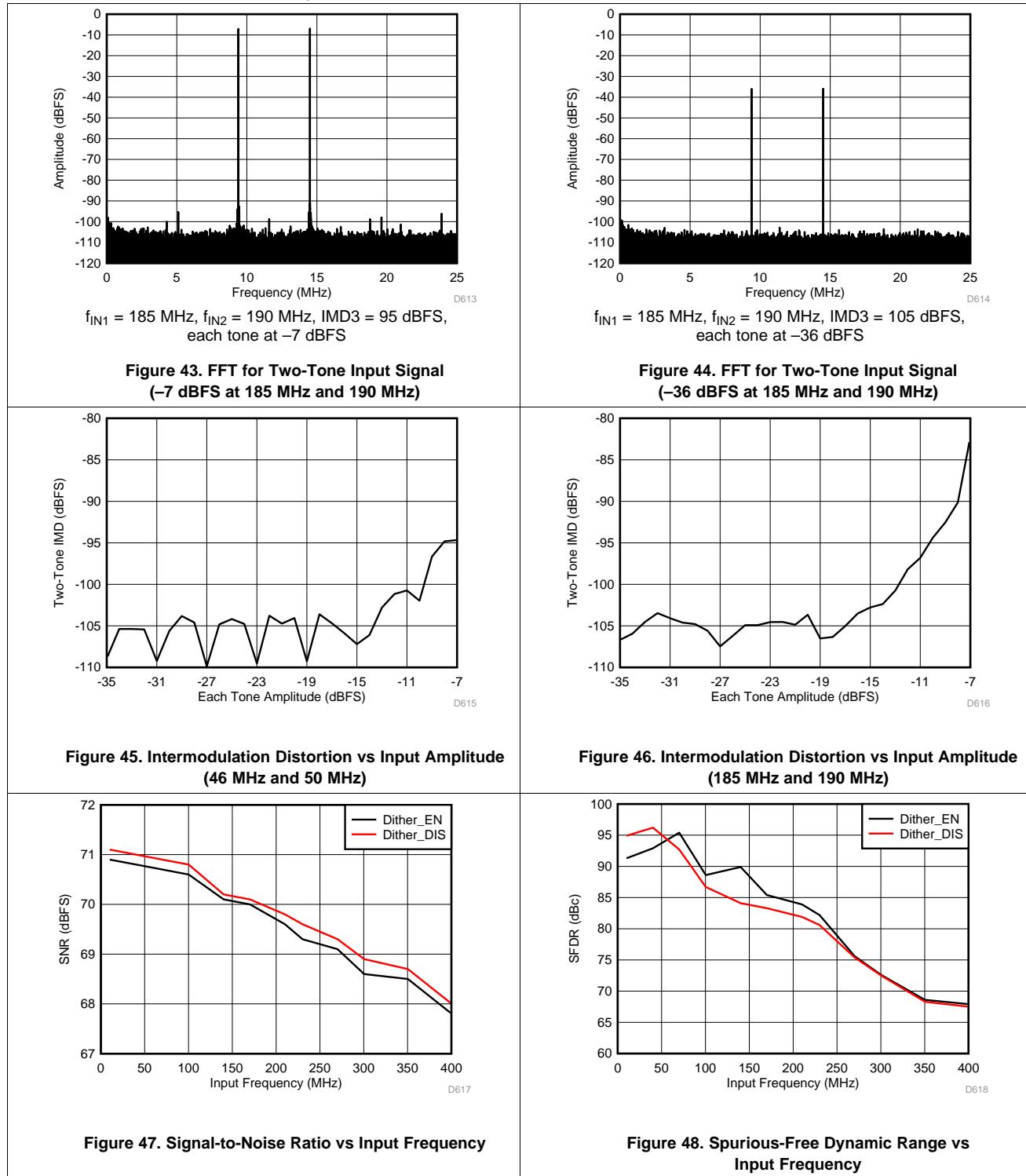
## ADC3221, ADC3222, ADC3223, ADC3224

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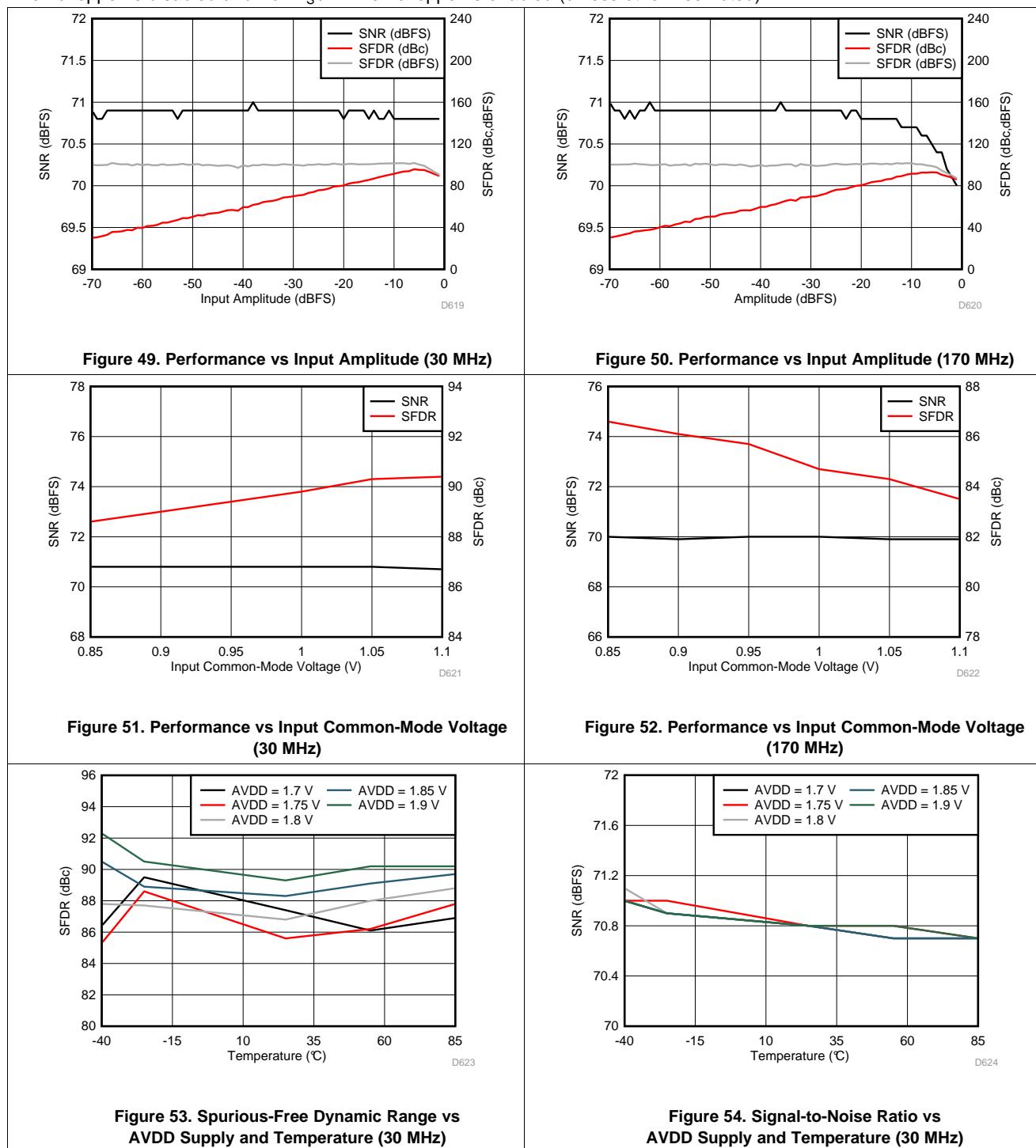
### Typical Characteristics: ADC3222 (continued)

typical values are at  $T_A = 25^\circ\text{C}$ , ADC sampling rate = 50 MSPS, 50% clock duty cycle, AVDD = 1.8 V, DVDD = 1.8 V, -1-dBFS differential input, 2-V<sub>PP</sub> full-scale, 32k-point FFT, chopper disabled, and SNR reported with a 1-MHz offset from dc when chopper is disabled and from  $f_S / 2$  when chopper is enabled (unless otherwise noted)



### Typical Characteristics: ADC3222 (continued)

typical values are at  $T_A = 25^\circ\text{C}$ , ADC sampling rate = 50 MSPS, 50% clock duty cycle, AVDD = 1.8 V, DVDD = 1.8 V, -1-dBFS differential input, 2-V<sub>PP</sub> full-scale, 32k-point FFT, chopper disabled, and SNR reported with a 1-MHz offset from dc when chopper is disabled and from  $f_s / 2$  when chopper is enabled (unless otherwise noted)



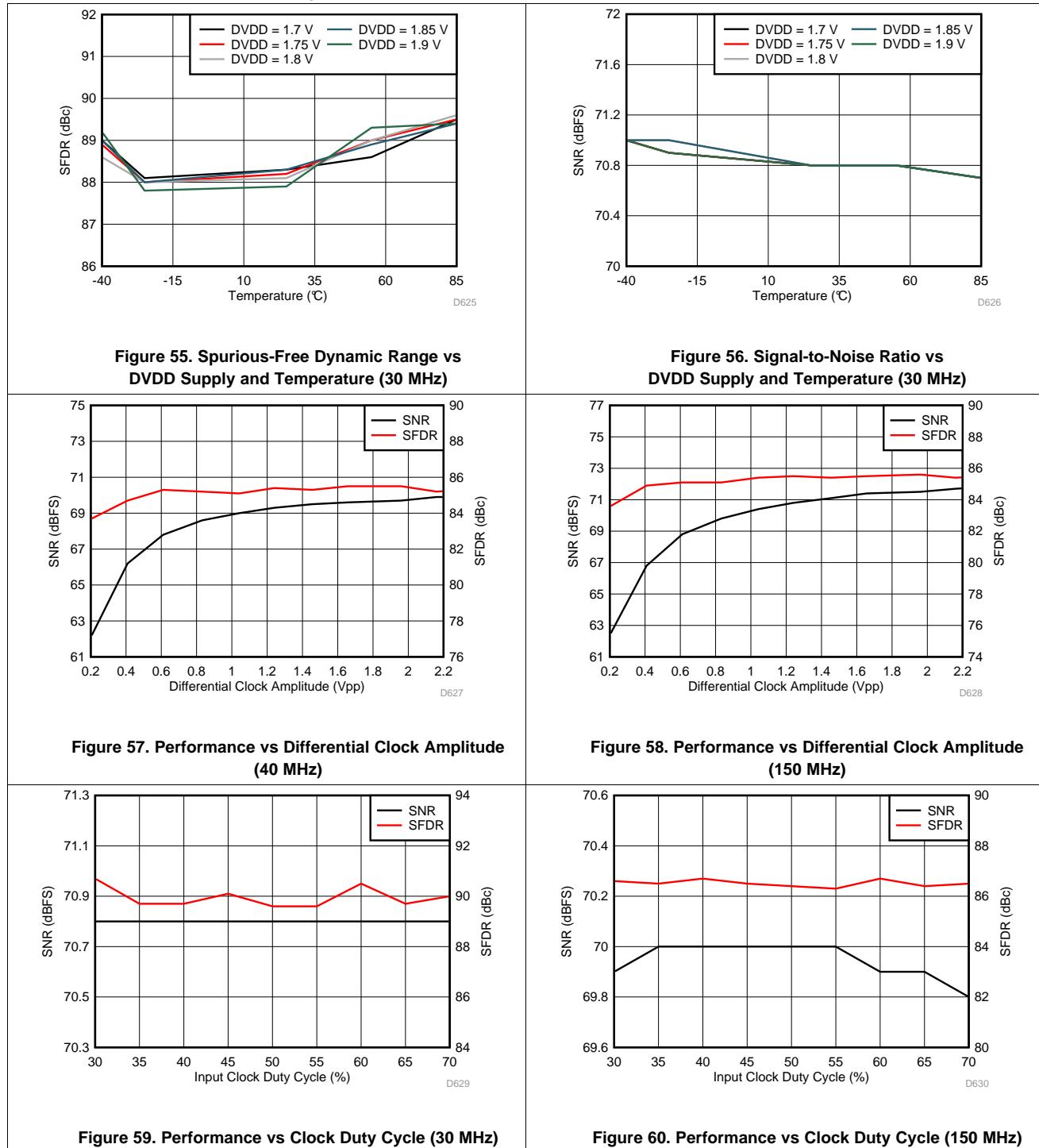
## ADC3221, ADC3222, ADC3223, ADC3224

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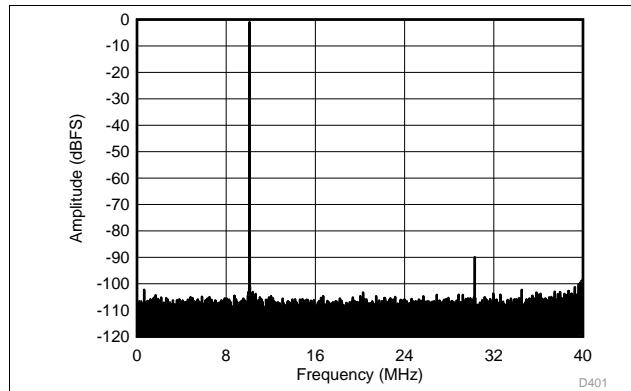
### Typical Characteristics: ADC3222 (continued)

typical values are at  $T_A = 25^\circ\text{C}$ , ADC sampling rate = 50 MSPS, 50% clock duty cycle, AVDD = 1.8 V, DVDD = 1.8 V, -1-dBFS differential input, 2-V<sub>PP</sub> full-scale, 32k-point FFT, chopper disabled, and SNR reported with a 1-MHz offset from dc when chopper is disabled and from  $f_s / 2$  when chopper is enabled (unless otherwise noted)



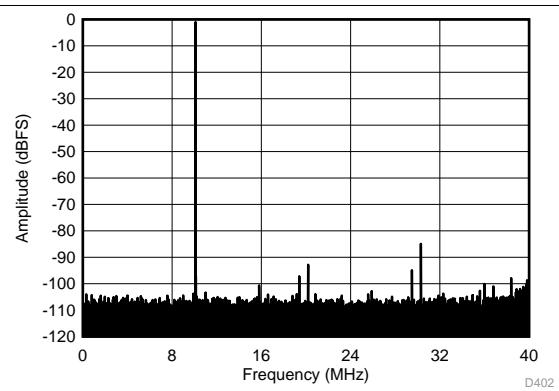
### 7.17 Typical Characteristics: ADC3223

typical values are at  $T_A = 25^\circ\text{C}$ , ADC sampling rate = 80 MSPS, 50% clock duty cycle, AVDD = 1.8 V, DVDD = 1.8 V, -1-dBFS differential input, 2-V<sub>PP</sub> full-scale, 32k-point FFT, chopper disabled, and SNR reported with a 1-MHz offset from dc when chopper is disabled and from  $f_S / 2$  when chopper is enabled (unless otherwise noted)



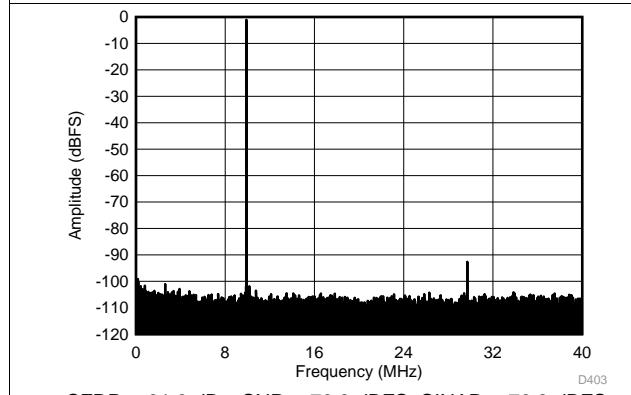
SFDR = 88.9 dBc, SNR = 70.9 dBFS, SINAD = 70.8 dBFS,  
THD = 88.6 dBc, HD2 = 108.1 dBc, HD3 = 88.9 dBc

**Figure 61. FFT for 10-MHz Input Signal (Dither On)**



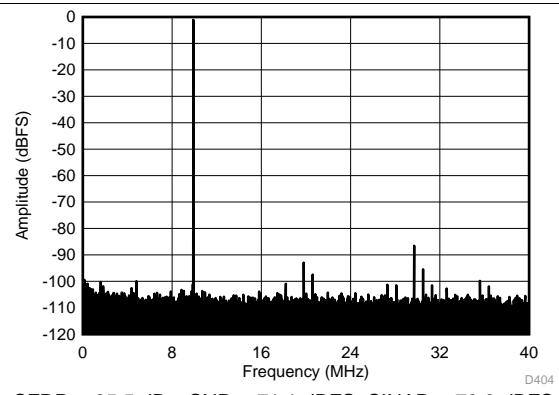
SFDR = 83.9 dBc, SNR = 71.1 dBFS, SINAD = 70.9 dBFS,  
THD = 82.6 dBc, HD2 = 91.8 dBc, HD3 = 83.9 dBc

**Figure 62. FFT for 10-MHz Input Signal (Dither Off)**



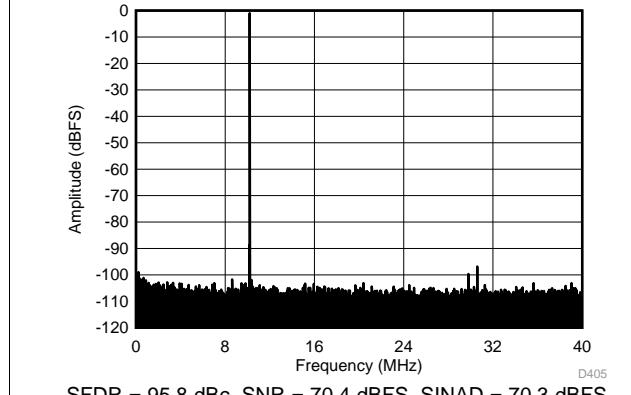
SFDR = 91.6 dBc, SNR = 70.8 dBFS, SINAD = 70.8 dBFS,  
THD = 91 dBc, HD2 = 112.2 dBc, HD3 = 91.6 dBc

**Figure 63. FFT for 70-MHz Input Signal (Dither On)**



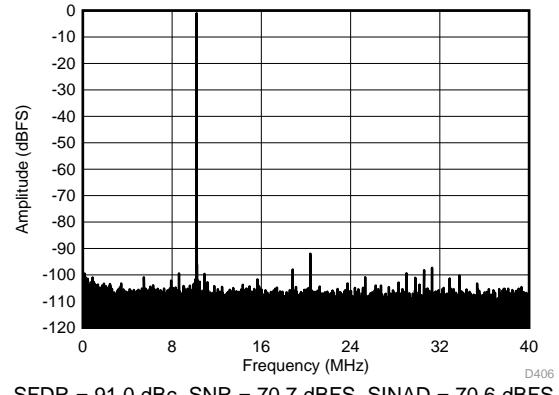
SFDR = 85.5 dBc, SNR = 71.1 dBFS, SINAD = 70.9 dBFS,  
THD = 83.8 dBc, HD2 = 91.9 dBc, HD3 = 85.5 dBc

**Figure 64. FFT for 70-MHz Input Signal (Dither Off)**



SFDR = 95.8 dBc, SNR = 70.4 dBFS, SINAD = 70.3 dBFS,  
THD = 92.9 dBc, HD2 = 102.1 dBc, HD3 = 95.8 dBc

**Figure 65. FFT for 170-MHz Input Signal (Dither On)**



SFDR = 91.0 dBc, SNR = 70.7 dBFS, SINAD = 70.6 dBFS,  
THD = 88 dBc, HD2 = 91.0 dBc, HD3 = 97.2 dBc

**Figure 66. FFT for 170-MHz Input Signal (Dither Off)**

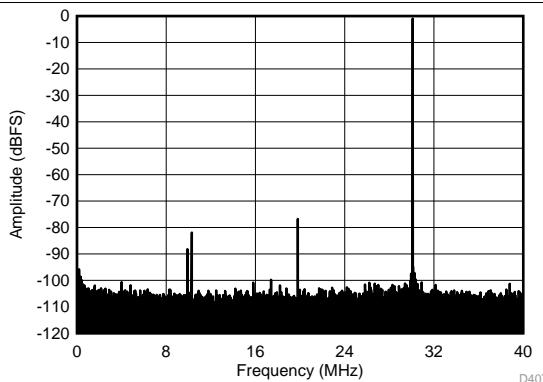
## ADC3221, ADC3222, ADC3223, ADC3224

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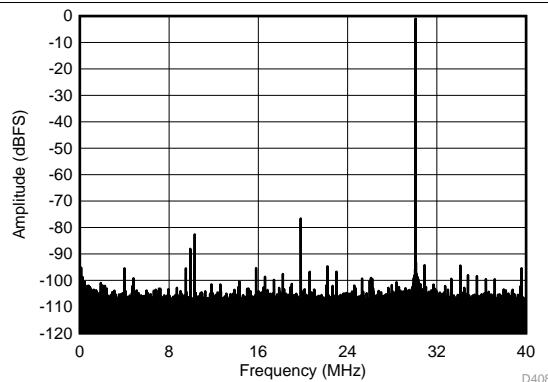
### Typical Characteristics: ADC3223 (continued)

typical values are at  $T_A = 25^\circ\text{C}$ , ADC sampling rate = 80 MSPS, 50% clock duty cycle, AVDD = 1.8 V, DVDD = 1.8 V, -1-dBFS differential input, 2-V<sub>PP</sub> full-scale, 32k-point FFT, chopper disabled, and SNR reported with a 1-MHz offset from dc when chopper is disabled and from  $f_S / 2$  when chopper is enabled (unless otherwise noted)



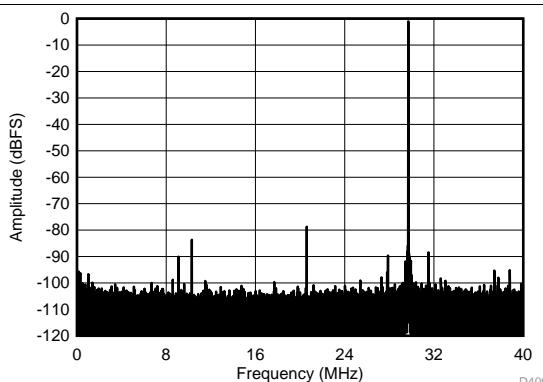
SFDR = 75.8 dBc, SNR = 69.4 dBFS, SINAD = 68.5 dBFS, THD = 74.6 dBc, HD2 = 75.8 dBc, HD3 = 80.9 dBc

Figure 67. FFT for 270-MHz Input Signal (Dither On)



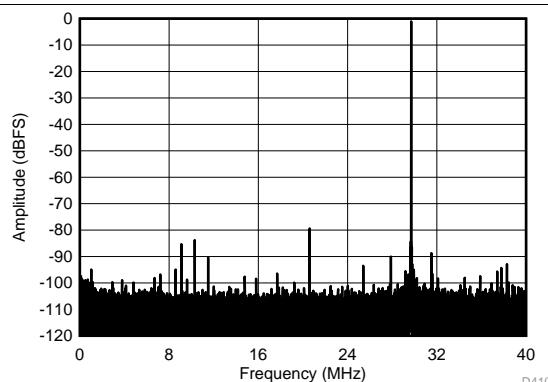
SFDR = 75.6 dBc, SNR = 69.7 dBFS, SINAD = 68.6 dBFS, THD = 74.5 dBc, HD2 = 75.6 dBc, HD3 = 81.6 dBc

Figure 68. FFT for 270-MHz Input Signal (Dither Off)



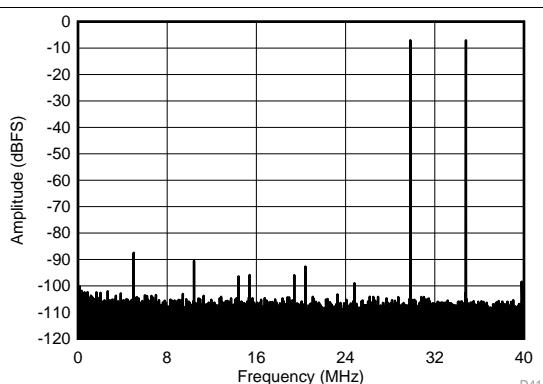
SFDR = 77.7 dBc, SNR = 67.7 dBFS, SINAD = 67.3 dBFS, THD = 77.2 dBc, HD2 = 77.7 dBc, HD3 = 89.0 dBc

Figure 69. FFT for 450-MHz Input Signal (Dither On)



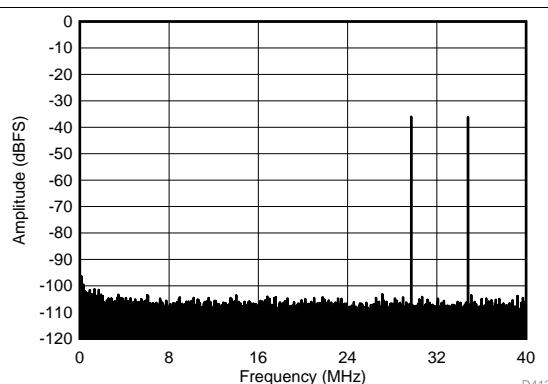
SFDR = 78.4 dBc, SNR = 67.9 dBFS, SINAD = 67.5 dBFS, THD = 77 dBc, HD2 = 78.4 dBc, HD3 = 84.3 dBc

Figure 70. FFT for 450-MHz Input Signal (Dither Off)



$f_{IN1} = 46$  MHz,  $f_{IN2} = 50$  MHz, IMD3 = 87.5 dBFS, each tone at -7 dBFS

Figure 71. FFT for Two-Tone Input Signal  
(-7 dBFS at 46 MHz and 50 MHz)

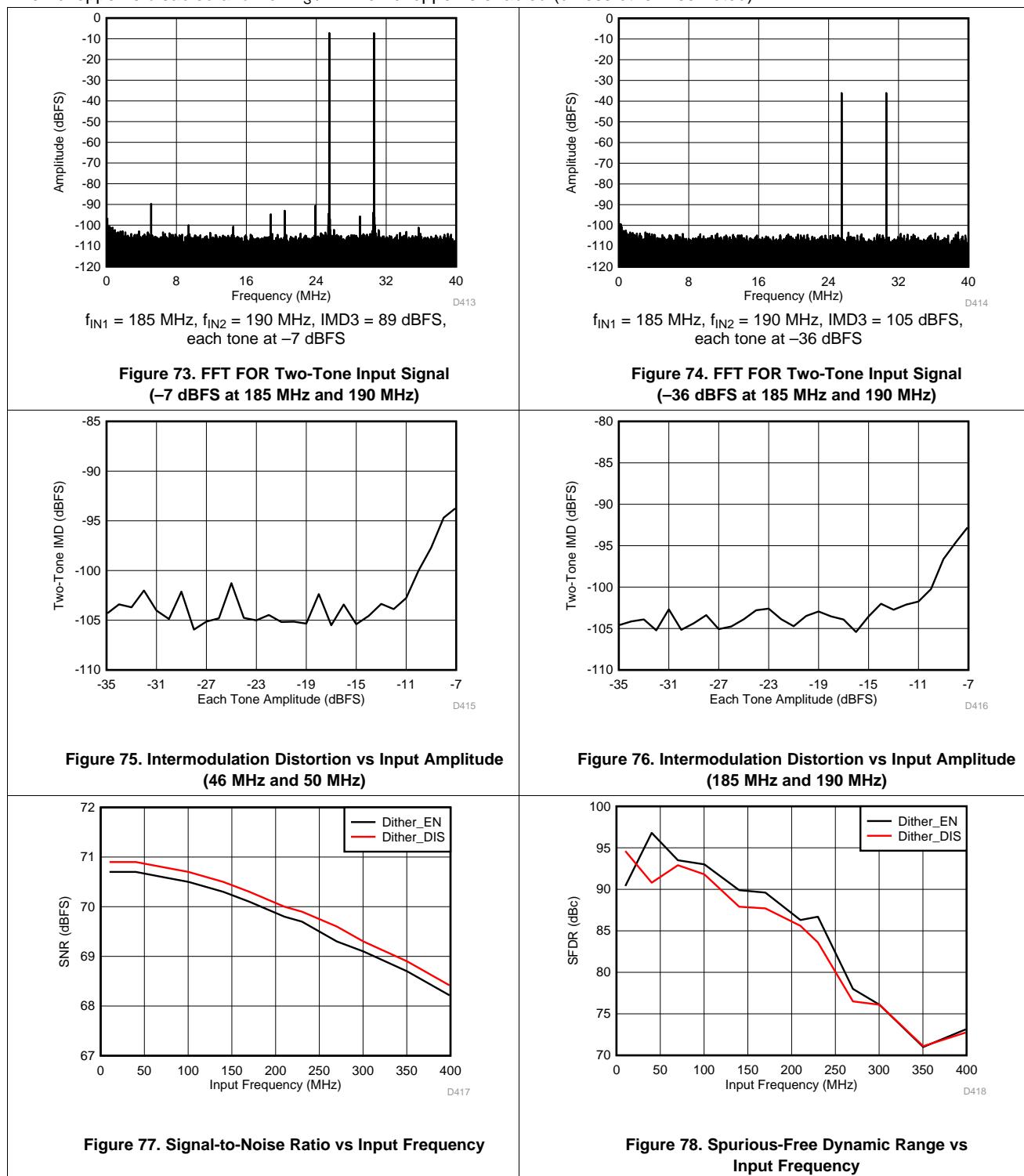


$f_{IN1} = 46$  MHz,  $f_{IN2} = 50$  MHz, IMD3 = 105 dBFS, each tone at -36 dBFS

Figure 72. FFT for Two-Tone Input Signal  
(-36 dBFS at 46 MHz and 50 MHz)

### Typical Characteristics: ADC3223 (continued)

typical values are at  $T_A = 25^\circ\text{C}$ , ADC sampling rate = 80 MSPS, 50% clock duty cycle, AVDD = 1.8 V, DVDD = 1.8 V, -1-dBFS differential input, 2-V<sub>PP</sub> full-scale, 32k-point FFT, chopper disabled, and SNR reported with a 1-MHz offset from dc when chopper is disabled and from  $f_S / 2$  when chopper is enabled (unless otherwise noted)



## ADC3221, ADC3222, ADC3223, ADC3224

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### Typical Characteristics: ADC3223 (continued)

typical values are at  $T_A = 25^\circ\text{C}$ , ADC sampling rate = 80 MSPS, 50% clock duty cycle, AVDD = 1.8 V, DVDD = 1.8 V, -1-dBFS differential input, 2-V<sub>PP</sub> full-scale, 32k-point FFT, chopper disabled, and SNR reported with a 1-MHz offset from dc when chopper is disabled and from  $f_s / 2$  when chopper is enabled (unless otherwise noted)

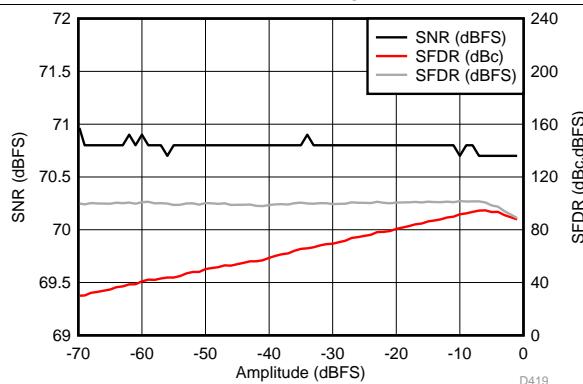


Figure 79. Performance vs Input Amplitude (30 MHz)

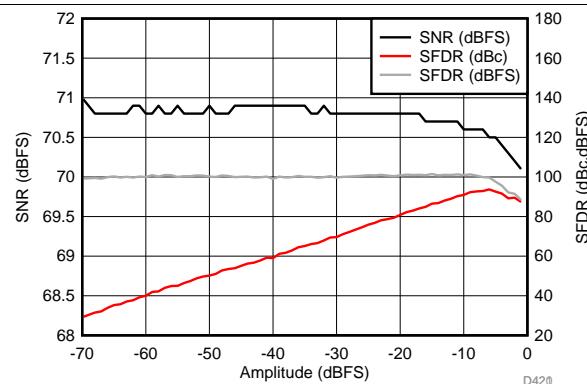


Figure 80. Performance vs Input Amplitude (170 MHz)

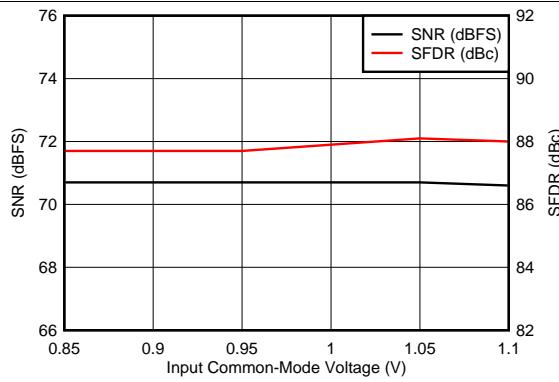


Figure 81. Performance vs Input Common-Mode Voltage (30 MHz)

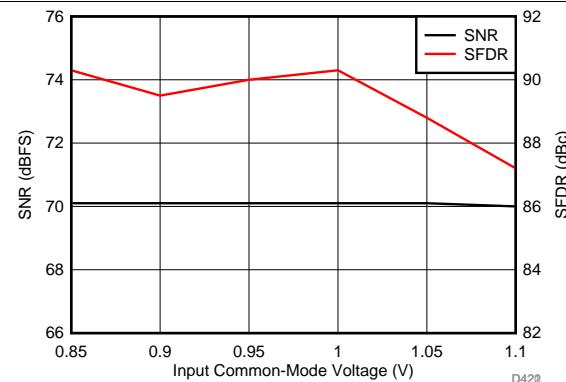


Figure 82. Performance vs Input Common-Mode Voltage (170 MHz)

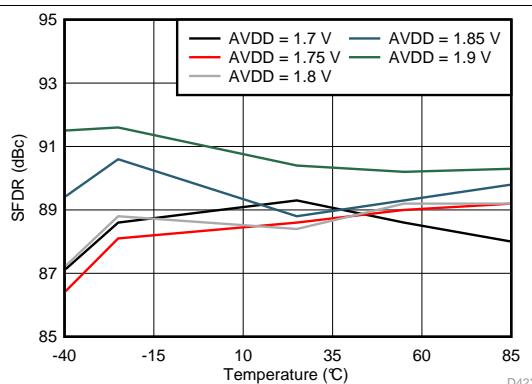


Figure 83. Spurious-Free Dynamic Range vs AVDD Supply and Temperature (170 MHz)

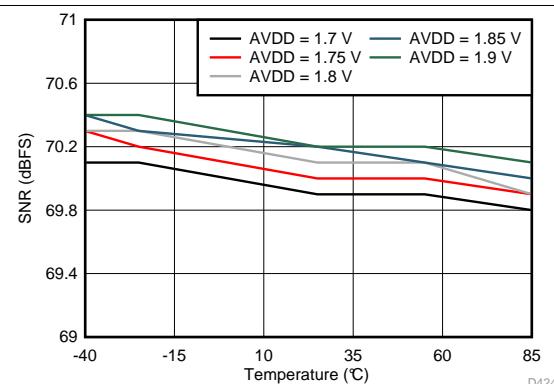
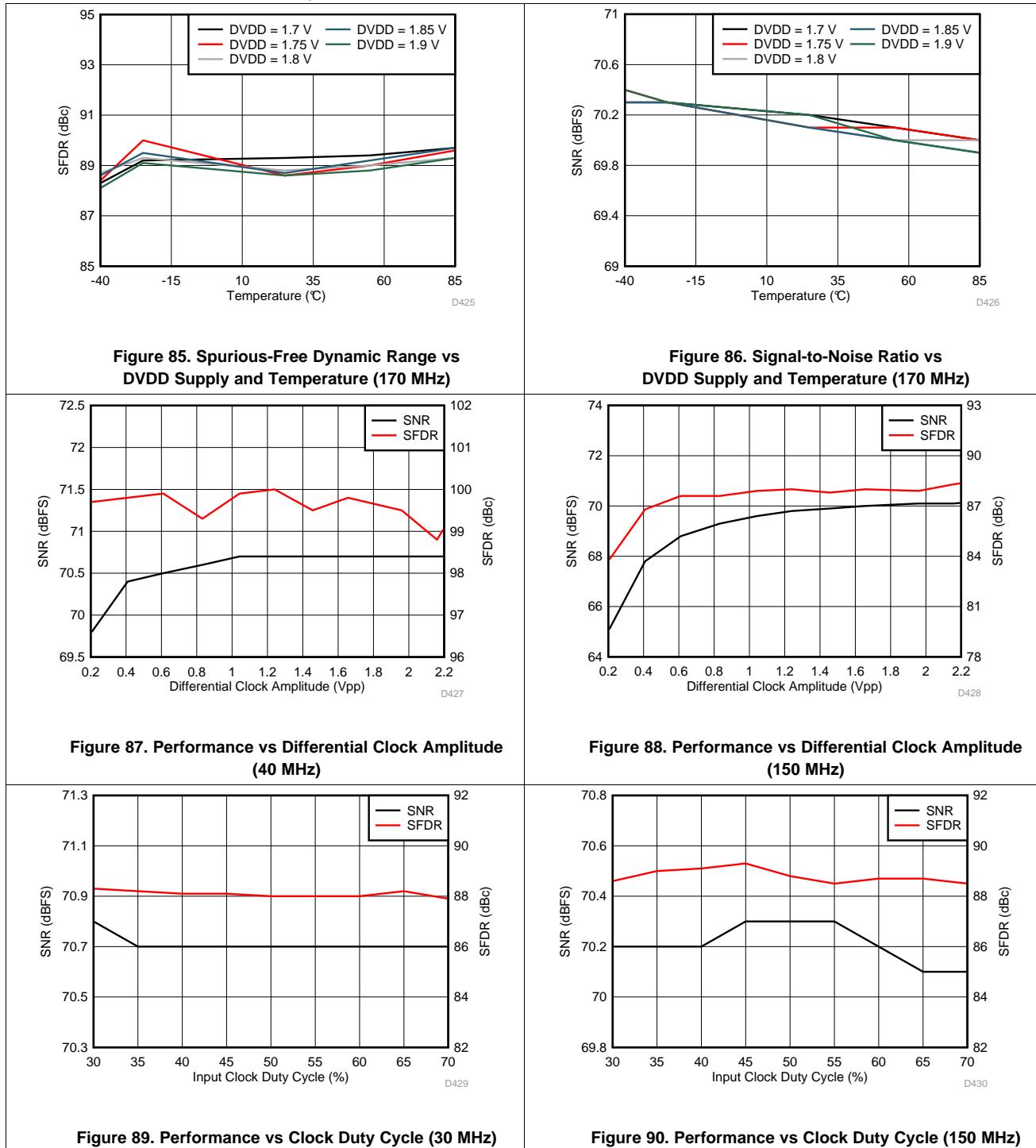


Figure 84. Signal-to-Noise Ratio vs AVDD Supply and Temperature (170 MHz)

### Typical Characteristics: ADC3223 (continued)

typical values are at  $T_A = 25^\circ\text{C}$ , ADC sampling rate = 80 MSPS, 50% clock duty cycle, AVDD = 1.8 V, DVDD = 1.8 V, -1-dBFS differential input, 2-V<sub>PP</sub> full-scale, 32k-point FFT, chopper disabled, and SNR reported with a 1-MHz offset from dc when chopper is disabled and from  $f_s / 2$  when chopper is enabled (unless otherwise noted)



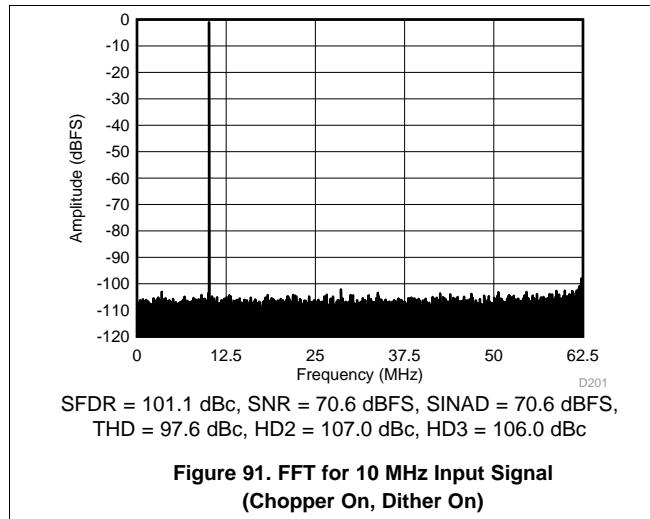
## ADC3221, ADC3222, ADC3223, ADC3224

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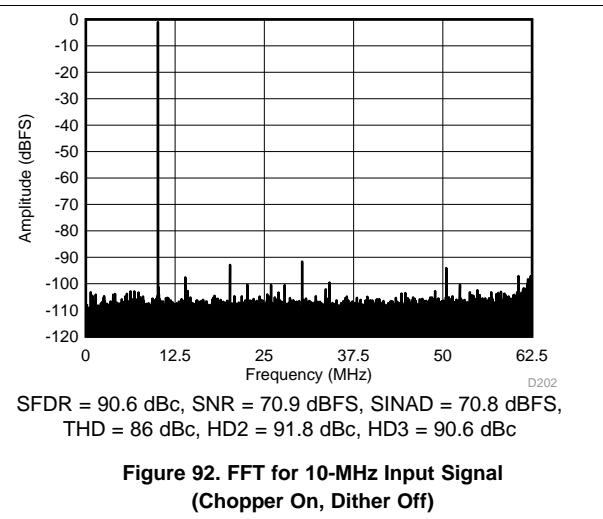
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### 7.18 Typical Characteristics: ADC3224

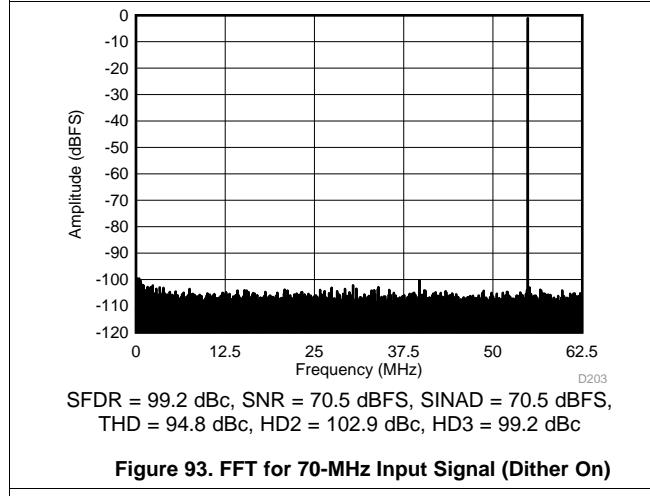
typical values are at  $T_A = 25^\circ\text{C}$ , ADC sampling rate = 125 MSPS, 50% clock duty cycle, AVDD = 1.8 V, DVDD = 1.8 V, –1-dBFS differential input, 2- $V_{\text{PP}}$  full-scale, 32k-point FFT, chopper disabled, and SNR reported with a 1-MHz offset from dc when chopper is disabled and from  $f_s / 2$  when chopper is enabled (unless otherwise noted)



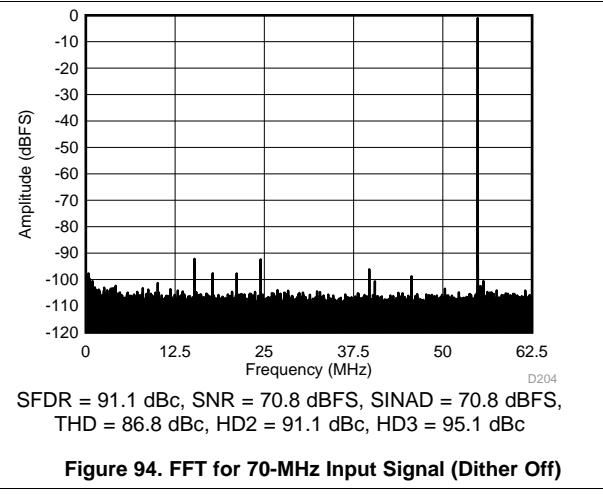
**Figure 91. FFT for 10 MHz Input Signal  
(Chopper On, Dither On)**



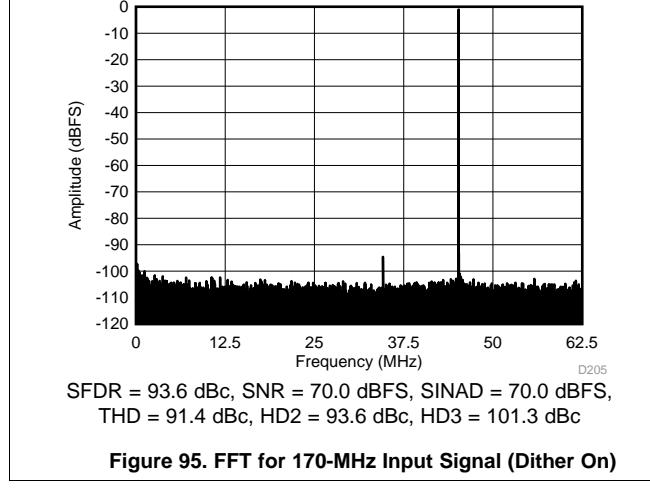
**Figure 92. FFT for 10-MHz Input Signal  
(Chopper On, Dither Off)**



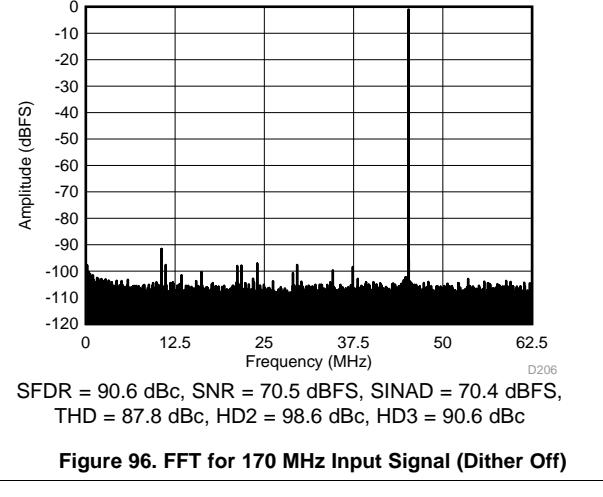
**Figure 93. FFT for 70-MHz Input Signal (Dither On)**



**Figure 94. FFT for 70-MHz Input Signal (Dither Off)**



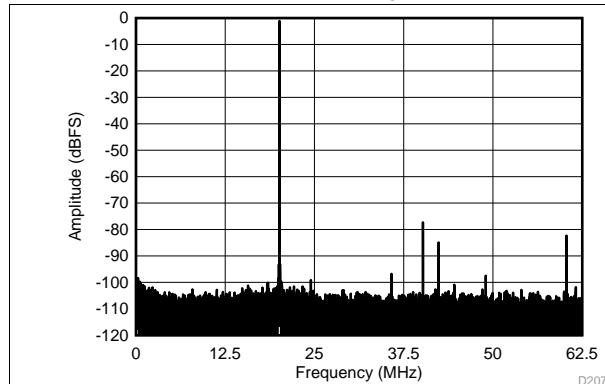
**Figure 95. FFT for 170-MHz Input Signal (Dither On)**



**Figure 96. FFT for 170 MHz Input Signal (Dither Off)**

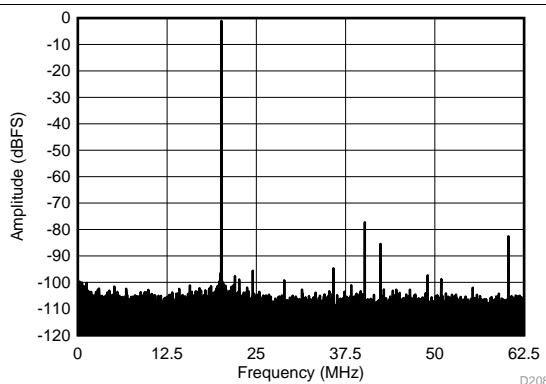
### Typical Characteristics: ADC3224 (continued)

typical values are at  $T_A = 25^\circ\text{C}$ , ADC sampling rate = 125 MSPS, 50% clock duty cycle, AVDD = 1.8 V, DVDD = 1.8 V, –1-dBFS differential input, 2-V<sub>PP</sub> full-scale, 32k-point FFT, chopper disabled, and SNR reported with a 1-MHz offset from dc when chopper is disabled and from  $f_S / 2$  when chopper is enabled (unless otherwise noted)



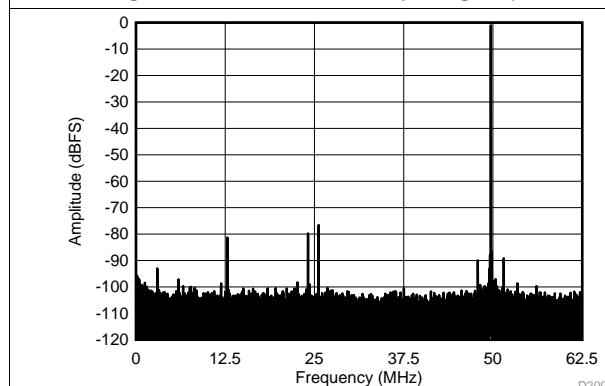
SFDR = 76.2 dBc, SNR = 69.4 dBFS, SINAD = 68.6 dBFS,  
THD = 74.9 dBc, HD2 = 76.2 dBc, HD3 = 81.2 dBc

**Figure 97. FFT for 270-MHz Input Signal (Dither On)**



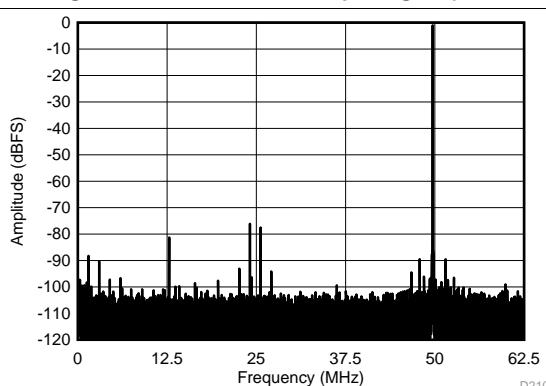
SFDR = 76.1 dBc, SNR = 69.7 dBFS, SINAD = 68.8 dBFS,  
THD = 74.9 dBc, HD2 = 76.1 dBc, HD3 = 81.5 dBc

**Figure 98. FFT for 270-MHz Input Signal (Dither Off)**



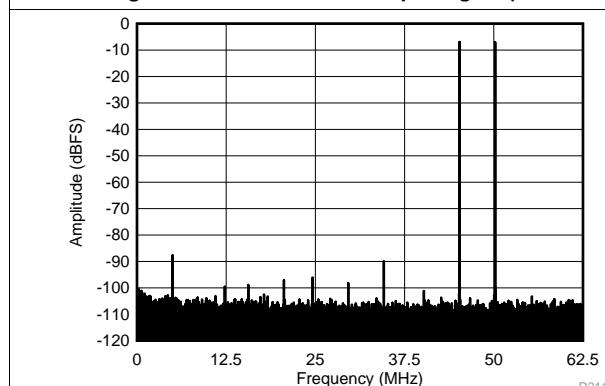
SFDR = 75.5 dBc, SNR = 67.4 dBFS, SINAD = 66.7 dBFS,  
THD = 73.8 dBc, HD2 = 75.5 dBc, HD3 = 78.7 dBc

**Figure 99. FFT for 450-MHz Input Signal (Dither On)**



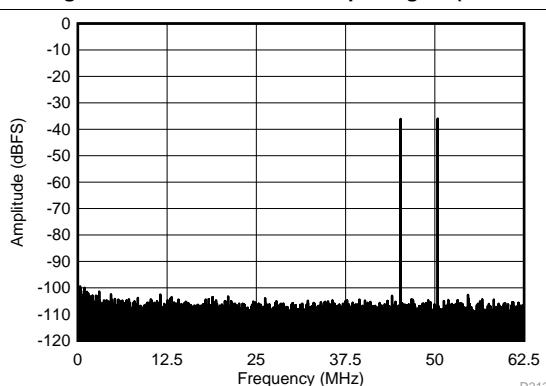
SFDR = 75.2 dBc, SNR = 68 dBFS, SINAD = 67.0 dBFS,  
THD = 72.5 dBc, HD2 = 76.5 dBc, HD3 = 75.2 dBc

**Figure 100. FFT for 450-MHz Input Signal (Dither Off)**



$f_{IN1} = 46$  MHz,  $f_{IN2} = 50$  MHz, IMD3 = 88 dBFS,  
each tone at –7 dBFS

**Figure 101. FFT for Two-Tone Input Signal  
(–7 dBFS at 46 MHz and 50 MHz)**



$f_{IN1} = 46$  MHz,  $f_{IN2} = 50$  MHz, IMD3 = 105 dBFS,  
each tone at –36 dBFS

**Figure 102. FFT for Two-Tone Input Signal  
(–36 dBFS at 46 MHz and 50 MHz)**

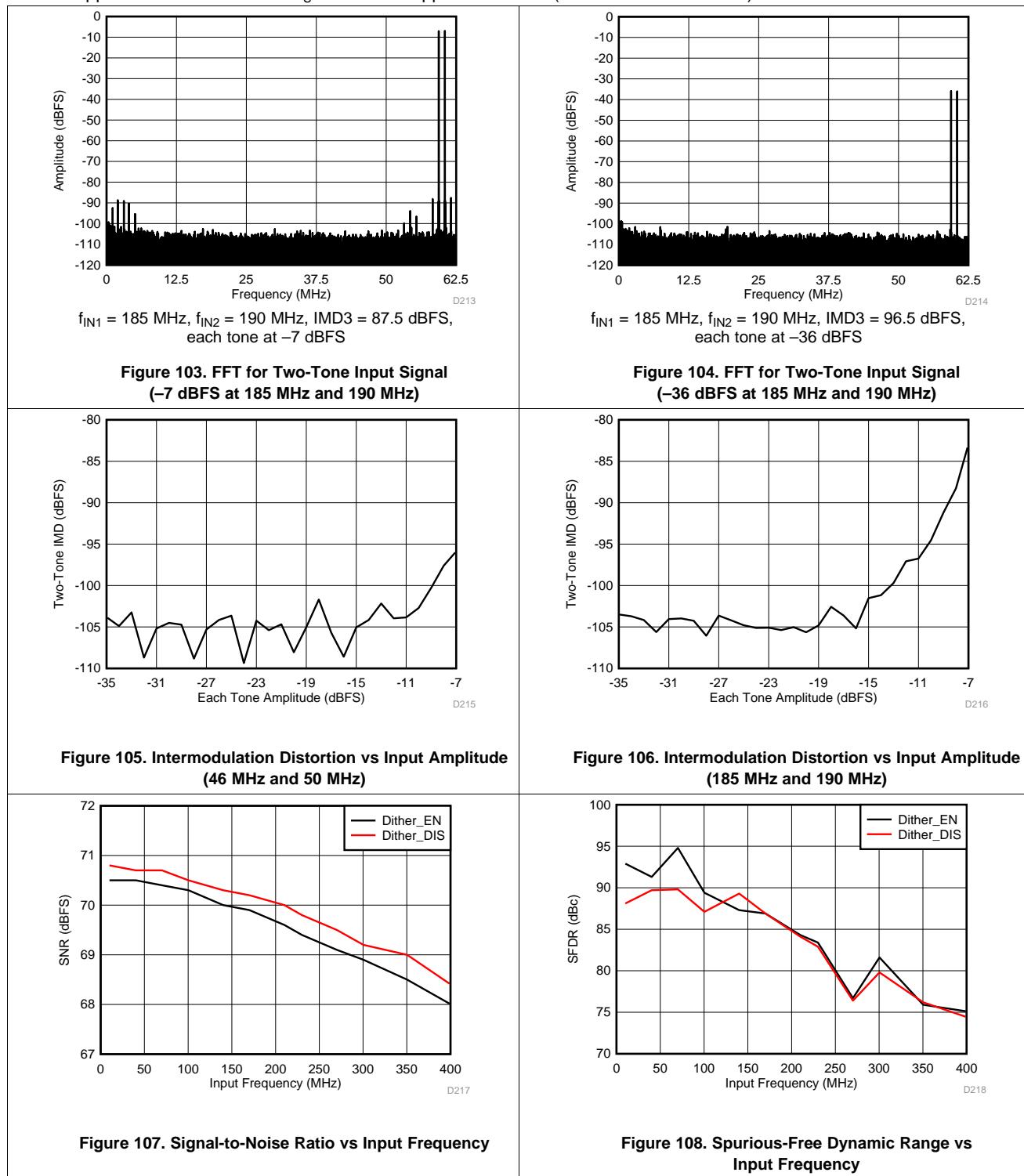
## ADC3221, ADC3222, ADC3223, ADC3224

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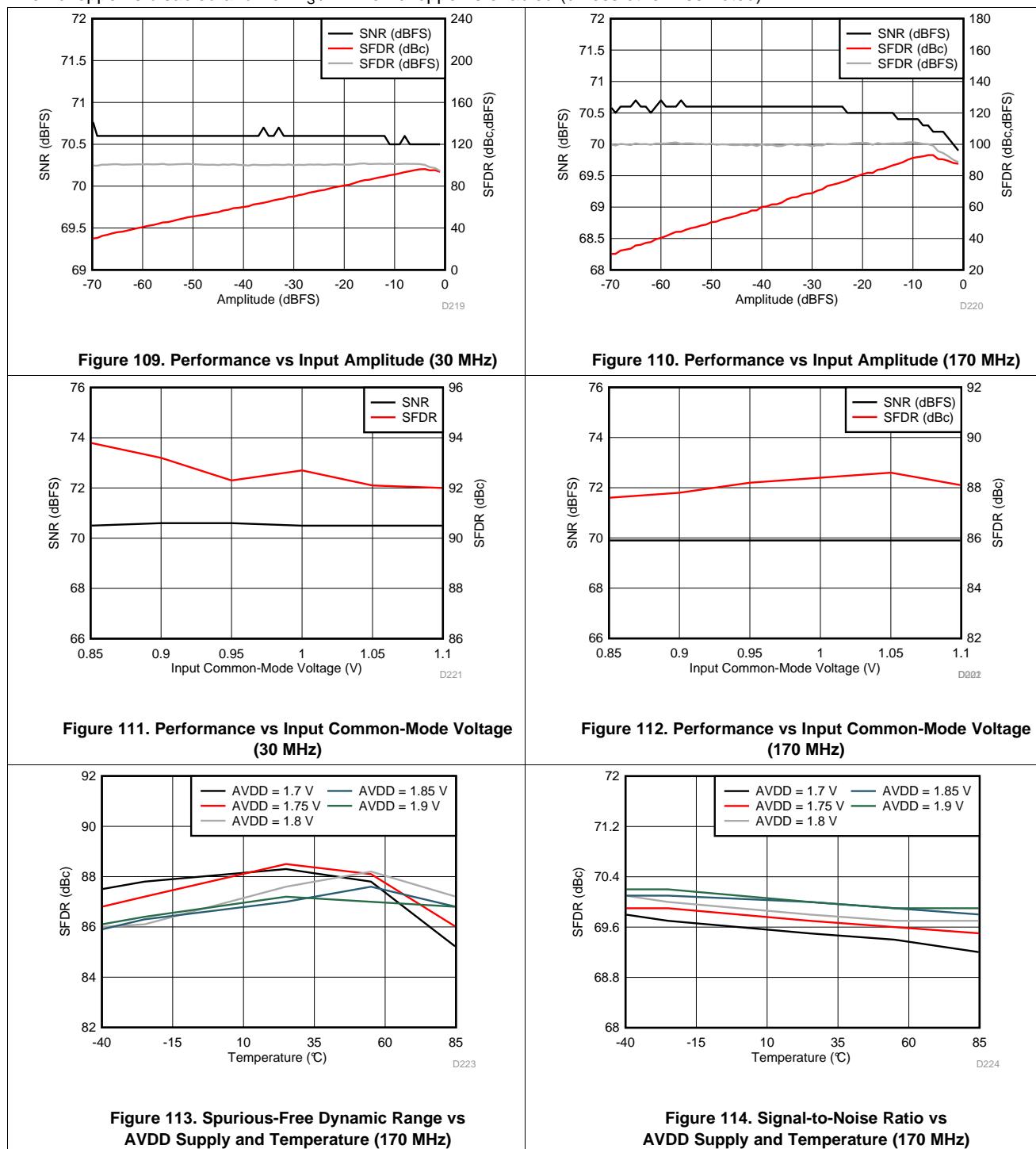
### Typical Characteristics: ADC3224 (continued)

typical values are at  $T_A = 25^\circ\text{C}$ , ADC sampling rate = 125 MSPS, 50% clock duty cycle, AVDD = 1.8 V, DVDD = 1.8 V, –1-dBFS differential input, 2-V<sub>PP</sub> full-scale, 32k-point FFT, chopper disabled, and SNR reported with a 1-MHz offset from dc when chopper is disabled and from  $f_S / 2$  when chopper is enabled (unless otherwise noted)



### Typical Characteristics: ADC3224 (continued)

typical values are at  $T_A = 25^\circ\text{C}$ , ADC sampling rate = 125 MSPS, 50% clock duty cycle, AVDD = 1.8 V, DVDD = 1.8 V, –1-dBFS differential input, 2-V<sub>PP</sub> full-scale, 32k-point FFT, chopper disabled, and SNR reported with a 1-MHz offset from dc when chopper is disabled and from  $f_s / 2$  when chopper is enabled (unless otherwise noted)



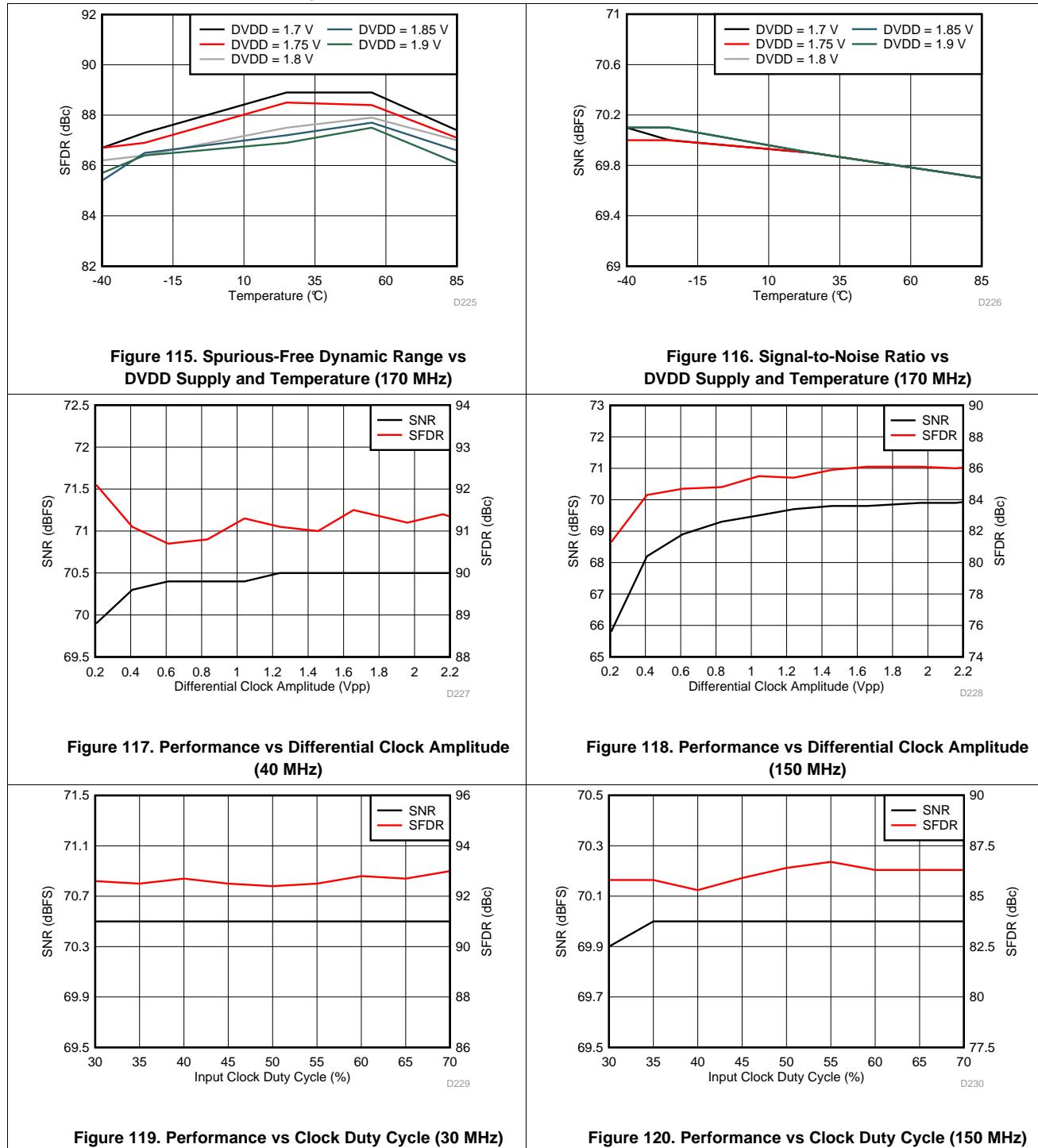
## ADC3221, ADC3222, ADC3223, ADC3224

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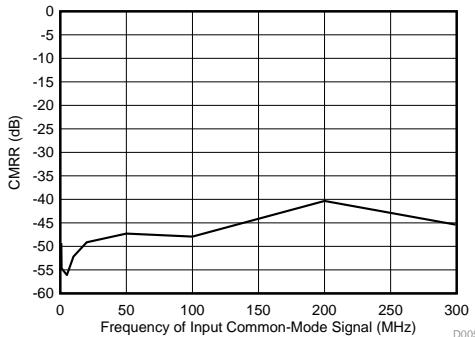
### Typical Characteristics: ADC3224 (continued)

typical values are at  $T_A = 25^\circ\text{C}$ , ADC sampling rate = 125 MSPS, 50% clock duty cycle, AVDD = 1.8 V, DVDD = 1.8 V, –1-dBFS differential input, 2-V<sub>PP</sub> full-scale, 32k-point FFT, chopper disabled, and SNR reported with a 1-MHz offset from dc when chopper is disabled and from  $f_s / 2$  when chopper is enabled (unless otherwise noted)

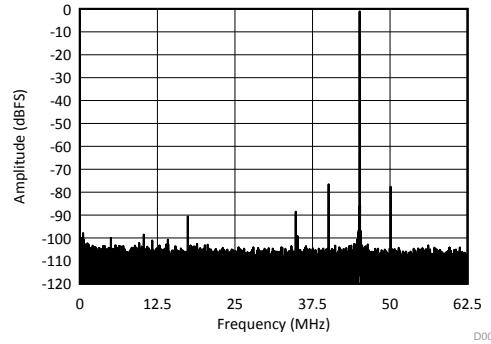


### 7.19 Typical Characteristics: Common

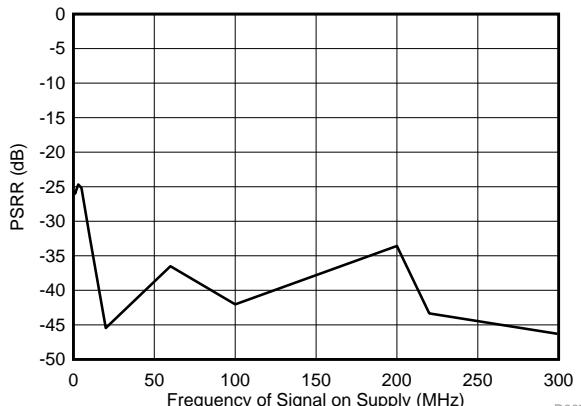
typical values are at  $T_A = 25^\circ\text{C}$ , ADC sampling rate = 125 MSPS, 50% clock duty cycle, AVDD = 1.8 V, DVDD = 1.8 V,  $-1\text{-dBFS}$  differential input, 2- $\text{V}_{\text{PP}}$  full-scale, 32k-point FFT, chopper disabled, and SNR reported with a 1-MHz offset from dc when chopper is disabled and from  $f_S / 2$  when chopper is enabled (unless otherwise noted)



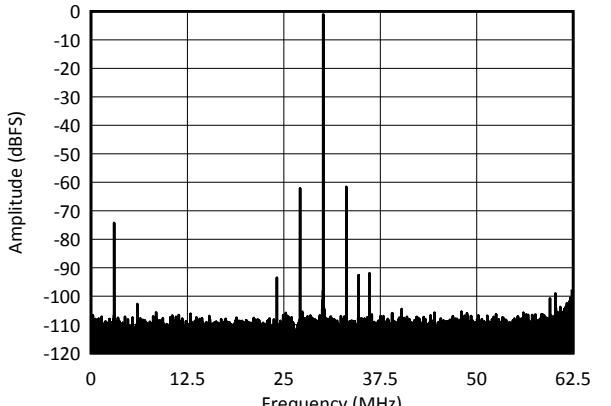
**Figure 121. Common-Mode Rejection Ratio vs Common-Mode Signal Frequency**



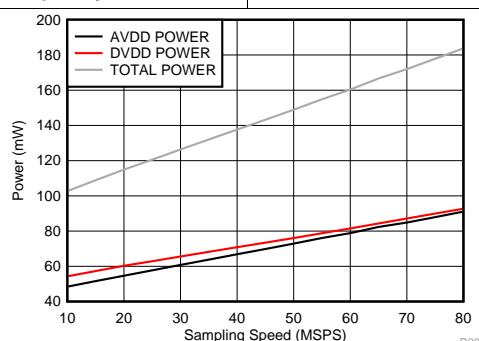
**Figure 122. Common-Mode Rejection Ratio Spectrum**



**Figure 123. Power-Supply Rejection Ratio vs Power-Supply Signal Frequency**



**Figure 124. Power-Supply Rejection Ratio Spectrum**



**Figure 125. Power vs Sampling Speed (One-Wire Mode)**

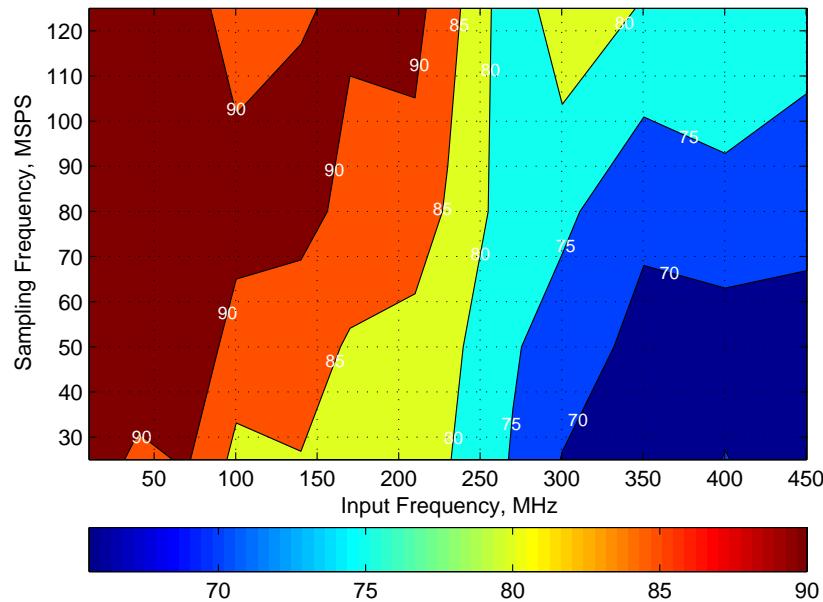
## ADC3221, ADC3222, ADC3223, ADC3224

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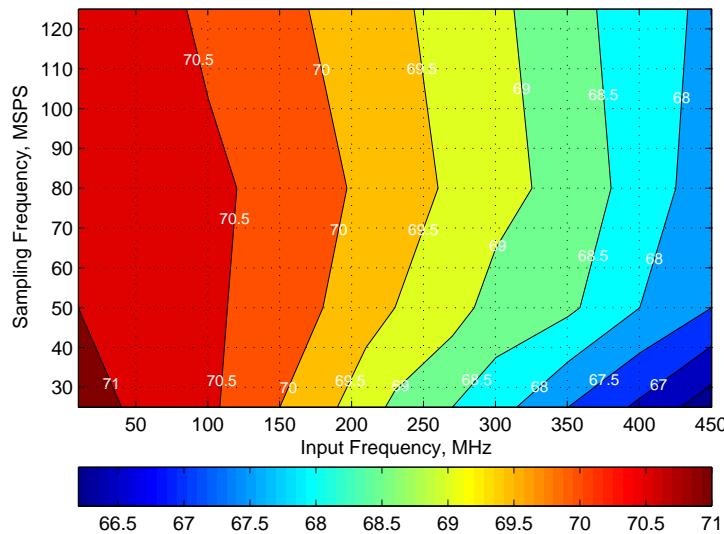
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### 7.20 Typical Characteristics: Contour

typical values are at  $T_A = 25^\circ\text{C}$ , ADC sampling rate = 125 MSPS, 50% clock duty cycle, AVDD = 1.8 V, DVDD = 1.8 V, –1-dBFS differential input, 2- $V_{\text{PP}}$  full-scale, 32k-point FFT, chopper disabled, and SNR reported with a 1-MHz offset from dc when chopper is disabled and from  $f_S / 2$  when is chopper enabled (unless otherwise noted)



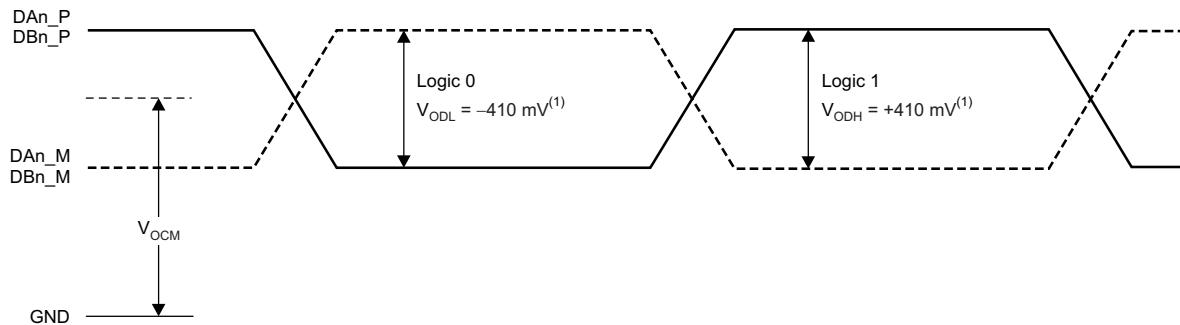
**Figure 126. Spurious-Free Dynamic Range (SFDR)**



**Figure 127. Signal-to-Noise Ratio (SNR)**

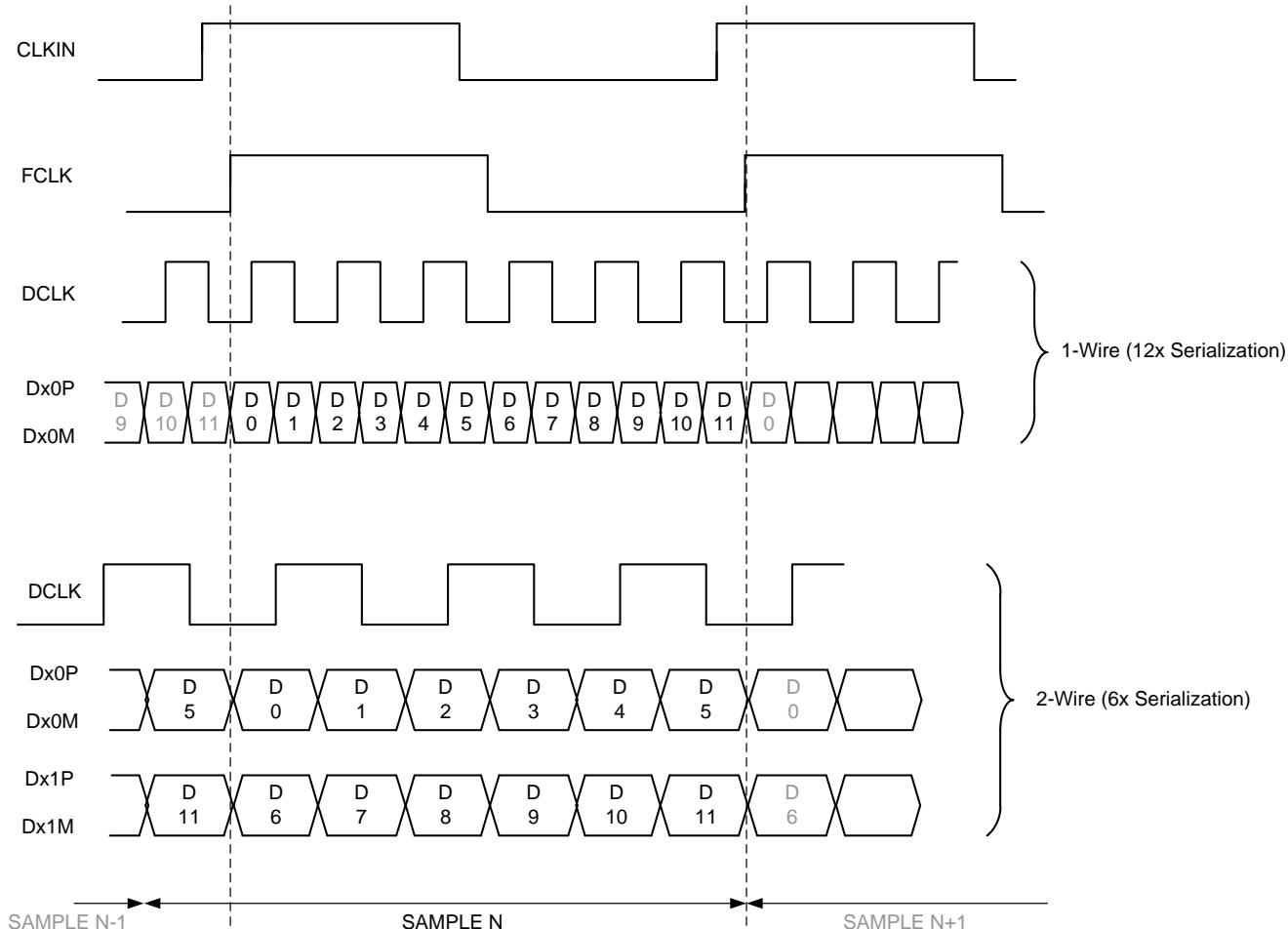
## 8 Parametric Measurement Information

### 8.1 Timing Diagrams



(1) With an external 100- $\Omega$  termination.

**Figure 128. Serial LVDS Output Voltage Levels**



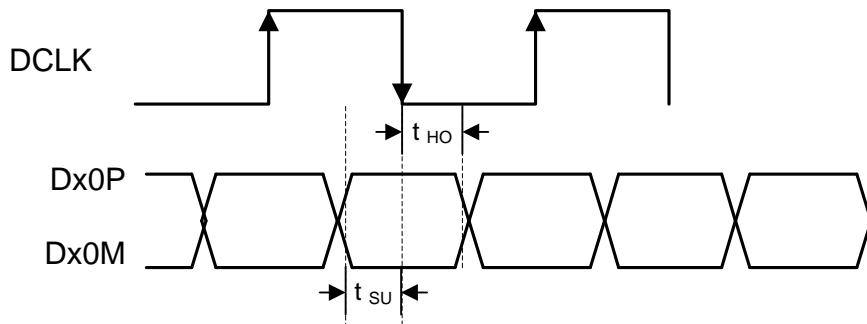
**Figure 129. Output Timing Diagram**

**ADC3221, ADC3222, ADC3223, ADC3224**

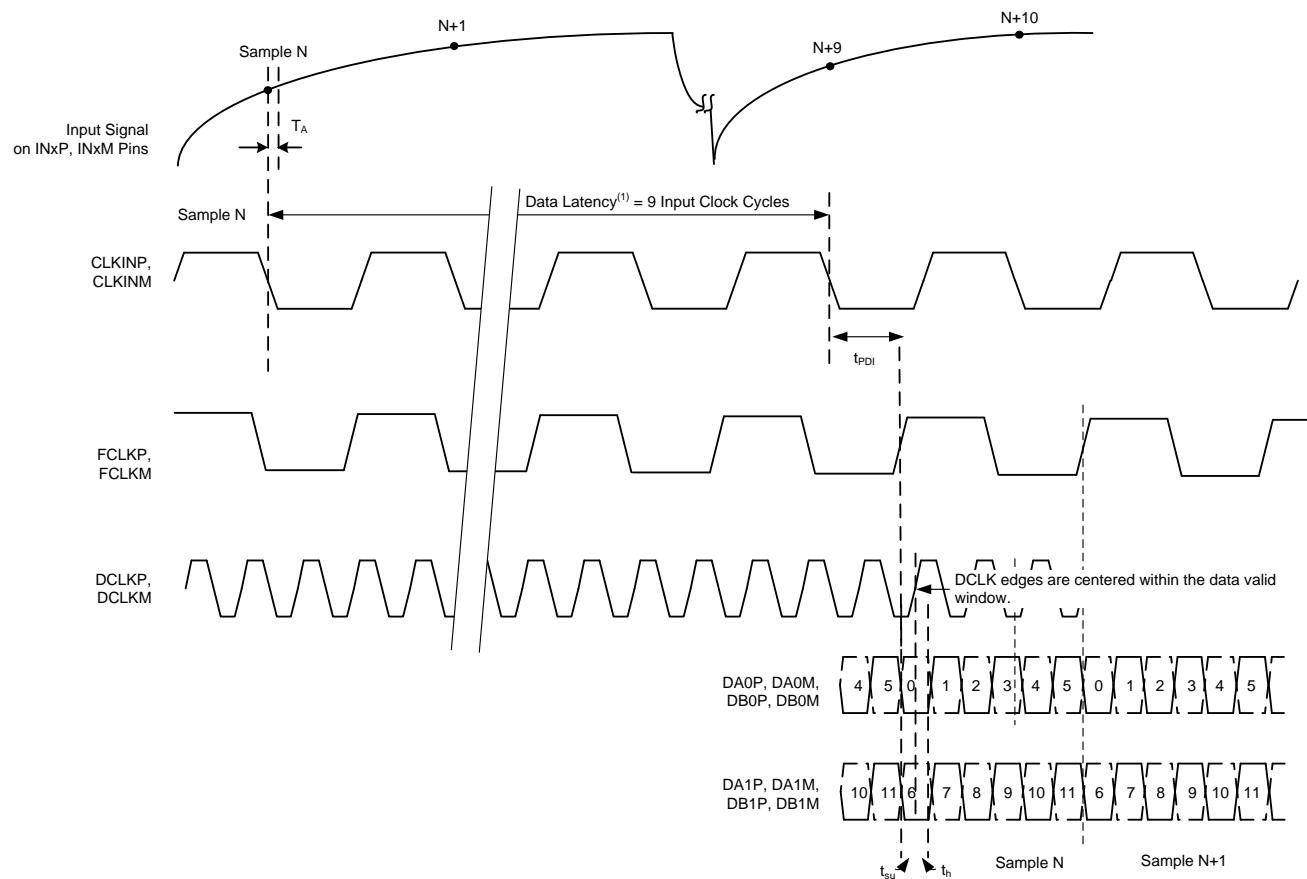
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**Timing Diagrams (continued)**



**Figure 130. Setup and Hold Time**



(1) Overall latency = data latency +  $t_{PD}$ .

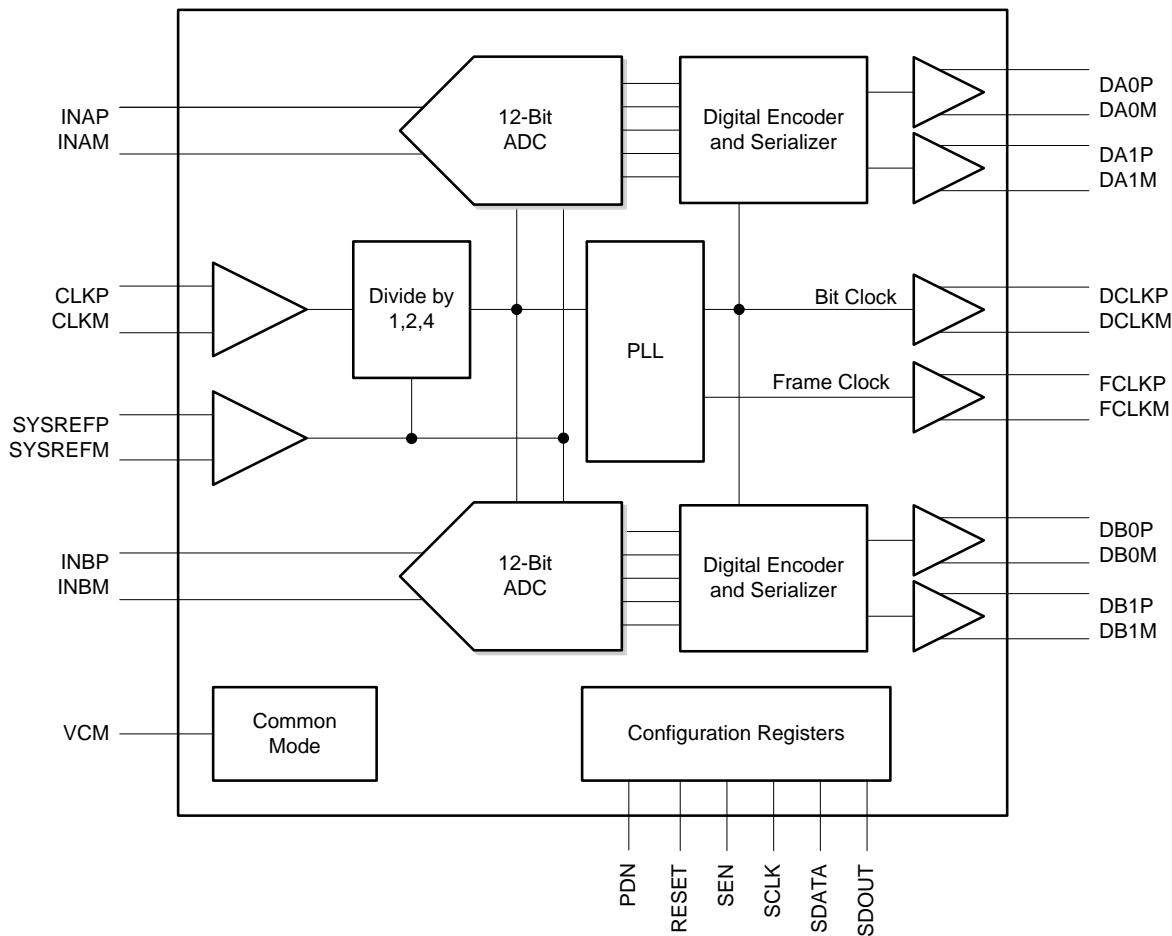
**Figure 131. Latency Diagram**

## 9 Detailed Description

### 9.1 Overview

The ADC322x are a high-linearity, ultra-low power, dual-channel, 12-bit, 25-MSPS to 125-MSPS, analog-to-digital converter (ADC) family. The ADC322x runs off of a single 1.8-V supply and supports system synchronization through the SYSREF pin. Output data are available in standard LVDS format accompanied with bit-clock and frame-clock outputs.

### 9.2 Functional Block Diagram



**ADC3221, ADC3222, ADC3223, ADC3224**

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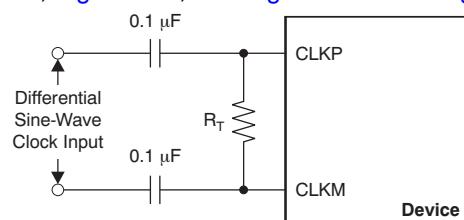
### 9.3 Feature Description

#### 9.3.1 Analog Inputs

The ADC322x analog signal inputs are designed to be driven differentially. Each input pin (INP, INM) must swing symmetrically between ( $V_{CM} + 0.5$  V) and ( $V_{CM} - 0.5$  V), resulting in a  $2\text{-}V_{PP}$  (default) differential input swing. The input sampling circuit has a 3-dB bandwidth that extends up to 540 MHz (50- $\Omega$  source driving a 50- $\Omega$  termination between INP and INM).

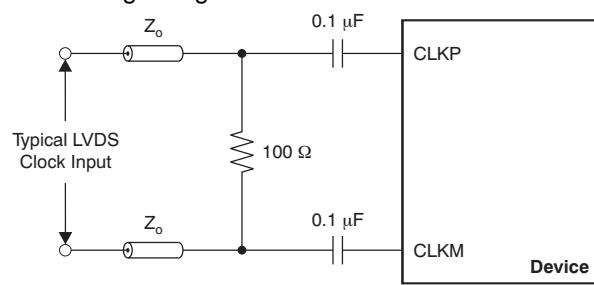
#### 9.3.2 Clock Input

The device clock inputs can be driven differentially (sine, LVPECL, or LVDS) or single-ended (LVCMOS), with little or no difference in performance between them. The common-mode voltage of the clock inputs is set to 0.95 V using internal 5-k $\Omega$  resistors. The self-bias clock inputs of the ADC322x can be driven by the transformer-coupled, sine-wave clock source or by the ac-coupled, LVPECL and LVDS clock sources, as shown in Figure 132, Figure 133, and Figure 134. See Figure 135 for details regarding the internal clock buffer.

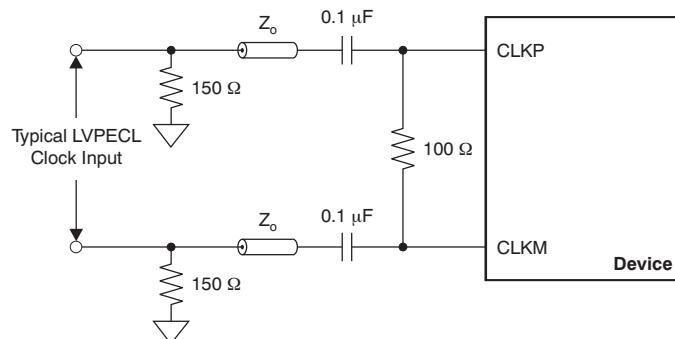


$R_T$  = termination resistor, if necessary.

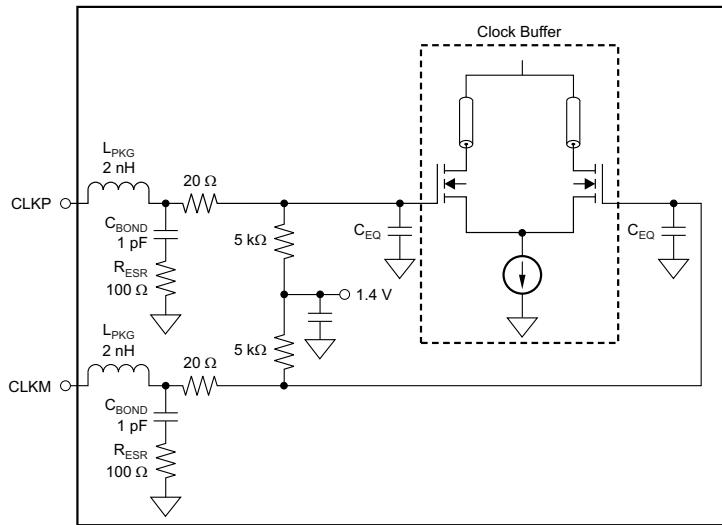
**Figure 132. Differential Sine-Wave Clock Driving Circuit**



**Figure 133. LVDS Clock Driving Circuit**



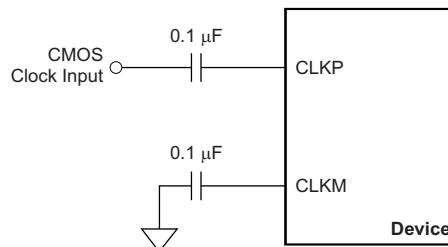
**Figure 134. LVPECL Clock Driving Circuit**



NOTE:  $C_{EQ}$  is 1 pF to 3 pF and is the equivalent input capacitance of the clock buffer.

**Figure 135. Internal Clock Buffer**

A single-ended CMOS clock can be ac-coupled to the CLKP input, with CLKM connected to ground with a 0.1- $\mu$ F capacitor, as shown in [Figure 136](#). However, for best performance the clock inputs must be driven differentially, thereby reducing susceptibility to common-mode noise. For high input frequency sampling, TI recommends using a clock source with very low jitter. Band-pass filtering of the clock source can help reduce the effects of jitter. There is no change in performance with a non-50% duty cycle clock input.



**Figure 136. Single-Ended Clock Driving Circuit**

### 9.3.2.1 SNR and Clock Jitter

The signal-to-noise ratio of the ADC is limited by three different factors, as shown in [Equation 1](#). Quantization noise (typically 74 dB for a 12-bit ADC) and thermal noise limit SNR at low input frequencies, and clock jitter sets SNR for higher input frequencies.

$$SNR_{ADC}[dBc] = -20 \cdot \log \sqrt{\left( 10^{\frac{SNR_{Quantization\ Noise}}{20}} \right)^2 + \left( 10^{\frac{SNR_{Thermal\ Noise}}{20}} \right)^2 + \left( 10^{\frac{SNR_{Jitter}}{20}} \right)^2} \quad (1)$$

The SNR limitation resulting from sample clock jitter can be calculated with [Equation 2](#).

$$SNR_{Jitter}[dBc] = -20 \cdot \log(2\pi \cdot f_{in} \cdot T_{Jitter}) \quad (2)$$

The total clock jitter ( $T_{Jitter}$ ) has two components: the internal aperture jitter (130 fs for the device), which is set by the noise of the clock input buffer, and the external clock.  $T_{Jitter}$  can be calculated with [Equation 3](#).

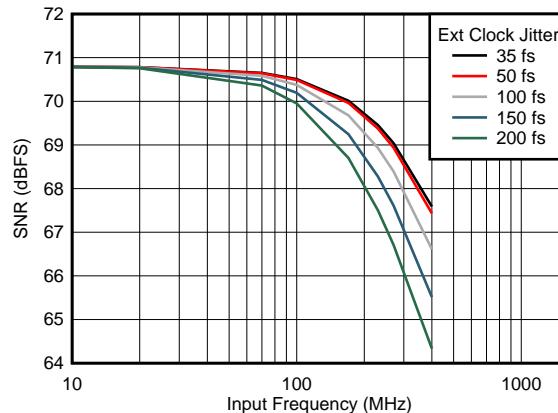
$$T_{Jitter} = \sqrt{(T_{Jitter,Ext.Clock\_Input})^2 + (T_{Aperture\_ADC})^2} \quad (3)$$

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External clock jitter can be minimized by using high-quality clock sources and jitter cleaners as well as band-pass filters at the clock input and a faster clock slew rate improves ADC aperture jitter. The devices have a typical thermal noise of 73.5 dBFS and an internal aperture jitter of 130 fs. The SNR, depending on the amount of external jitter for different input frequencies. [Figure 137](#) shows SNR (from 1 MHz offset leaving the 1/f flicker noise) for different jitter of clock driver.


**Figure 137. SNR vs Frequency for Different Clock Jitter**

### 9.3.3 Digital Output Interface

The devices offer two different output format options, thus making interfacing to a field-programmable gate array (FPGA) or an application-specific integrated circuit (ASIC) easy. Each option can be easily programmed using the serial interface, as shown in [Table 3](#). The output interface options are:

- One-wire, 1X frame clock, 12X serialization with the DDR bit clock and
- Two-wire, 1X frame clock, 6X serialization with the DDR bit clock.

**Table 3. Interface Rates**

INTERFACE OPTIONS	SERIALIZATION	MAXIMUM RECOMMENDED SAMPLING FREQUENCY (MSPS)		BIT CLOCK FREQUENCY (MHz)	FRAME CLOCK FREQUENCY (MHz)	SERIAL DATA RATE PER WIRE (Mbps)
		MIN	MAX			
One-wire	12X	15 <sup>(1)</sup>		90	15	180
			65	390	65	780
Two-wire	6X	20 <sup>(1)</sup>		60	20	120
			125	375	125	750

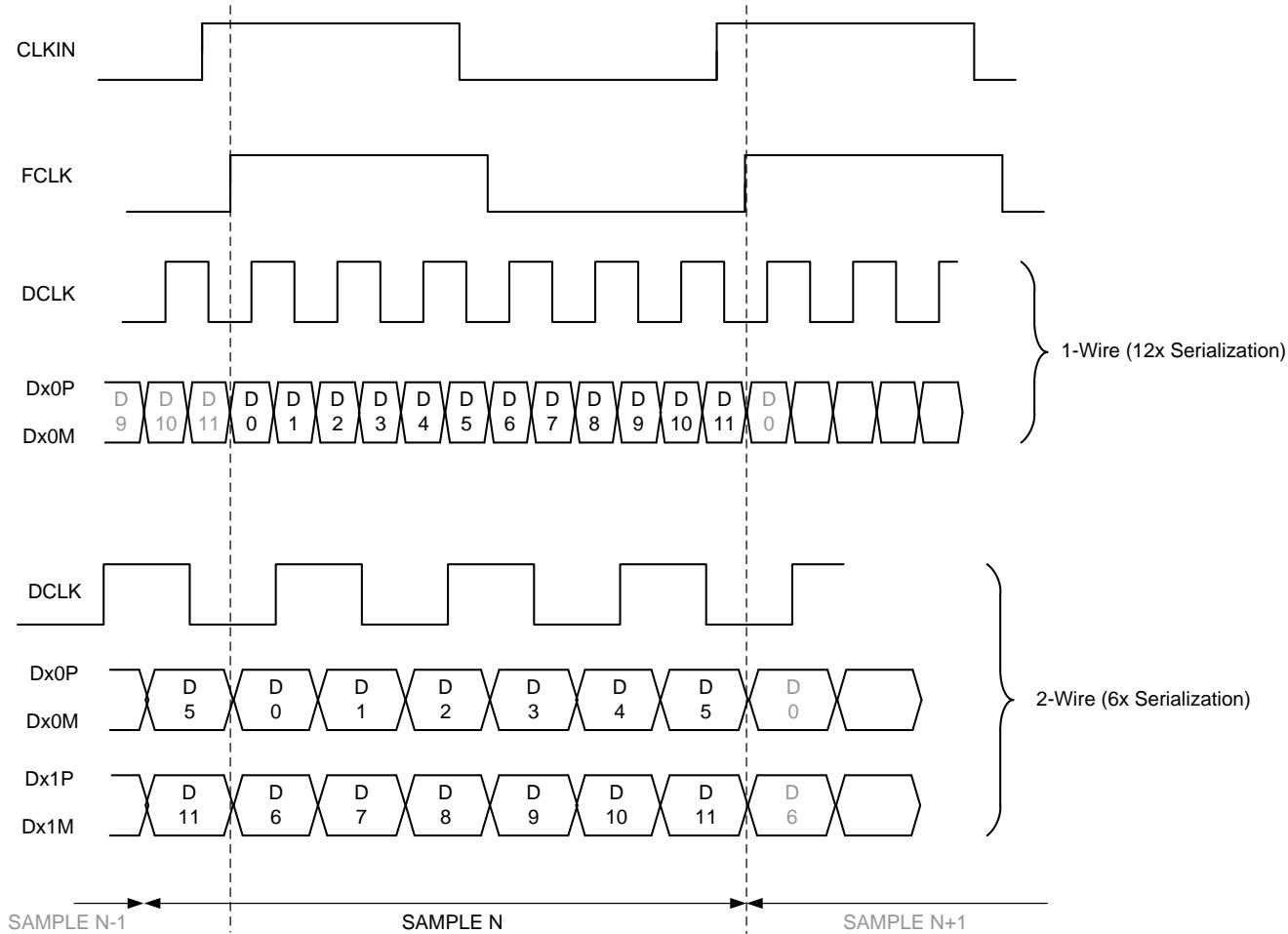
(1) Use the LOW SPEED ENABLE register bits for low speed operation; see [Table 22](#).

#### 9.3.3.1 One-Wire Interface: 12X Serialization

In this interface option, the device outputs the data of each ADC serially on a single LVDS pair (one-wire). The data are available at the rising and falling edges of the bit clock (DDR bit clock). The ADC outputs a new word at the rising edge of every frame clock, starting with the MSB. The data rate is a 12X sample frequency (12X serialization).

### 9.3.3.2 Two-Wire Interface: 6X Serialization

The two-wire interface is recommended for sampling frequencies above 65 MSPS. The output data rate is a 6X sample frequency because six data bits are output every clock cycle on each differential pair. Each ADC sample is sent over the two wires with the six MSBs on Dx1P, Dx1M and the six LSBs on Dx0P, Dx0M, as shown in Figure 138.



**Figure 138. Output Timing Diagram**

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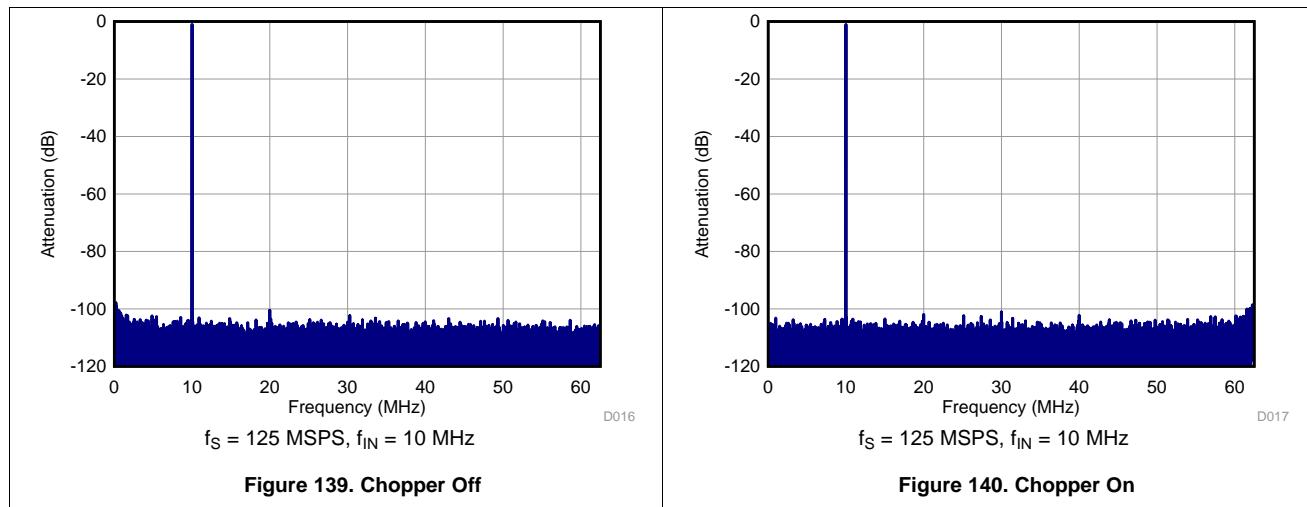
## 9.4 Device Functional Modes

### 9.4.1 Input Clock Divider

The devices are equipped with an internal divider on the clock input. The clock divider allows operation with a faster input clock, thus simplifying the system clock distribution design. The clock divider can be bypassed for operation with a 125-MHz clock; the divide-by-2 option supports a maximum input clock of 250 MHz and the divide-by-4 option provides a maximum input clock frequency of 500 MHz.

### 9.4.2 Chopper Functionality

The devices are equipped with an internal chopper front-end. Enabling the chopper function swaps the ADC noise spectrum by shifting the 1/f noise from dc to  $f_s / 2$ . [Figure 139](#) shows the noise spectrum with the chopper off and [Figure 140](#) shows the noise spectrum with the chopper on. This function is especially useful in applications requiring good ac performance at low input frequencies or in dc-coupled applications. The chopper can be enabled via SPI register writes and is recommended for input frequencies below 30 MHz. The chopper function creates a spur at  $f_s / 2$  that must be filtered out digitally.



### 9.4.3 Power-Down Control

The power-down functions of the ADC322x can be controlled either through the parallel control pin (PDN) or through an SPI register setting (see [register 15h](#)). The PDN pin can also be configured via the SPI to a global power-down or standby functionality, as shown in [Table 4](#).

**Table 4. Power-Down Modes**

FUNCTION	POWER CONSUMPTION (mW)	WAKE-UP TIME (μs)
Global power-down	5	85
Standby	81	35

#### 9.4.3.1 Improving Wake-Up Time From Global Power-Down

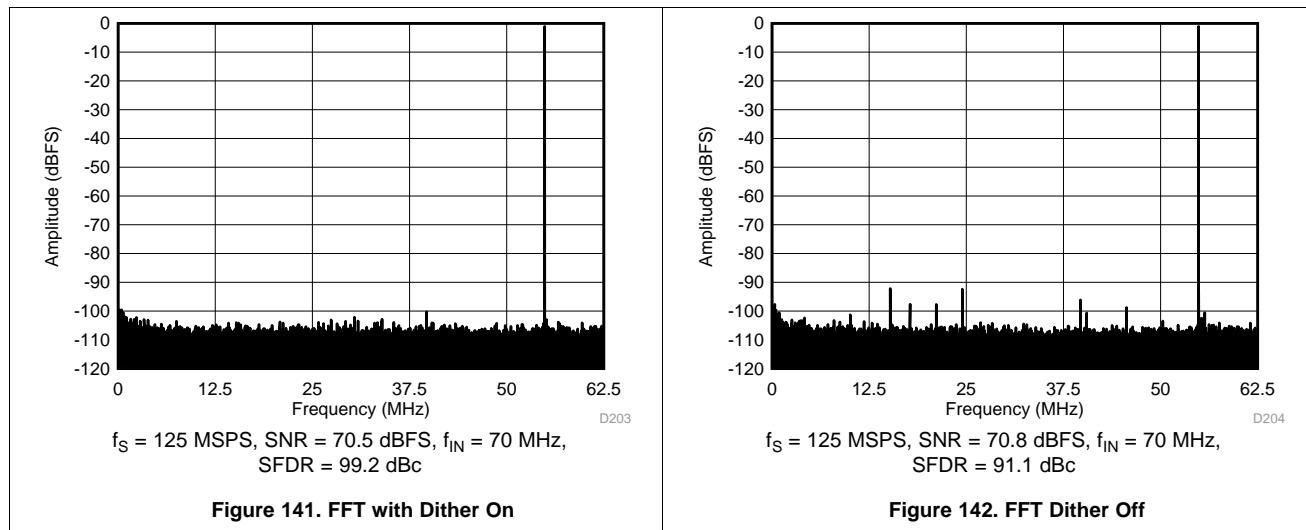
The device has an internal low-pass filter in the sampling clock path. This low-pass filter helps improve the aperture jitter of the device. However, in applications where input frequencies are  $< 200$  MHz, noise from the aperture jitter does not dominate the overall SNR of the device. In such applications, the wake-up time from a global power-down can be reduced by bypassing the low-pass filter using the DIS CLK FILT register bit (write 80h to register address 70Ah). As shown in [Table 5](#), setting the DIS CLK FILT bit improves the wake-up time from a global power-down from 85  $\mu$ s to 55  $\mu$ s.

**Table 5. Wake-Up Time From Global Power-Down**

DIS CLK FILT REGISTER BIT	GLOBAL PDN REGISTER BIT	WAKE-UP TIME		
		TYP	MAX	UNIT
0	0→1→0	85	140	$\mu$ s
1	0→1→0	55	81	$\mu$ s

#### 9.4.4 Internal Dither Algorithm

The ADC322x use an internal dither algorithm to achieve high SFDR and a clean spectrum. However, the dither algorithm marginally degrades SNR, creating a trade-off between SNR and SFDR. If desired, the dither algorithm can be turned off by using the DIS DITH CHx registers bits. [Figure 141](#) and [Figure 142](#) show the effect of using dither algorithms.



## 9.5 Programming

The ADC322x can be configured using a serial programming interface, as described in this section.

### 9.5.1 Serial Interface

The device has a set of internal registers that can be accessed by the serial interface formed by the SEN (serial interface enable), SCLK (serial interface clock), SDATA (serial interface data), and SDOUT (serial interface data output) pins. Serially shifting bits into the device is enabled when SEN is low. Serial data SDATA are latched at every SCLK rising edge when SEN is active (low). The serial data are loaded into the register at every 24th SCLK rising edge when SEN is low. When the word length exceeds a multiple of 24 bits, the excess bits are ignored. Data can be loaded in multiples of 24-bit words within a single active SEN pulse. The interface can function with SCLK frequencies from 20 MHz down to very low speeds (of a few hertz) and also with a non-50% SCLK duty cycle.

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**Programming (continued)**
**9.5.1.1 Register Initialization**

After power-up, the internal registers **must be** initialized to their default values through a hardware reset by applying a high pulse on the RESET pin (of durations greater than 10 ns), as shown in [Figure 143](#). If required, the serial interface registers can be cleared during operation either:

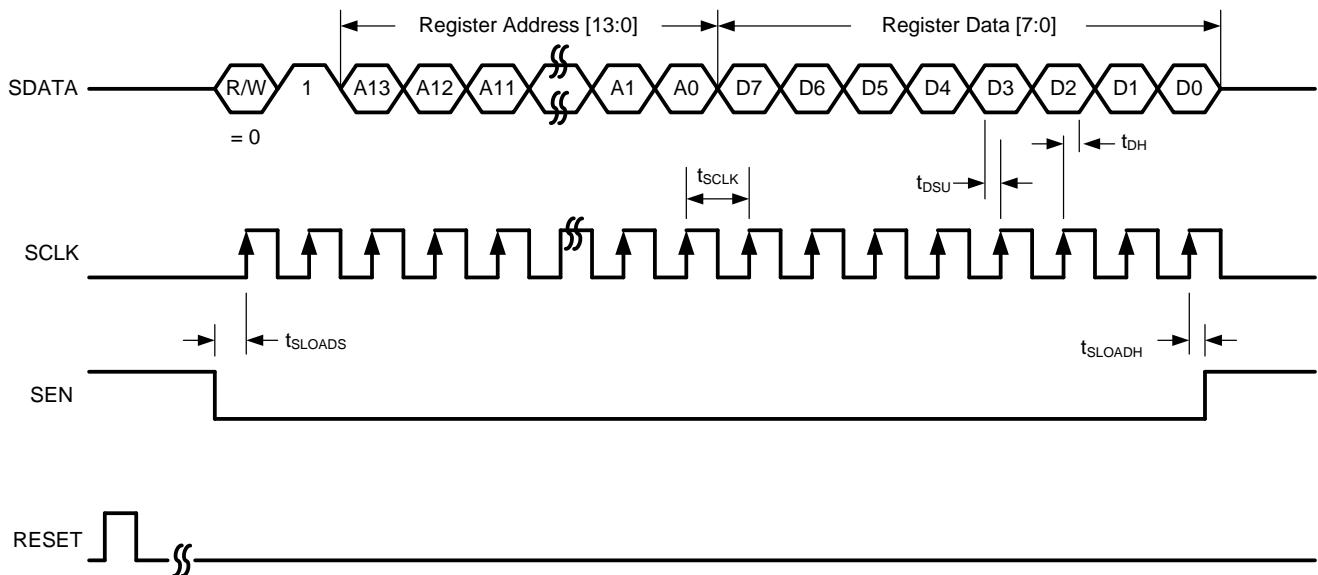
1. Through a hardware reset, or
2. By applying a software reset. When using the serial interface, set the RESET bit (D0 in register address 06h) high. This setting initializes the internal registers to the default values and then self-resets the RESET bit low. In this case, the RESET pin is kept low.

**9.5.1.1.1 Serial Register Write**

The device internal register can be programmed with these steps:

1. Drive the SEN pin low,
2. Set the R/W bit to 0 (bit A15 of the 16-bit address),
3. Set bit A14 in the address field to 1,
4. Initiate a serial interface cycle by specifying the address of the register (A13 to A0) whose content must be written, and
5. Write the 8-bit data that are latched in on the SCLK rising edge.

[Figure 143](#) and [Table 6](#) show the timing requirements for the serial register write operation.



**Figure 143. Serial Register Write Timing Diagram**

**Table 6. Serial Interface Timing<sup>(1)</sup>**

		MIN	TYP	MAX	UNIT
$f_{SCLK}$	SCLK frequency (equal to $1 / t_{SCLK}$ )		> dc	20	MHz
$t_{SLOADS}$	SEN to SCLK setup time		25		ns
$t_{SLOADH}$	SCLK to SEN hold time		25		ns
$t_{DSU}$	SDIO setup time		25		ns
$t_{DH}$	SDIO hold time		25		ns

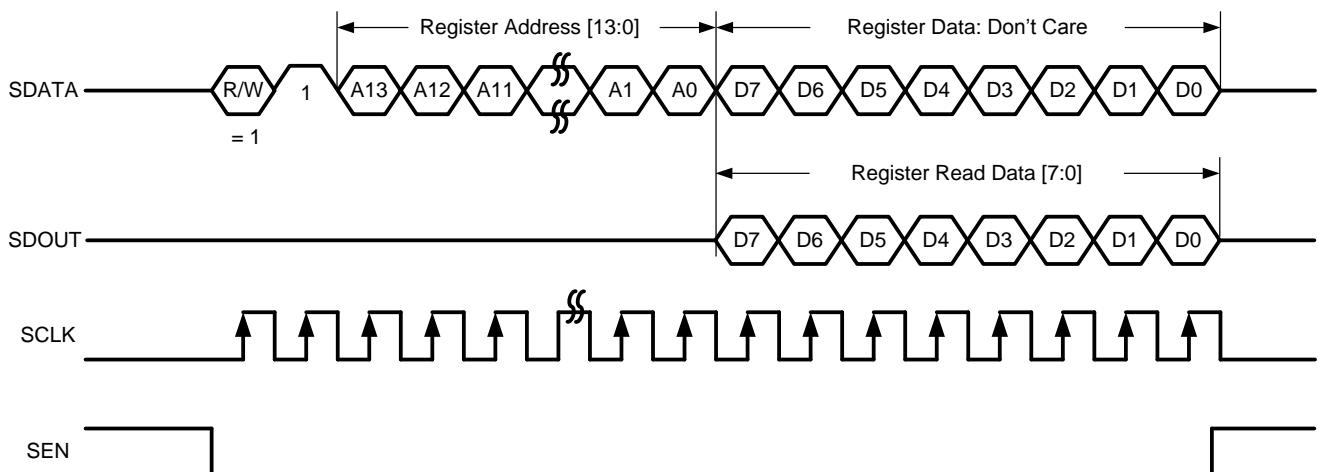
(1) Typical values are at 25°C, full temperature range is from  $T_{MIN} = -40^{\circ}\text{C}$  to  $T_{MAX} = 85^{\circ}\text{C}$ , and  $AVDD = DVDD = 1.8\text{ V}$ , unless otherwise noted.

### 9.5.1.1.2 Serial Register Readout

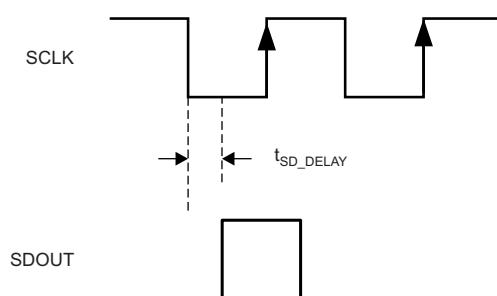
The device includes a mode where the contents of the internal registers can be read back using the SDOUT pin. This readback mode can be useful as a diagnostic check to verify the serial interface communication between the external controller and the ADC. The procedure to read the contents of the serial registers is as follows:

1. Drive the SEN pin low.
2. Set the R/W bit (A15) to 1. This setting disables any further writes to the registers.
3. Set bit A14 in the address field to 1.
4. Initiate a serial interface cycle specifying the address of the register (A[13:0]) whose content must be read.
5. The device outputs the contents (D[7:0]) of the selected register on the SDOUT pin.
6. The external controller can latch the contents at the SCLK rising edge.
7. To enable register writes, reset the R/W register bit to 0.

When READOUT is disabled, the SDOUT pin is in a high-impedance mode. If serial readout is not used, the SDOUT pin must float. **Figure 144** shows a timing diagram of the serial register read operation. Data appear on the SDOUT pin at the SCLK falling edge with an approximate delay ( $t_{SD\_DELAY}$ ) of 20 ns, as shown in **Figure 145**.



**Figure 144. Serial Register Read Timing Diagram**



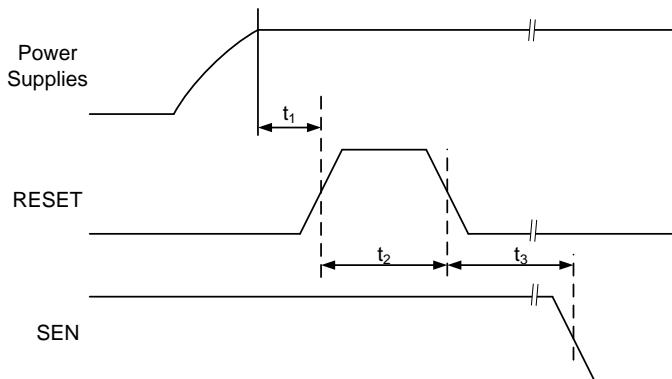
**Figure 145. SDOUT Timing Diagram**

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**9.5.2 Register Initialization**

After power-up, the internal registers must be initialized to their default values through a hardware reset by applying a high pulse on the RESET pin, as shown in [Figure 146](#) and [Table 7](#).



**Figure 146. Initialization of Serial Registers after Power-Up**

**Table 7. Power-Up Timing**

		MIN	TYP	MAX	UNIT
$t_1$	Power-on delay: delay from power up to active high RESET pulse	1			ms
$t_2$	Reset pulse width: active high RESET pulse width	10		1000	ns
$t_3$	Register write delay: delay from RESET disable to SEN active	100			ns

If required, the serial interface registers can be cleared during operation either:

1. Through a hardware reset, or
2. By applying a software reset. When using the serial interface, set the RESET bit (D0 in register address 06h) high. This setting initializes the internal registers to the default values and then self-resets the RESET bit low. In this case, the RESET pin is kept low.

## 9.6 Register Maps

**Table 8. Register Map Summary**

REGISTER ADDRESS A[13:0] (Hex)	REGISTER DATA							
	7	6	5	4	3	2	1	0
Register 01h	0	0	DIS DITH CHA		DIS DITH CHB		0	0
Register 03h	0	0	0	0	0	0	0	ODD EVEN
Register 04h	0	0	0	0	0	0	0	FLIP WIRE
Register 05h	0	0	0	0	0	0	0	1W-2W
Register 06h	0	0	0	0	0	0	TEST PATTERN EN	RESET
Register 07h	0	0	0	0	0	0	0	OVR ON LSB
Register 09h	0	0	0	0	0	0	ALIGN TEST PATTERN	DATA FORMAT
Register 0Ah	0	0	0	0	CHA TEST PATTERN			
Register 0Bh	CHB TEST PATTERN			0	0	0	0	0
Register 0Eh	CUSTOM PATTERN[11:4]				0	0	0	0
Register 0Fh	CUSTOM PATTERN[3:0]				0	0	0	0
Register 13h	0	0	0	0	0	0	LOW SPEED ENABLE	
Register 15h	0	CHA PDN	CHB PDN	0	STANDBY	GLOBAL PDN	0	CONFIG PDN PIN
LVDS SWING								
Register 27h	CLK DIV		0	0	0	0	0	0
Register 41Dh	0	0	0	0	0	0	HIGH IF MODE0	0
Register 422h	0	0	0	0	0	0	DIS CHOP CHA	0
Register 434h	0	0	DIS DITH CHA	0	DIS DITH CHA	0	0	0
Register 439h	0	0	0	0	SP1 CHA	0	0	0
Register 51Dh	0	0	0	0	0	0	HIGH IF MODE1	0
Register 522h	0	0	0	0	0	0	DIS CHOP CHB	0
Register 534h	0	0	DIS DITH CHB	0	DIS DITH CHB	0	0	0
Register 539h	0	0	0	0	SP1 CHB	0	0	0
Register 608h	HIGH IF MODE[3:2]		0	0	0	0	0	0
Register 70Ah	DIS CLK FILT	0	0	0	0	0	0	PDN SYSREF

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### 9.6.1 Summary of Special Mode Registers

Table 9 lists the location, value, and functions of special mode registers in the device.

**Table 9. Special Modes Summary**

MODE	REGISTER SETTINGS	DESCRIPTION
Special modes	Registers 439h (bit 3) and 539h (bit 3)	Always set these bits high for best performance
Disable dither	Registers 1h (bits 5-2), 434h (bits 5 and 3), and 534h (bits 5 and 3)	Disable dither to improve SNR
Disable chopper	Registers 422h (bit 1) and 522h (bit 1)	Disable chopper to shift 1/f noise floor at dc
High IF modes	Registers 41Dh (bit 1), 51Dh (bit 1), and 608h (bits 7-6)	Improves HD3 for IF > 100 MHz

### 9.6.2 Serial Register Description

#### 9.6.2.1 Register 01h

**Figure 147. Register 01h**

7	6	5	4	3	2	1	0
0	0	DIS DITH CHA		DIS DITH CHB		0	0
W-0h	W-0h	R/W-0h		R/W-0h		W-0h	W-0h

LEGEND: R/W = Read/Write; R = Read only; W = Write only; -n = value after reset

**Table 10. Register 01h Description**

Bit	Field	Type	Reset	Description
7-6	0	W	0h	Must write 0
5-4	DIS DITH CHA	R/W	0h	These bits enable or disable the on-chip dither. Control this bit with bits 5 and 3 of register 434h. 00 = Default 11 = Dither is disabled for channel A. In this mode, SNR typically improves by 0.2 dB at 70 MHz.
3-2	DIS DITH CHB	R/W	0h	These bits enable or disable the on-chip dither. Control this bit with bits 5 and 3 of register 434h. 00 = Default 11 = Dither is disabled for channel B. In this mode, SNR typically improves by 0.2 dB at 70 MHz.
1-0	0	W	0h	Must write 0

#### 9.6.2.2 Register 03h

**Figure 148. Register 03h**

7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	ODD EVEN
W-0h	R/W-0h						

LEGEND: R/W = Read/Write; R = Read only; W = Write only; -n = value after reset

**Table 11. Register 03h Description**

Bit	Field	Type	Reset	Description
7-1	0	W	0h	Must write 0
0	ODD EVEN	R/W	0h	This bit selects the bit sequence on the output wires (in 2-wire mode only). 0 = Bits 0, 1, and 2 appear on wire 0; bits 7, 8, and 9 appear on wire 1 1 = Bits 0, 2, and 4 appear on wire 0; bits 1, 3, and 5 appear on wire 1

### 9.6.2.3 Register 04h

**Figure 149. Register 04h**

7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	FLIP WIRE
W-0h	R/W-0h						

LEGEND: R/W = Read/Write; R = Read only; W = Write only; -n = value after reset

**Table 12. Register 04h Description**

Bit	Field	Type	Reset	Description
7-1	0	W	0h	Must write 0
0	FLIP WIRE	R/W	0h	This bit flips the data on the output wires. Valid only in two wire configuration. 0 = Default 1 = Data on output wires is flipped. Pin D0x becomes D1x, and vice versa.

### 9.6.2.4 Register 05h

**Figure 150. Register 05h**

7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	1W-2W
W-0h	R/W-0h						

LEGEND: R/W = Read/Write; R = Read only; W = Write only; -n = value after reset

**Table 13. Register 05h Description**

Bit	Field	Type	Reset	Description
7-1	0	W	0h	Must write 0
0	1W-2W	R/W	0h	This bit transmits output data on either one or two wires. 0 = Output data are transmitted on two wires (Dx0P, Dx0M and Dx1P, Dx1M) 1 = Output data are transmitted on one wire (Dx0P, Dx0M). In this mode, the recommended $f_S$ is less than 62.5 MSPS.

### 9.6.2.5 Register 06h

**Figure 151. Register 06h**

7	6	5	4	3	2	1	0
0	0	0	0	0	0	TEST PATTERN EN	RESET
W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	R/W-0h	W-0h

LEGEND: R/W = Read/Write; R = Read only; W = Write only; -n = value after reset

**Table 14. Register 06h Description**

Bit	Field	Type	Reset	Description
7-2	0	W	0h	Must write 0
1	TEST PATTERN EN	R/W	0h	This bit enables test pattern selection for the digital outputs. 0 = Normal output 1 = Test pattern output enabled
0	RESET	W	0h	This bit applies a software reset. This bit resets all internal registers to the default values and self-clears to 0.

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**9.6.2.6 Register 07h**
**Figure 152. Register 07h**

7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	OVR ON LSB
W-0h	R/W-0h						

LEGEND: R/W = Read/Write; R = Read only; W = Write only; -n = value after reset

**Table 15. Register 07h Description**

Bit	Field	Type	Reset	Description			
7-1	0	W	0h	Must write 0			
0	OVR ON LSB	R/W	0h	This bit provides the overrange (OVR) information on the LSB bits. 0 = Output data bit 0 functions as the LSB of the 12-bit data 1 = Output data bit 0 carries the OVR information.			

**9.6.2.7 Register 09h**
**Figure 153. Register 09h**

7	6	5	4	3	2	1	0
0	0	0	0	0	0	ALIGN TEST PATTERN	DATA FORMAT
W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	R/W-0h	R/W-0h

LEGEND: R/W = Read/Write; R = Read only; W = Write only; -n = value after reset

**Table 16. Register 09h Description**

Bit	Field	Type	Reset	Description			
7-2	0	W	0h	Must write 0			
1	ALIGN TEST PATTERN	R/W	0h	This bit aligns the test patterns across the outputs of both channels. 0 = Test patterns of both channels are free running 1 = Test patterns of both channels are aligned			
0	DATA FORMAT	R/W	0h	This bit programs the digital output data format. 0 = Twos complement 1 = Offset binary			

### 9.6.2.8 Register 0Ah

**Figure 154. Register 0Ah**

7	6	5	4	3	2	1	0
0	0	0	0				CHA TEST PATTERN
W-0h	W-0h	W-0h	W-0h				R/W-0h

LEGEND: R/W = Read/Write; R = Read only; W = Write only; -n = value after reset

**Table 17. Register 0Ah Description**

Bit	Field	Type	Reset	Description
7-4	0	W	0h	Must write 0
3-0	CHA TEST PATTERN	R/W	0h	<p>These bits control the test pattern for channel A after the TEST PATTERN EN bit is set.</p> <p>0000 = Normal operation</p> <p>0001 = All 0's</p> <p>0010 = All 1's</p> <p>0011 = Toggle pattern: data alternate between 101010101010 and 010101010101</p> <p>0100 = Digital ramp: data increment by 1 LSB every clock cycle from code 0 to 4095</p> <p>0101 = Custom pattern: output data are the same as programmed by the CUSTOM PATTERN register bits</p> <p>0110 = Deskew pattern: data are AAAAh</p> <p>1000 = PRBS pattern: data are a sequence of pseudo random numbers</p> <p>1001 = 8-point sine-wave: data are a repetitive sequence of the following eight numbers that form a sine-wave: 0, 599, 2048, 3496, 4095, 3496, 2048, and 599</p> <p>Others = Do not use</p>

### 9.6.2.9 Register 0Bh

**Figure 155. Register 0Bh**

7	6	5	4	3	2	1	0
			CHB TEST PATTERN	0	0	0	0
			R/W-0h	W-0h	W-0h	W-0h	W-0h

LEGEND: R/W = Read/Write; R = Read only; W = Write only; -n = value after reset

**Table 18. Register 0Bh Description**

Bit	Field	Type	Reset	Description
7-4	CHB TEST PATTERN	R/W	0h	<p>These bits control the test pattern for channel B after the TEST PATTERN EN bit is set.</p> <p>0000 = Normal operation</p> <p>0001 = All 0's</p> <p>0010 = All 1's</p> <p>0011 = Toggle pattern: data alternate between 101010101010 and 010101010101</p> <p>0100 = Digital ramp: data increment by 1 LSB every clock cycle from code 0 to 4095</p> <p>0101 = Custom pattern: output data are the same as programmed by the CUSTOM PATTERN register bits</p> <p>0110 = Deskew pattern: data are AAAAh</p> <p>1000 = PRBS pattern: data are a sequence of pseudo random numbers</p> <p>1001 = 8-point sine-wave: data are a repetitive sequence of the following eight numbers that form a sine-wave: 0, 599, 2048, 3496, 4095, 3496, 2048, and 599</p> <p>Others = Do not use</p>
3-0	0	W	0h	Must write 0

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### 9.6.2.10 Register 0Eh

**Figure 156. Register 0Eh**

7	6	5	4	3	2	1	0
CUSTOM PATTERN[11:4]							
R/W-0h							

LEGEND: R/W = Read/Write; R = Read only; -n = value after reset

**Table 19. Register 0Eh Description**

Bit	Field	Type	Reset	Description
7-0	CUSTOM PATTERN[11:4]	R/W	0h	These bits set the 12-bit custom pattern (bits 11-4) for all channels.

### 9.6.2.11 Register 0Fh

**Figure 157. Register 0Fh**

7	6	5	4	3	2	1	0
CUSTOM PATTERN[3:0]							
R/W-0h							

LEGEND: R/W = Read/Write; R = Read only; W = Write only; -n = value after reset

**Table 20. Register 0Fh Description**

Bit	Field	Type	Reset	Description
7-4	CUSTOM PATTERN[3:0]	R/W	0h	These bits set the 12-bit custom pattern (bits 3-0) for all channels.
3-0	0	W	0h	Must write 0

### 9.6.2.12 Register 13h

**Figure 158. Register 13h**

7	6	5	4	3	2	1	0
0	0	0	0	0	0	LOW SPEED ENABLE	
W-0h	R/W-0h	R/W-0h	W-0h	R/W-0h	R/W-0h	W-0h	R/W-0h

LEGEND: R/W = Read/Write; R = Read only; W = Write only; -n = value after reset

**Table 21. Register 13h Description**

Bit	Field	Type	Reset	Description
7-2	0	W	0h	Must write 0
1-0	LOW SPEED ENABLE	R/W	0h	Enables low speed operation in 1-wire and 2-wire mode. Depending upon sampling frequency, write this bit as per <a href="#">Table 22</a> .

**Table 22. LOW SPEED ENABLE Register Bit Settings Across  $f_S$**

$f_S$ (MSPS)		REGISTER BIT LOW SPEED ENABLE	
MIN	MAX	1-WIRE MODE	2-WIRE MODE
25	125	00	00
20	25	10	11
15	20	10	Not supported

### 9.6.2.13 Register 15h

**Figure 159. Register 15h**

7	6	5	4	3	2	1	0
0	CHA PDN	CHB PDN	0	STANDBY	GLOBAL PDN	0	CONFIG PDN PIN
W-0h	R/W-0h	R/W-0h	W-0h	R/W-0h	R/W-0h	W-0h	R/W-0h

LEGEND: R/W = Read/Write; R = Read only; W = Write only; -n = value after reset

**Table 23. Register 15h Description**

Bit	Field	Type	Reset	Description
7	0	W	0h	Must write 0
6	CHA PDN	R/W	0h	0 = Normal operation 1 = Power-down channel A
5	CHB PDN	R/W	0h	0 = Normal operation 1 = Power-down channel B
4	0	W	0h	Must write 0
3	STANDBY	R/W	0h	The ADCs of both channels enter standby. 0 = Normal operation 1 = Standby
2	GLOBAL PDN	R/W	0h	0 = Normal operation 1 = Global power-down
1	0	W	0h	Must write 0
0	CONFIG PDN PIN	R/W	0h	This bit configures the PDN pin as either a global power-down or standby pin. 0 = Logic high voltage on the PDN pin sends the device into global power-down 1 = Logic high voltage on the PDN pin sends the device into standby

### 9.6.2.14 Register 25h

**Figure 160. Register 25h**

7	6	5	4	3	2	1	0
LVDS SWING							
R/W-0h							

LEGEND: R/W = Read/Write; R = Read only; -n = value after reset

**Table 24. Register 25h Description**

Bit	Field	Type	Reset	Description
7-0	LVDS SWING	R/W	0h	These bits control the swing of the LVDS outputs (including the data output, bit clock, and frame clock). For details see <a href="#">Table 25</a> .

**Table 25. LVDS Output Swing**

BITS 7-4	BITS 3-0	LVDS OUTPUT SWING
0h	0h	Default ( $\pm 425$ mV)
Dh	9h	Swing reduces by 50 mV
Eh	Ah	Swing reduces by 100 mV
Fh	Dh	Swing reduces by 300 mV
Ch	Eh	Swing increases by 100 mV
Others	Others	Do not use

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### 9.6.2.15 Register 27h

**Figure 161. Register 27h**

7	6	5	4	3	2	1	0
CLK DIV		0	0	0	0	0	0
R/W-0h	W-0h						

LEGEND: R/W = Read/Write; R = Read only; W = Write only; -n = value after reset

**Table 26. Register 27h Description**

Bit	Field	Type	Reset	Description
7-6	CLK DIV	R/W	0h	These bits set the internal clock divider for the input sampling clock. 00 = Divide-by-1 01 = Divide-by-1 10 = Divide-by-2 11 = Divide-by-4
5-0	0	W	0h	Must write 0

### 9.6.2.16 Register 41Dh

**Figure 162. Register 41Dh**

7	6	5	4	3	2	1	0
0	0	0	0	0	0	HIGH IF MODE0	0
W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	R/W-0h	W-0h

LEGEND: R/W = Read/Write; R = Read only; W = Write only; -n = value after reset

**Table 27. Register 41Dh Description**

Bit	Field	Type	Reset	Description
7-2	0	W	0h	Must write 0
1	HIGH IF MODE0	R/W	0h	This bit improves HD3 for IF > 100 MHz. 0 = Normal operation For best HD3 at IF > 100 MHz, set HIGH IF MODE[3:0] to 1111.
0	0	W	0h	Must write 0

### 9.6.2.17 Register 422h

**Figure 163. Register 422h**

7	6	5	4	3	2	1	0
0	0	0	0	0	0	DIS CHOP CHA	0
W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	R/W-0h	W-0h

LEGEND: R/W = Read/Write; R = Read only; W = Write only; -n = value after reset

**Table 28. Register 422h Description**

Bit	Field	Type	Reset	Description
7-2	0	W	0h	Must write 0
1	DIS CHOP CHA	R/W	0h	Disable chopper. Set this bit to shift a 1/f noise floor at dc. 0 = 1/f noise floor is centered at $f_S / 2$ (default) 1 = Chopper mechanism is disabled; 1/f noise floor is centered at dc
0	0	W	0h	Must write 0

### 9.6.2.18 Register 434h

**Figure 164. Register 434h**

7	6	5	4	3	2	1	0
0	0	DIS DITH CHA	0	DIS DITH CHA	0	0	0
W-0h	W-0h	R/W-0h	W-0h	R/W-0h	W-0h	W-0h	W-0h

LEGEND: R/W = Read/Write; R = Read only; W = Write only; -n = value after reset

**Table 29. Register 434h Description**

Bit	Field	Type	Reset	Description
7-6	0	W	0h	Must write 0
5	DIS DITH CHA	R/W	0h	Set this bit with bits 5 and 4 of register 01h. 00 = Default 11 = Dither is disabled for channel A. In this mode, SNR typically improves by 0.5 dB at 70 MHz.
4	0	W	0h	Must write 0
3	DIS DITH CHA	R/W	0h	Set this bit with bits 5 and 4 of register 01h. 00 = Default 11 = Dither is disabled for channel A. In this mode, SNR typically improves by 0.5 dB at 70 MHz.
2-0	0	W	0h	Must write 0

### 9.6.2.19 Register 439h

**Figure 165. Register 439h**

7	6	5	4	3	2	1	0
0	0	0	0	SP1 CHA	0	0	0
W-0h	W-0h	W-0h	W-0h	R/W-0h	W-0h	W-0h	W-0h

LEGEND: R/W = Read/Write; R = Read only; W = Write only; -n = value after reset

**Table 30. Register 439h Description**

Bit	Field	Type	Reset	Description
7-4	0	W	0h	Must write 0
3	SP1 CHA	R/W	0h	Special mode for best performance on channel A. Always write 1 after reset.
2-0	0	W	0h	Must write 0

### 9.6.2.20 Register 51Dh

**Figure 166. Register 51Dh**

7	6	5	4	3	2	1	0
0	0	0	0	0	0	HIGH IF MODE1	0
W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	R/W-0h	W-0h

LEGEND: R/W = Read/Write; R = Read only; W = Write only; -n = value after reset

**Table 31. Register 51Dh Description**

Bit	Field	Type	Reset	Description
7-2	0	W	0h	Must write 0
1	HIGH IF MODE1	R/W	0h	This bit improves HD3 for IF > 100 MHz. 0 = Normal operation For best HD3 at IF > 100 MHz, set HIGH IF MODE[3:0] to 1111.
0	0	W	0h	Must write 0

## ADC3221, ADC3222, ADC3223, ADC3224

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### 9.6.2.21 Register 522h

**Figure 167. Register 522h**

7	6	5	4	3	2	1	0
0	0	0	0	0	0	DIS CHOP CHB	0
W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	R/W-0h	W-0h

LEGEND: R/W = Read/Write; R = Read only; W = Write only; -n = value after reset

**Table 32. Register 522h Description**

Bit	Field	Type	Reset	Description
7-2	0	W	0h	Must write 0
1	DIS CHOP CHB	R/W	0h	Disable chopper. Set this bit to shift a 1/f noise floor at dc. 0 = 1/f noise floor is centered at $f_S / 2$ (default) 1 = Chopper mechanism is disabled; 1/f noise floor is centered at dc
0	0	W	0h	Must write 0

### 9.6.2.22 Register 534h

**Figure 168. Register 534h**

7	6	5	4	3	2	1	0
0	0	DIS DITH CHA	0	DIS DITH CHA	0	0	0
W-0h	W-0h	R/W-0h	W-0h	R/W-0h	W-0h	W-0h	W-0h

LEGEND: R/W = Read/Write; R = Read only; W = Write only; -n = value after reset

**Table 33. Register 534h Description**

Bit	Field	Type	Reset	Description
7-6	0	W	0h	Must write 0
5	DIS DITH CHA	R/W	0h	Set this bit with bits 3 and 2 of register 01h. 00 = Default 11 = Dither is disabled for channel B. In this mode, SNR typically improves by 0.5 dB at 70 MHz.
4	0	W	0h	Must write 0
3	DIS DITH CHA	R/W	0h	Set this bit with bits 3 and 2 of register 01h. 00 = Default 11 = Dither is disabled for channel B. In this mode, SNR typically improves by 0.5 dB at 70 MHz.
2-0	0	W	0h	Must write 0

### 9.6.2.23 Register 539h

**Figure 169. Register 539h**

7	6	5	4	3	2	1	0
0	0	0	0	SP1 CHB	0	0	0
W-0h	W-0h	W-0h	W-0h	R/W-0h	W-0h	W-0h	W-0h

LEGEND: R/W = Read/Write; R = Read only; W = Write only; -n = value after reset

**Table 34. Register 539h Description**

Bit	Field	Type	Reset	Description
7-4	0	W	0h	Must write 0
3	SP1 CHB	R/W	0h	Special mode for best performance on channel B. Always write 1 after reset.
0	0	W	0h	Must write 0

### 9.6.2.24 Register 608h

**Figure 170. Register 608h**

7	6	5	4	3	2	1	0
HIGH IF MODE[3:2]	0	0	0	0	0	0	0
R/W-0h	W-0h						

LEGEND: R/W = Read/Write; R = Read only; W = Write only; -n = value after reset

**Table 35. Register 608h Description**

Bit	Field	Type	Reset	Description
7-6	HIGH IF MODE[3:2]	R/W	0h	This bit improves HD3 for IF > 100 MHz. 0 = Normal operation For best HD3 at IF > 100 MHz, set HIGH IF MODE[3:0] to 1111.
5-0	0	W	0h	Must write 0

### 9.6.2.25 Register 70Ah

**Figure 171. Register 70Ah**

7	6	5	4	3	2	1	0
DIS CLK FILT	0	0	0	0	0	0	PDN SYSREF
R/W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	W-0h	R/W-0h

LEGEND: R/W = Read/Write; R = Read only; W = Write only; -n = value after reset

**Table 36. Register 70Ah Description**

Bit	Field	Type	Reset	Description
7	DIS CLK FILT	R/W	0h	Set this bit to improve wake-up time from global power-down mode; see the <i>Improving Wake-Up Time From Global Power-Down</i> section for details.
6-1	0	W	0h	Must write 0
0	PDN SYSREF	R/W	0h	If the SYSREF pins are not used in the system, the SYSREF buffer must be powered down by setting this bit. 0 = Normal operation 1 = Powers down the SYSREF buffer

**ADC3221, ADC3222, ADC3223, ADC3224**

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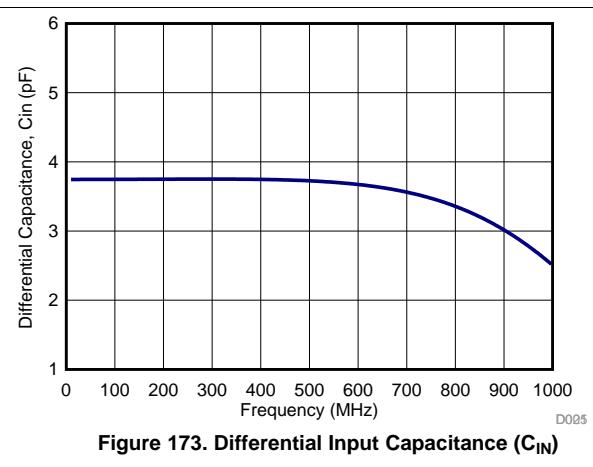
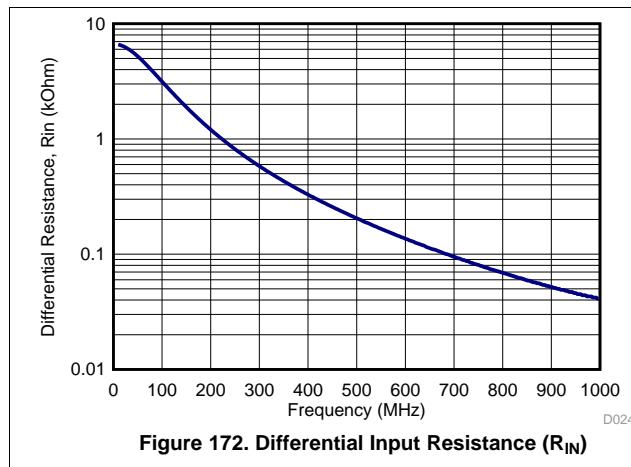
## 10 Applications and Implementation

### NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

### 10.1 Application Information

Typical applications involving transformer-coupled circuits are discussed in this section. Transformers (such as ADT1-1WT or WBC1-1) can be used up to 250 MHz to achieve good phase and amplitude balances at the ADC inputs. When designing the dc-driving circuits, the ADC input impedance must be considered. [Figure 172](#) and [Figure 173](#) show the impedance ( $Z_{in} = R_{in} \parallel C_{in}$ ) across the ADC input pins.



## 10.2 Typical Applications

### 10.2.1 Driving Circuit Design: Low Input Frequencies

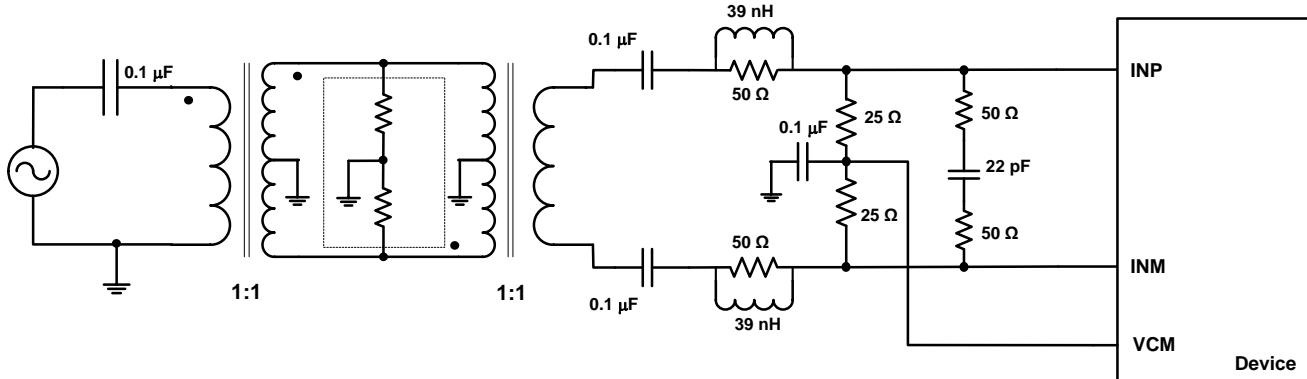


Figure 174. Driving Circuit for Low Input Frequencies

#### 10.2.1.1 Design Requirements

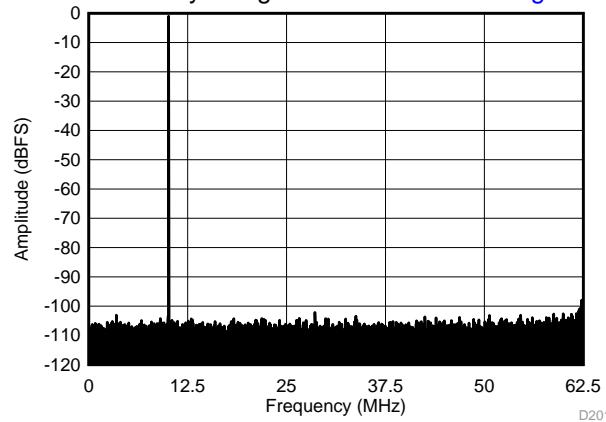
For optimum performance, the analog inputs must be driven differentially. An optional 5-Ω to 15-Ω resistor in series with each input pin can be kept to damp out ringing caused by package parasitic. The drive circuit may have to be designed to minimize the affect of kick-back noise generated by sampling switches opening and closing inside the ADC, as well as ensuring low insertion loss over the desired frequency range and matched impedance to the source.

#### 10.2.1.2 Detailed Design Procedure

A typical application involving using two back-to-back coupled transformers is shown in Figure 174. This circuit is optimized for low input frequencies. An external R-C-R filter using 50-Ω resistors and a 22-pF capacitor is used with the series inductor (39 nH); this combination helps absorb the sampling glitches.

#### 10.2.1.3 Application Curve

Figure 175 shows the performance obtained by using the circuit shown in Figure 174.



$f_s = 125$  MSPS, SNR = 70.6 dBFS,  $f_{IN} = 10$  MHz, SFDR = 101.1 dBc

Figure 175. Performance FFT at 10 MHz (Low Input Frequency)

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### Typical Applications (continued)

#### 10.2.2 Driving Circuit Design: Input Frequencies Between 100 MHz to 230 MHz

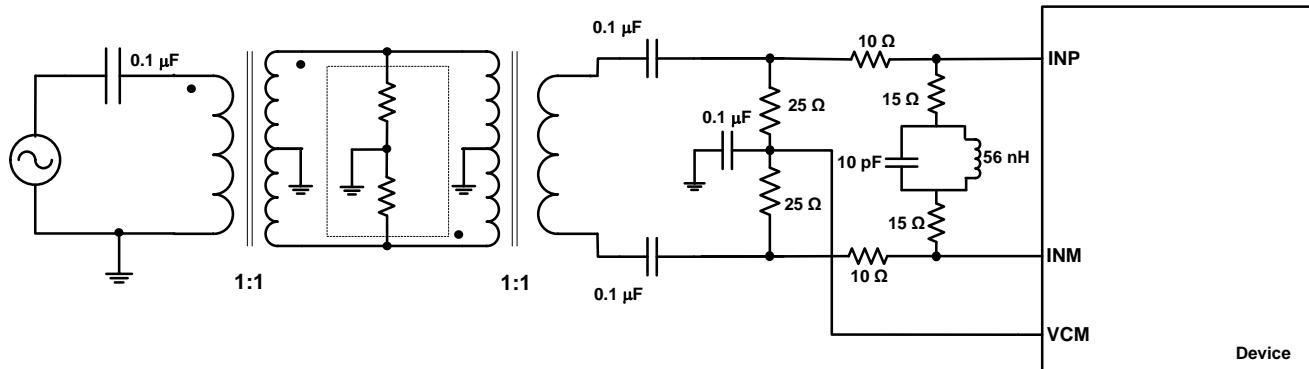


Figure 176. Driving Circuit for Mid-Range Input Frequencies ( $100 \text{ MHz} < f_{\text{IN}} < 230 \text{ MHz}$ )

##### 10.2.2.1 Design Requirements

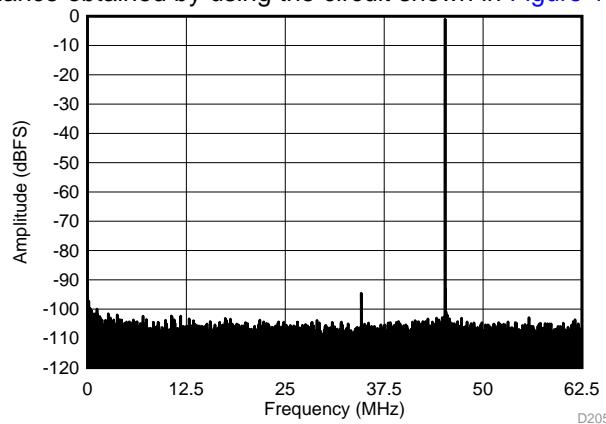
See the [Design Requirements](#) section for further details.

##### 10.2.2.2 Detailed Design Procedure

When input frequencies are between 100 MHz to 230 MHz, an R-LC-R circuit can be used to optimize performance, as shown in [Figure 176](#).

##### 10.2.2.3 Application Curve

[Figure 177](#) shows the performance obtained by using the circuit shown in [Figure 176](#).



$f_s = 125 \text{ MSPS}$ , SNR = 70 dBFS,  $f_{\text{IN}} = 170 \text{ MHz}$ , SFDR = 93.6 dBc

Figure 177. Performance FFT at 170 MHz (Mid Input Frequency)

## Typical Applications (continued)

### 10.2.3 Driving Circuit Design: Input Frequencies Greater than 230 MHz

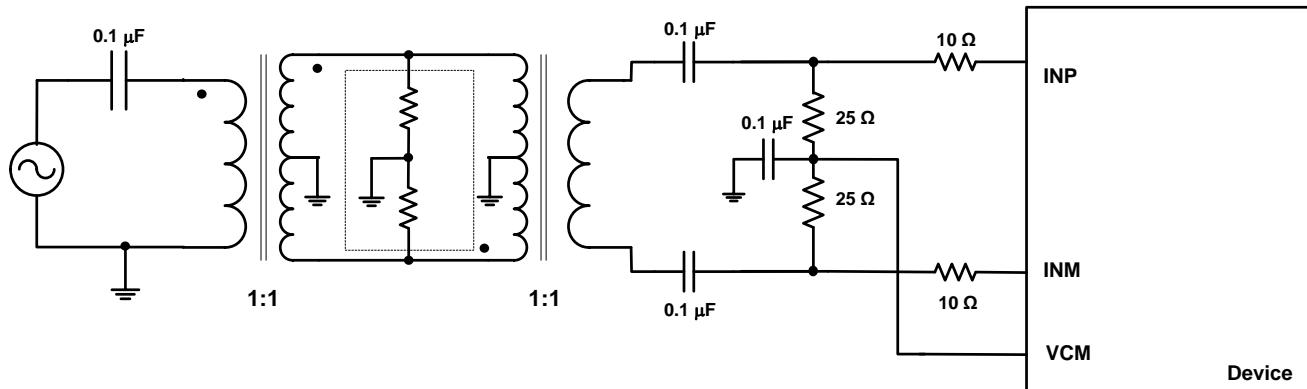


Figure 178. Driving Circuit for High Input Frequencies ( $f_{IN} > 230$  MHz)

#### 10.2.3.1 Design Requirements

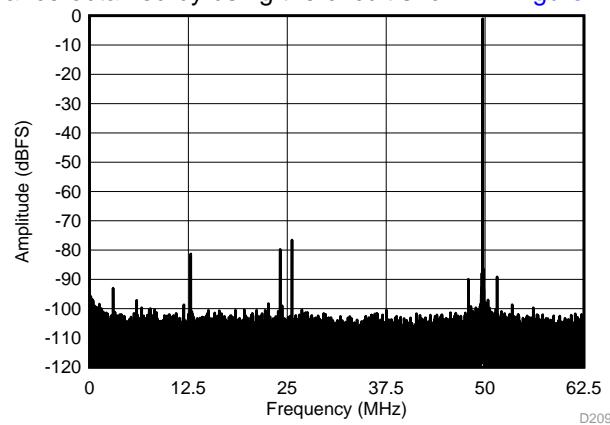
See the [Design Requirements](#) section for further details.

#### 10.2.3.2 Detailed Design Procedure

For high input frequencies ( $> 230$  MHz), using the R-C-R or R-LC-R circuit does not show significant improvement in performance. However, a series resistance of  $10\ \Omega$  can be used as shown in [Figure 178](#).

#### 10.2.3.3 Application Curve

[Figure 179](#) shows the performance obtained by using the circuit shown in [Figure 178](#).



$f_S = 125$  MSPS, SNR = 67.4 dBFS,  $f_{IN} = 450$  MHz, SFDR = 75.5 dBc

Figure 179. Performance FFT at 450 MHz (High Input Frequency)

## 11 Power-Supply Recommendations

The device requires a 1.8-V nominal supply for AVDD and DVDD. There are no specific sequence power-supply requirements during device power-up. AVDD and DVDD can power up in any order.

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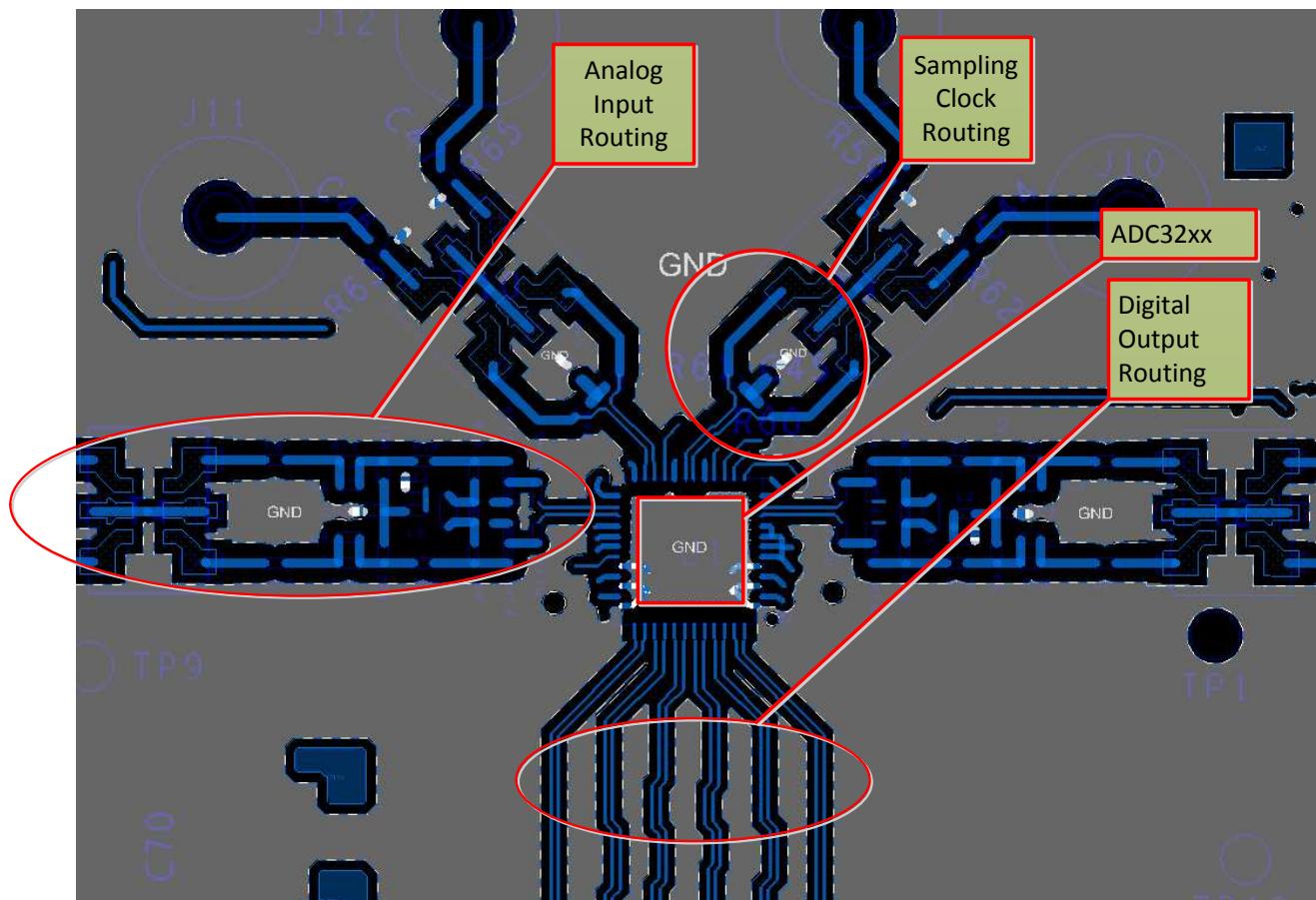
## 12 Layout

### 12.1 Layout Guidelines

The ADC322x EVM layout can be used as a reference layout to obtain the best performance. A layout diagram of the EVM top layer is provided in [Figure 180](#). Some important points to remember during laying out the board are:

1. Analog inputs are located on opposite sides of the device pin out to ensure minimum crosstalk on the package level. To minimize crosstalk onboard, the analog inputs must exit the pin out in opposite directions, as shown in the reference layout of [Figure 180](#) as much as possible.
2. In the device pin out, the sampling clock is located on a side perpendicular to the analog inputs in order to minimize coupling between them. This configuration is also maintained on the reference layout of [Figure 180](#) as much as possible.
3. Keep digital outputs away from analog inputs. When these digital outputs exit the pin out, the digital output traces must not be kept parallel to the analog input traces because this configuration can result in coupling from digital outputs to analog inputs and degrade performance. All digital output traces to the receiver (such as an FPGA or an ASIC) must be matched in length to avoid skew among outputs.
4. At each power-supply pin (AVDD and DVDD), a 0.1- $\mu$ F decoupling capacitor must be kept close to the device. A separate decoupling capacitor group consisting of a parallel combination of 10- $\mu$ F, 1- $\mu$ F, and 0.1- $\mu$ F capacitors can be kept close to the supply source.

### 12.2 Layout Example



**Figure 180. Typical Layout of the ADC322x Board**

## 13 Device and Documentation Support

### 13.1 Related Links

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

**Table 37. Related Links**

PARTS	PRODUCT FOLDER	SAMPLE & BUY	TECHNICAL DOCUMENTS	TOOLS & SOFTWARE	SUPPORT & COMMUNITY
ADC3221	<a href="#">Click here</a>				
ADC3222	<a href="#">Click here</a>				
ADC3223	<a href="#">Click here</a>				
ADC3224	<a href="#">Click here</a>				

### 13.2 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's [Terms of Use](#).

**TI E2E™ Online Community** *TI's Engineer-to-Engineer (E2E) Community.* Created to foster collaboration among engineers. At [e2e.ti.com](http://e2e.ti.com), you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

**Design Support** *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

### 13.3 Trademarks

E2E is a trademark of Texas Instruments.

PowerPAD is a trademark of Texas Instruments, Inc.

All other trademarks are the property of their respective owners.

### 13.4 Electrostatic Discharge Caution

 This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

 ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

### 13.5 Glossary

[SLYZ022](#) — *TI Glossary.*

This glossary lists and explains terms, acronyms, and definitions.

## 14 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

**PACKAGING INFORMATION**

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
ADC3221IRGZR	ACTIVE	VQFN	RGZ	48	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	-40 to 85	AZ3221	<a href="#">Samples</a>
ADC3221IRGZT	ACTIVE	VQFN	RGZ	48	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	-40 to 85	AZ3221	<a href="#">Samples</a>
ADC3222IRGZR	ACTIVE	VQFN	RGZ	48	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	-40 to 85	AZ3222	<a href="#">Samples</a>
ADC3222IRGZT	ACTIVE	VQFN	RGZ	48	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	-40 to 85	AZ3222	<a href="#">Samples</a>
ADC3223IRGZ25	ACTIVE	VQFN	RGZ	48	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	-40 to 85	AZ3223	<a href="#">Samples</a>
ADC3223IRGZR	ACTIVE	VQFN	RGZ	48	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	-40 to 85	AZ3223	<a href="#">Samples</a>
ADC3223IRGZT	ACTIVE	VQFN	RGZ	48	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	-40 to 85	AZ3223	<a href="#">Samples</a>
ADC3224IRGZ25	ACTIVE	VQFN	RGZ	48	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	-40 to 85	AZ3224	<a href="#">Samples</a>
ADC3224IRGZR	ACTIVE	VQFN	RGZ	48	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	-40 to 85	AZ3224	<a href="#">Samples</a>
ADC3224IRGZT	ACTIVE	VQFN	RGZ	48	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	-40 to 85	AZ3224	<a href="#">Samples</a>

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check <http://www.ti.com/productcontent> for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

**Green (RoHS & no Sb/Br):** TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

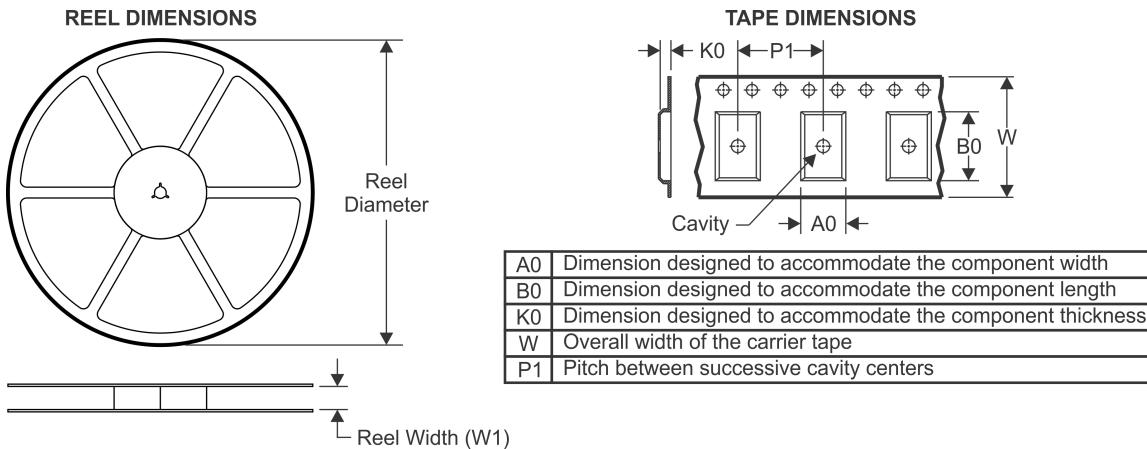
<sup>(5)</sup> Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

<sup>(6)</sup> Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

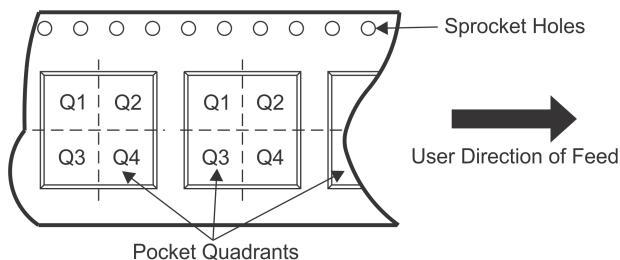
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**TAPE AND REEL INFORMATION**



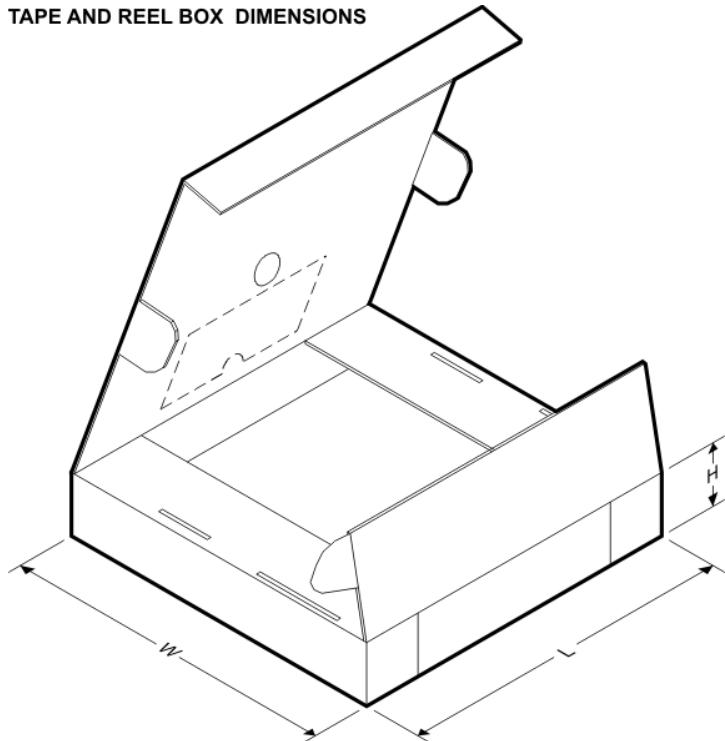
**QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE**



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
ADC3221IRGZR	VQFN	RGZ	48	2500	330.0	16.4	7.3	7.3	1.5	12.0	16.0	Q2
ADC3221IRGZT	VQFN	RGZ	48	250	180.0	16.4	7.3	7.3	1.5	12.0	16.0	Q2
ADC3222IRGZR	VQFN	RGZ	48	2500	330.0	16.4	7.3	7.3	1.5	12.0	16.0	Q2
ADC3222IRGZT	VQFN	RGZ	48	250	180.0	16.4	7.3	7.3	1.5	12.0	16.0	Q2
ADC3223IRGZR	VQFN	RGZ	48	2500	330.0	16.4	7.3	7.3	1.5	12.0	16.0	Q2
ADC3223IRGZT	VQFN	RGZ	48	250	180.0	16.4	7.3	7.3	1.5	12.0	16.0	Q2
ADC3224IRGZR	VQFN	RGZ	48	2500	330.0	16.4	7.3	7.3	1.5	12.0	16.0	Q2
ADC3224IRGZT	VQFN	RGZ	48	250	180.0	16.4	7.3	7.3	1.5	12.0	16.0	Q2

**TAPE AND REEL BOX DIMENSIONS**



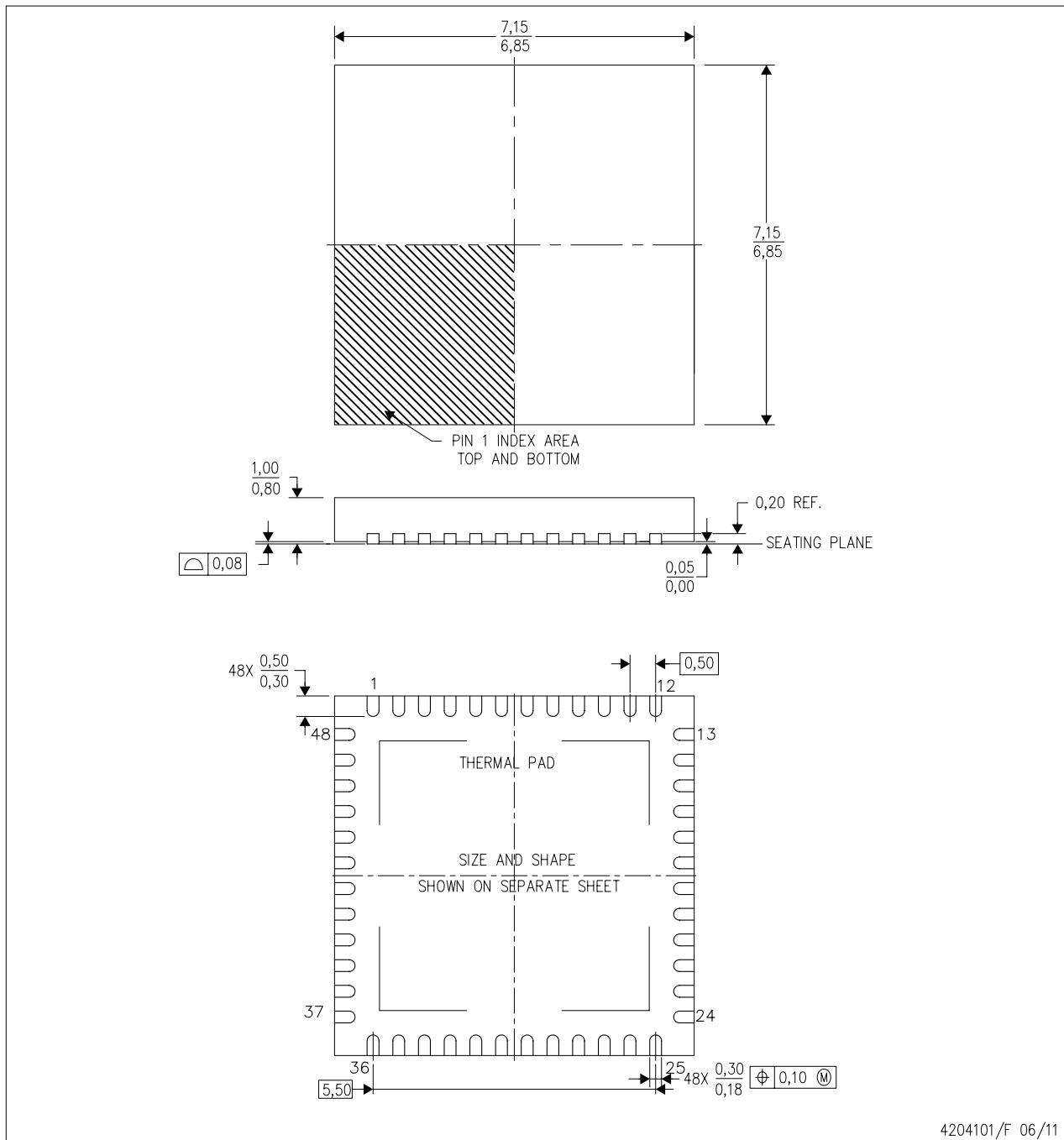
\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
ADC3221IRGZR	VQFN	RGZ	48	2500	336.6	336.6	28.6
ADC3221IRGZT	VQFN	RGZ	48	250	213.0	191.0	55.0
ADC3222IRGZR	VQFN	RGZ	48	2500	336.6	336.6	28.6
ADC3222IRGZT	VQFN	RGZ	48	250	213.0	191.0	55.0
ADC3223IRGZR	VQFN	RGZ	48	2500	336.6	336.6	28.6
ADC3223IRGZT	VQFN	RGZ	48	250	213.0	191.0	55.0
ADC3224IRGZR	VQFN	RGZ	48	2500	336.6	336.6	28.6
ADC3224IRGZT	VQFN	RGZ	48	250	213.0	191.0	55.0

## MECHANICAL DATA

RGZ (S-PVQFN-N48)

PLASTIC QUAD FLATPACK NO-LEAD



4204101/F 06/11

NOTES:

- All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
- This drawing is subject to change without notice.
- Quad Flatpack, No-leads (QFN) package configuration.
- The package thermal pad must be soldered to the board for thermal and mechanical performance.
- See the additional figure in the Product Data Sheet for details regarding the exposed thermal pad features and dimensions.
- Falls within JEDEC MO-220.

## THERMAL PAD MECHANICAL DATA

RGZ (S-PVQFN-N48)

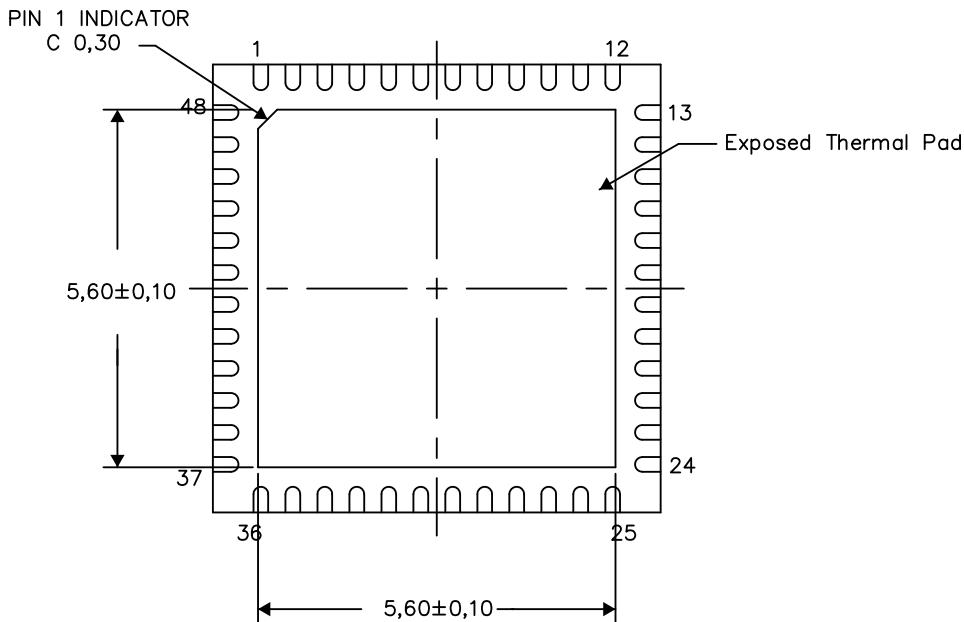
PLASTIC QUAD FLATPACK NO-LEAD

## THERMAL INFORMATION

This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For information on the Quad Flatpack No-Lead (QFN) package and its advantages, refer to Application Report, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271. This document is available at [www.ti.com](http://www.ti.com).

The exposed thermal pad dimensions for this package are shown in the following illustration.



### Bottom View

## Exposed Thermal Pad Dimensions

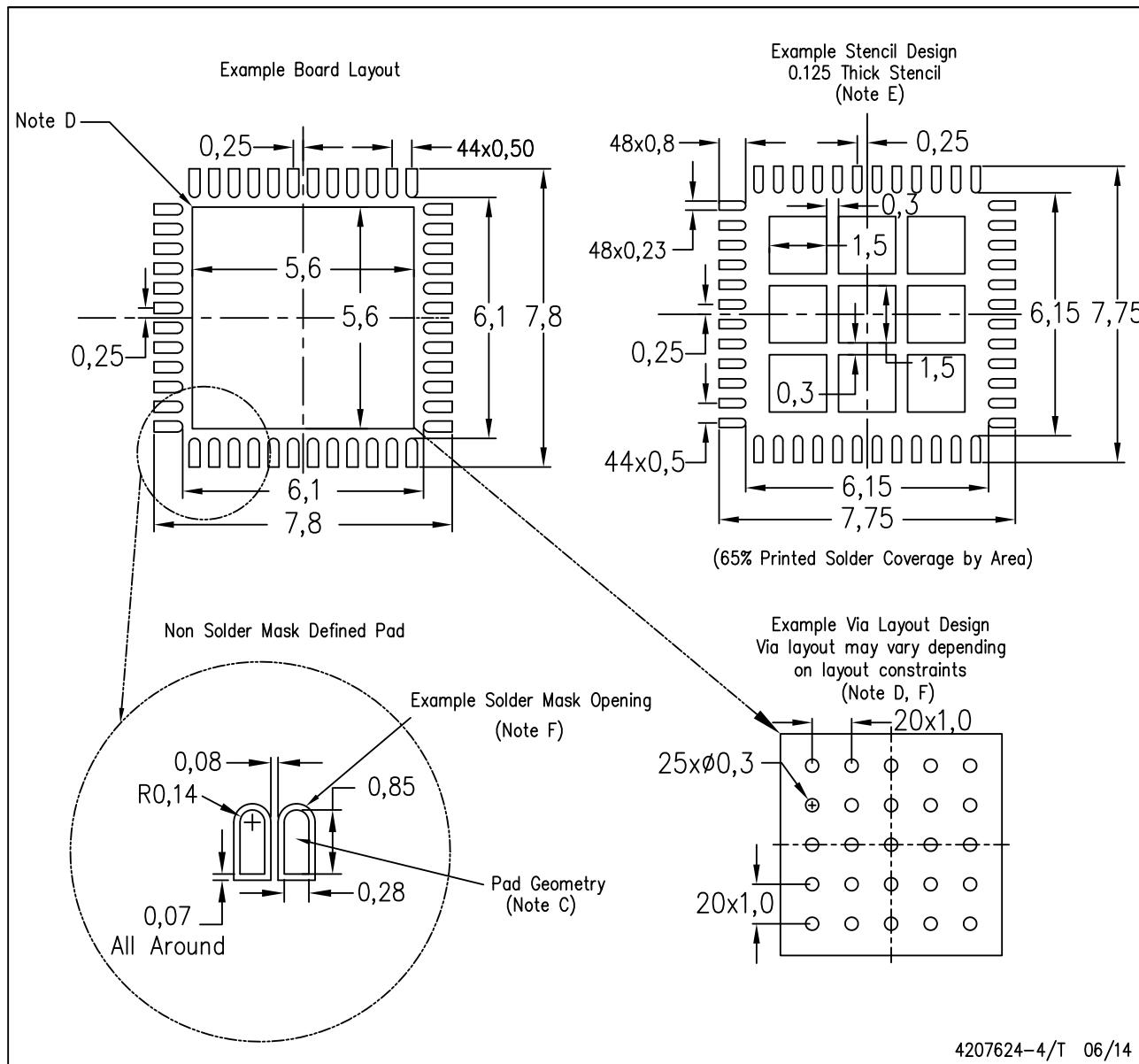
4206354-5/Z 03/15

NOTE: All linear dimensions are in millimeters.

## LAND PATTERN DATA

RGZ (S-PVQFN-N48)

PLASTIC QUAD FLATPACK NO-LEAD



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. This package is designed to be soldered to a thermal pad on the board. Refer to Application Note, Quad Flat-Pack Packages, Texas Instruments Literature No. SLUA271, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at [www.ti.com](http://www.ti.com) <<http://www.ti.com>>.
- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
- F. Customers should contact their board fabrication site for recommended solder mask tolerances and via tenting recommendations for vias placed in the thermal pad.

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